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NAVAL POSTGRADUATE SCHOOL Monterey, California



THESIS

NATURAL CONVECTION IMMERSION COOLING OF AN
ARRAY OF HEATED PROTRUSIONS IN AN ENCLOSURE
FILLED WITH DIELECTRIC LIQUID: EFFECTS OF
ENCLOSURE WIDTH AND FLUID PRANDTL NUMBER

by

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MARCH 1991

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Natural Convection Immersion Cooling
of an Array of Heated Protrusions in an Enclosure
Filled With Dielectric Liquid:
Effects of Enclosure Width and Fluid Prandtl Number

by

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Submitted in partial fulfillment of the
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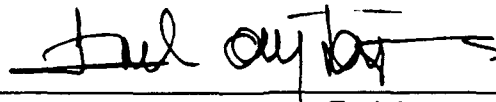
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ABSTRACT

An experimental investigation of natural convection immersion cooling of an array (3 by 3 horizontally-placed heated discrete protrusions) in an enclosure filled with dielectric fluids has been conducted. Each rectangular protrusion simulates a 20 pin dual-inline-package.

Effects of enclosure width and fluid Prandtl number were examined. Five different spacings from 42 mm to 7 mm and two dielectric fluids, FC-75 ($Pr=25$ at $27^{\circ}C$) and FC-43 ($Pr=82$ at $27^{\circ}C$) were used. The top boundary of the enclosure was kept constant at $10^{\circ}C$ and the bottom boundary was insulated during the experiments.

Power dissipation levels per component ranged from 0.115 W to 2.9 W. Component surface temperature measurements were used to obtain the nondimensional heat transfer parameters. In the case of FC-75 and 30 and 7 mm spacings, and in the case of FC-43 and 7 mm spacing, timewise fluctuations of temperature at steady state in several locations were recorded with increasing power level.



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NOMENCLATURE

SYMBOL	DESCRIPTION	UNITS
A	Area	m ²
A _{total}	Total wetted surface area	m ²
C _p	Specific heat	J/kg °C
emf	Thermocouple voltage	Volt
g	Gravitational acceleration	m/s ²
Gr _f	Flux-based Grashof Number	Dimensionless
Gr _t	Temperature-based Grashof Number	Dimensionless
h	Heat transfer coefficient	W/m ² °C
k _f	Fluid thermal conductivity	W/m °C
k _p	Plexiglass thermal conductivity	W/m °C
L1	Component length in the vertical direction	m
L2	Summation of the ratios of the component fluid exposed areas to their perimeters	m
Nu1	Nusselt number based on L1	Dimensionless
Nu2	Nusselt number based on L2	Dimensionless
Pr	Prandtl number	Dimensionless
Power	Power dissipated by the heaters	Watts
Q _{loss}	Energy loss by conduction	Watts
Q _{net}	Net power dissipated by the heater	Watts
R _c	Total thermal resistance	°C/W
R _p	Resistance of the precision resistor	Ohms
Ra _f	Flux-based Rayleigh number	Dimensionless
Ra _t	Temperature-based Rayleigh number	Dimensionless
T	Temperature	°C
T _{avg}	Average of component temperature	°C
T _b	Back surface temperature	°C
T _{film}	Film temperature	°C

T_{sink}	Average temperature of the top wall of the chamber	$^{\circ}\text{C}$
U	Uncertainty value	Various
Volt	Input voltage	Volts
X'	Nondimensional chamber width	Dimensionless
w	chamber width	mm
α	Thermal diffusivity	m^2/s
β	Thermal expansion coefficient	$^{\circ}\text{C}^{-1}$
ρ	Density	kg/m^3
ν	Kinematic viscosity	m^2/s

I. INTRODUCTION

A. STATEMENT OF PROBLEM

The growing interest in high power dissipation from electronic packages with the improvements in circuit packaging density brought the necessity for enhancements in cooling technology.

A strong need to keep component at temperatures below 100°C exists since for every 20°C decrease in junction temperature, the chip failure rates are cut in half (Oktay, 1986). Natural convection immersion cooling of these packages with dielectric fluids has become important recently because of its enormous promise for high heat dissipation capabilities, together with such added advantages as no noise and high reliability (Liu, Kelleher, Yang, 1987). Natural convection is important for immersion cooling because it governs the lower power devices. In addition, an accurate prediction of natural convection is necessary for establishing the conditions under which two-phase heat transfer begins.

B. NUMERICAL AND EXPERIMENTAL STUDIES OF NATURAL CONVECTION IMMERSION COOLING

Extensive research has been conducted on the immersion cooling of electronic devices by means of natural convection. Much more basic data than

currently exists are needed as inputs to the design of such cooling systems for optimum thermal performance (Liu, Kelleher, Yang, 1987).

Baker (Vols. 11, 12, 1973) found that natural convection liquid cooling of heat sources ($1.0 \times 2.6 \times 0.12$ cm) was three times more effective than natural convection air cooling of the same heat sources. Two different dielectric liquids, Freon 113 ($Pr=3.9$) and Dow Corning #200 silicone oil ($Pr=126$) were used. The analysis showed that:

- Convection heat transfer coefficient increases significantly as the heat source size decreases.
- Heat transfer coefficient is proportional to the cube root of the reciprocal of the viscosity.
- Decreasing the heat source surface area from 2.0 to 0.01 cm² increased the free convection heat transfer coefficient an order of magnitude under the same operation conditions.

Park and Bergles (1987) conducted experimental studies of natural convection liquid cooling from both discrete flush heaters and protruding rectangular heaters. Heat transfer coefficients (midpoint) were obtained with two heater heights (5 mm and 10 mm) and varying width (2 mm - 70 mm). Water and Freon 113 were used as working fluids. Data indicated that:

- Heat transfer coefficient increases with decreasing width, with the coefficient for 2 mm wide heaters being 150% above that for 20 mm - 70 mm. This effect was greater in Freon 113 than water.
- With in-line flush heaters, the heat transfer coefficients for the upper heaters are lower than those for the bottom heater. With an array of protruding

heaters, heat transfer coefficients for the top heater are higher than those for the bottom heater.

- The heat transfer coefficient for a single protruding heater is about 15% higher than that for a flush surface.
- As the distance between the heaters increases, the heat transfer coefficients for the upper heaters increase.

Chen *et al.* (1988) conducted an experiment on natural convection heat transfer in a chamber with 10 protruding components from one vertical wall. Distilled water and ethylene glycol were used. The top boundary of the chamber was maintained at a constant temperature acting as a heat sink. Experimental results showed that:

- Bottom heater had the highest heat transfer coefficient except at high Rayleigh numbers.
- At high Rayleigh numbers the top heater had the highest heat transfer coefficient.

Liu *et al.* (1987) developed a finite difference analysis of natural convection from an array of 3 by 3 components immersed in FC-75. The top and bottom boundaries of the chamber were assumed to be at uniform temperatures. Results were presented for the chamber widths of 30 and 18 mm. They found that:

- Temperature field in the chamber is characterized by the flow around the components.
- Lesser temperatures were found in the bottom row components, and maximum temperatures on chip surfaces were found on the upper horizontal faces.

- The results for the chamber widths of 30 and 18 mm were almost the same indicating very little effect of chamber width.
- Local oscillatory surface temperatures of the components tended to fluctuate within a range of almost $\pm 3^{\circ}\text{C}$ with a period of 4 seconds.

Kelleher *et al.* (1987) investigated natural convection of a water-filled enclosure with a long protruding heater from one vertical wall. They carried out both flow visualization and heat transfer measurement for three different heater locations. Flow visualizations indicated two dimensional dual-celled flow structures in the chamber: Buoyancy-driven upper shell which accounts for a majority of the heat transfer and shear-driven lower shell in which the fluid motion arises due to viscous drag from the upper shell.

Joshi *et al.* (1988) investigated natural convection immersion cooling of a 3 by 3 array of heated protrusions in an enclosure filled with FC-75. They found that:

- Flow structure was largely determined by the boundary conditions at low power levels (0.1 W)
- Upon increasing the power levels (0.7 W to 3.0 W), an upward flow developed adjacent to each column of components.
- With increasing thermal input, flow away from the components showed 3 dimensional and time dependent behavior.

C. OBJECTIVES

This experimental study is a continuation of the research conducted at the Naval Postgraduate School by Pamuk (1987), Benedict (1988), Torres (1988) and Powell (1989). The objectives of this thesis are:

- To design and build a new simulated circuit board using tack-welding method for attaching the thermocouples on component surfaces.
- To analyze the data in terms of both dimensional and nondimensional heat transfer parameters for different chamber widths and dielectric fluids.
- To correlate the data in terms of Nusselt number and Rayleigh number for each case.
- To find single correlation for each dielectric fluid to account for the effects of spacing.

II. EXPERIMENTAL APPARATUS

A. GENERAL CONSIDERATIONS

This experimental study is a continuation of past experiments conducted at the Naval Postgraduate School. Effects of the chamber width (spacing) on heat transfer characteristics of the components (3 by 3 array of horizontally placed rectangular aluminum blocks) were examined. Two dielectric liquids were used: FC-75 and FC-43. The top boundary of the chamber was kept at 10°C and the bottom boundary was insulated.

The top view of the chamber assembly is provided in Figure 2.1 (after Torres, 1988). This was the same chamber used by Torres (1988) and Powell (1989) with vertical component arrangement. The horizontal arrangement used in this study was obtained by turning the vertically arranged components 90° around their back surface area centers. A front and side view of the horizontally arranged simulated circuit board is provided in Figure 2.2 (after Benedict, 1988).

The components and heaters are identical to the previous ones in order to compare the results. A more detailed description of the chamber, components, heaters and heat exchangers can be found in Benedict (1988), Torres (1988), Powell (1989) and Pamuk (1987).

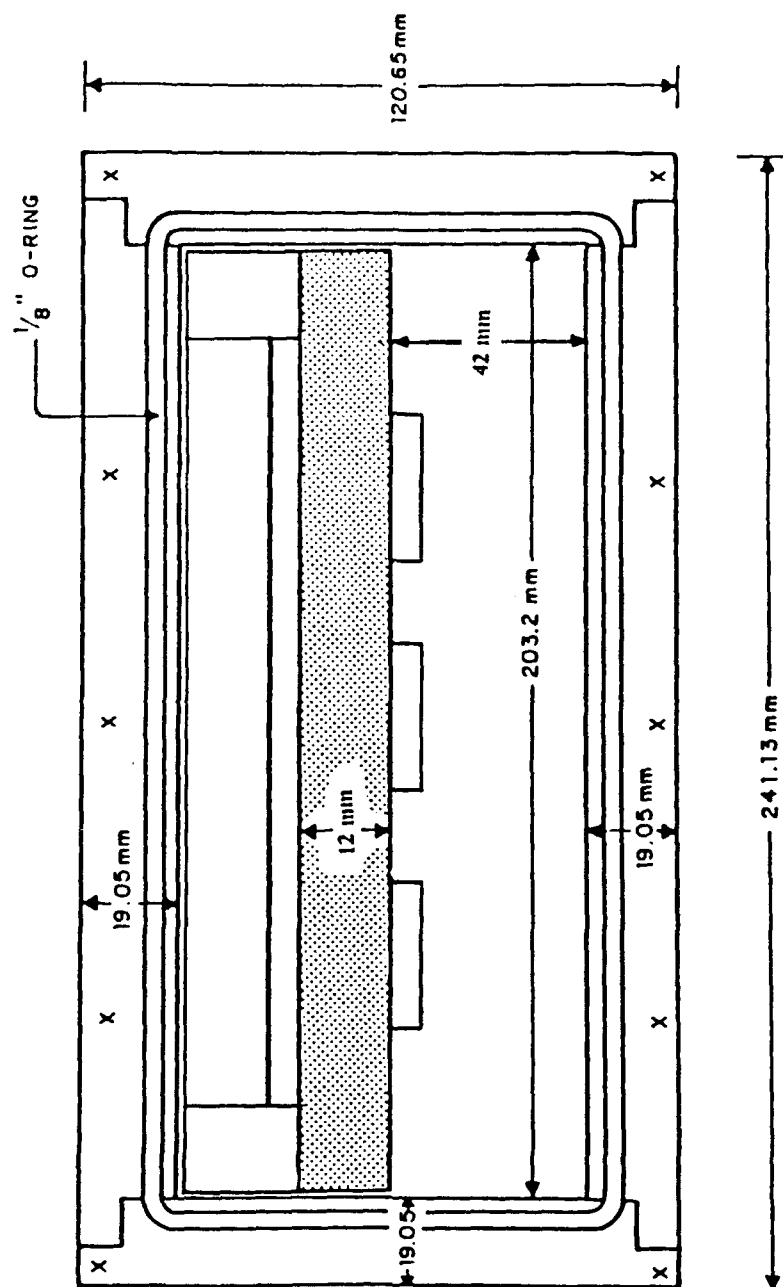


Figure 2.1. Top View of the Chamber and Circuit Board

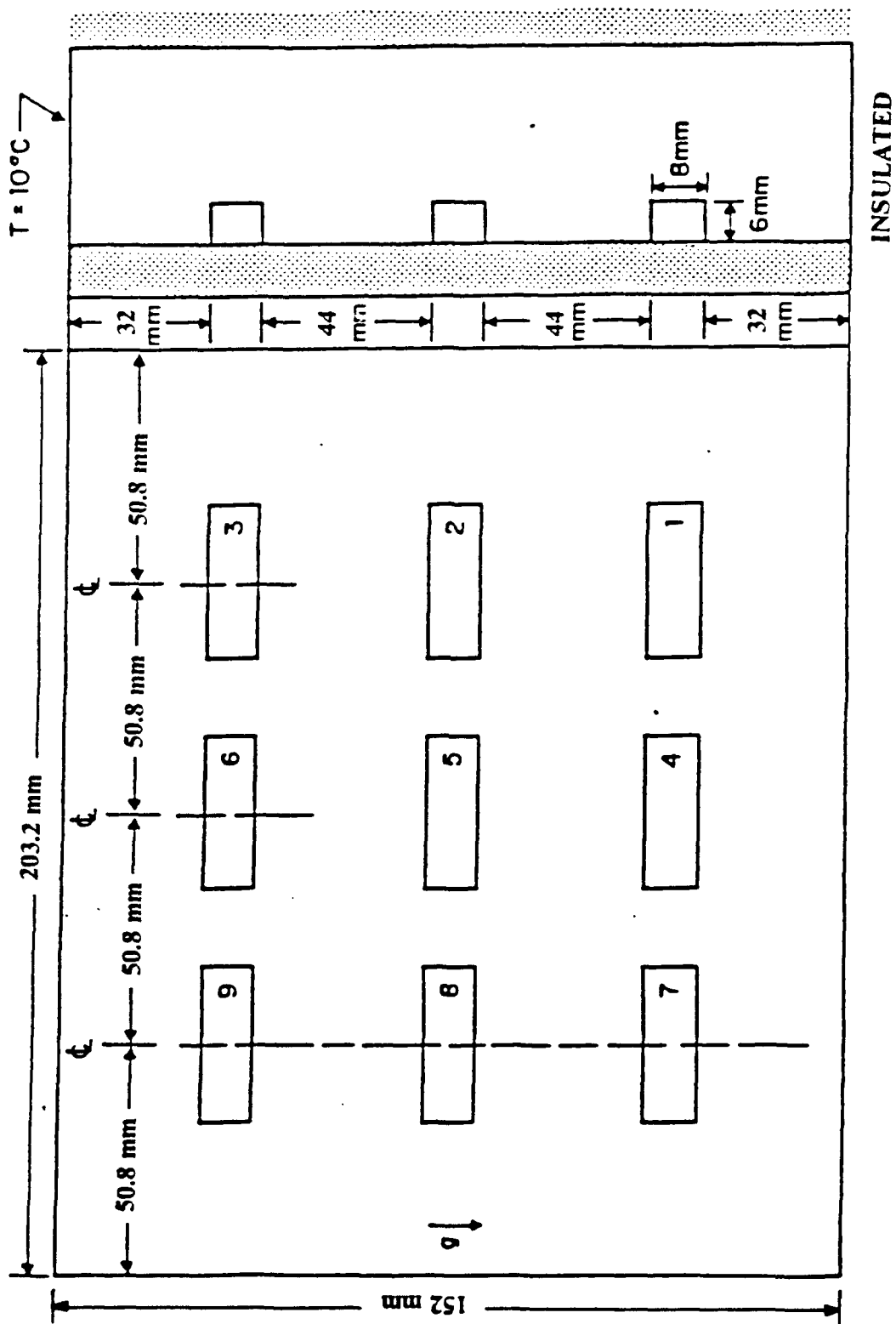


Figure 2.2. Simulated Circuit Board with Horizontally Placed Components

B. DESCRIPTION OF THE HARDWARE AND DESIGNING THE CIRCUIT BOARD

The chamber was made of 19.05 mm thick plexiglass with external dimensions of 241.13 x 152.0 x 120.65 mm. Some minor modifications were done on the chamber. The location of the steel tubings were changed in order to allow the chamber to be filled with dielectric liquids at any chamber width. The bottom heat exchanger was replaced by 12 mm thick plexiglass wall to have insulated bottom boundary condition. The external walls of the top heat exchanger were made of plexiglass. On 3 mm thick internal aluminum wall allowing almost isothermal top boundary conditions to the chamber, six thermocouples were placed symmetrically along the plate length and width. This modification was done to enable calculation of the average temperature of the top boundary, no matter what the spacing was.

The circuit board was fixed in the chamber allowing the maximum obtainable spacing of 42 mm. Two 12 mm and two 6 mm thick plexiglass spacers (152 x 203.2 mm) were used to change spacing between the circuit board and front wall of the chamber. Spacers were placed in the chamber by removing the bottom wall of the chamber. The spacings of 42 mm, 30 mm, 18 mm and 11 mm are obtainable by using these spacers.

The components were 24 x 8 x 6 mm aluminum blocks to simulate approximately a 20-pin-dual-in-line-package. Aluminum blocks were provided a nearly uniform heat flux by attaching foil heaters to the base. The approximate

resistance of the heaters was 10.3 ohms. These heaters were connected in series with $2\ \Omega \pm 2.5\%$ resistors to calculate the power dissipation on each heater. (See data analysis.)

Temperatures on the component surfaces were measured using 3 mil copper-constantan thermocouples. They were manufactured by using an arc welder. During the manufacturing process, current and time setting were kept at a minimum and the argon gas pressure was less than 5 psig. Due to the extremely small diameter of the copper and constantan, and in order not to loose strength between the bead and insulation, bare parts were kept as small as possible. Then, the bare parts except for the bead were insulated by means of electrical varnish. This process made it easier to handle the thermocouples during and after tack-welding them to the aluminum blocks.

In order to reduce the unknown contact resistance between the block surfaces and thermocouple beads, thermocouples were tack-welded to the wells machined on the blocks. (See Figure 2.3 after Benedict, 1988.) A small table vise was modified by replacing the steel jaws with copper. This prevented the blocks from being deformed and introduced lesser electrical resistance to the conduction path of the machine. During tack-welding process power rate was kept between 16-20 W/sec. Not more than two thermocouples were welded to the blocks, one at a time, because of the very brittle property of the wires after welding even under their own weight. The rest of the wells were filled with high thermal conductivity epoxy (Omega bond 101). Besides filling up the grooves it made the block easier

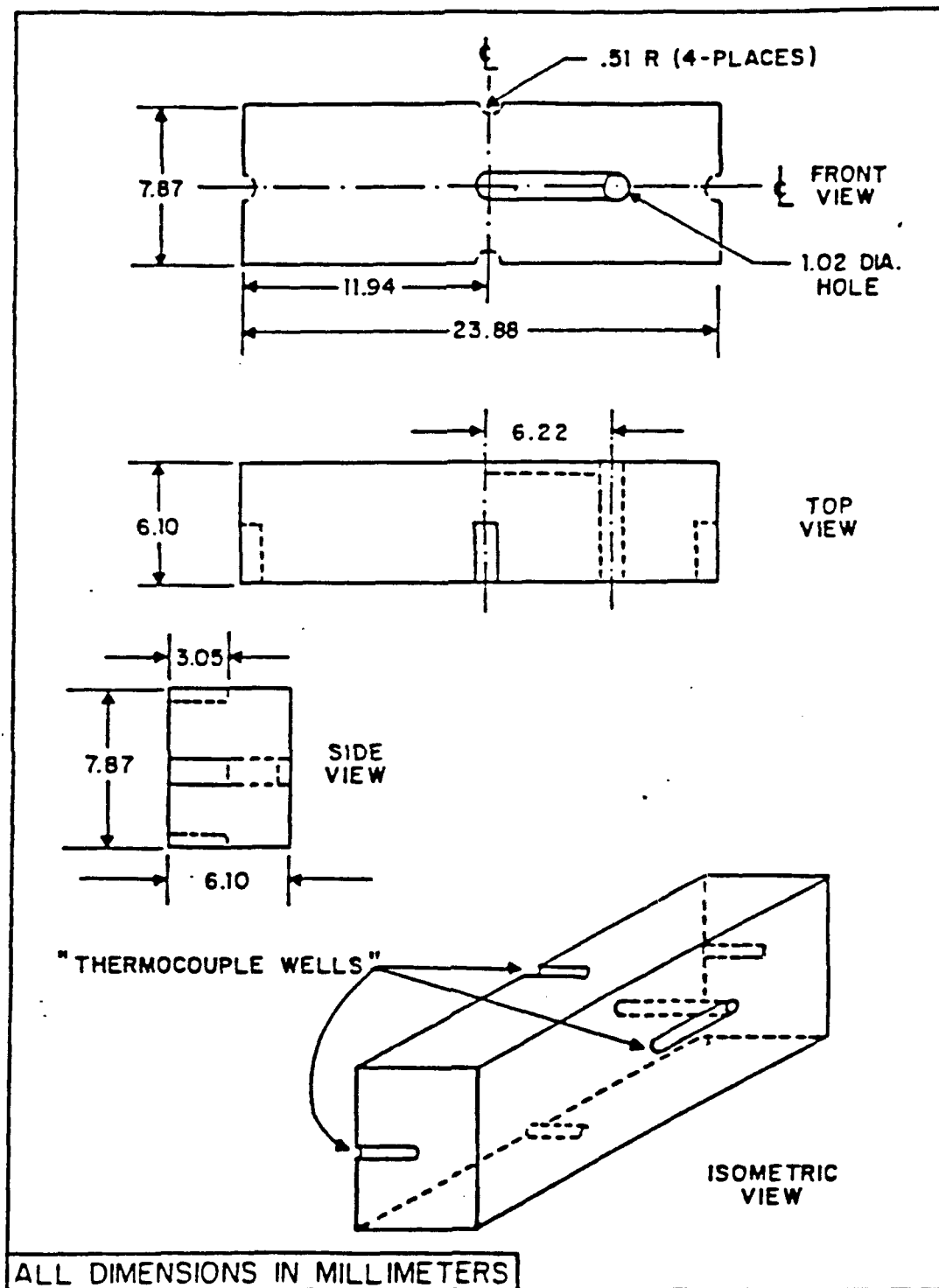


Figure 2.3. Aluminum Block and Thermocouple Location.

to handle. The same method as in measuring the front surface temperatures of the blocks was used to read the back surface temperatures of the blocks.

The next step was bonding the heaters in the grooves of 0.5 mm depth machined on the circuit board. This was done with adhesive epoxy (Omega bond 100), ensuring that the holes on the heater and plexiglass circuit board were aligned and not blocked by bonding material. Inserting the thermocouple wires attached to the blocks through the holes and making sure of proper alignment, blocks were bonded onto the heaters by means of Omega bond 101. Filling up the rest of the holes at the back of the circuit board completed the design of the new circuit board.

All thermocouples were connected to a HP-3497 data acquisition system controlled by a HP-9826 microcomputer. Power to the heaters was supplied by a 0-10 V and 0-5 A DC power supply. Channel 61 and channels 62 through 70 were connected in parallel to the power supply output and heaters. This connection then allowed measurement of the voltage drop across the precision resistors. The numbering scheme on both data acquisition system and hardware was as follows:

Channels 0 to 53: Component surface temperatures starting from chip #1 with the order of center, top, right, left, bottom and back.

Channels 54 to 56: Heat exchanger temperatures.

Channels 57 to 60 and 71 to 75: Back circuit board temperatures which allow calculation of the conduction loss.

Channel 76: Ambient temperature.

III. EXPERIMENTAL PROCEDURE

A. HARDWARE PREPARATION

Upon assembling the hardware (see Figure 3.1 after Benedict, 1988), each channel on the HP-3497 data acquisition system were scanned to verify that all nine components were equally powered and all thermocouples were operating properly. Then, the following procedure was used for each chamber width:

1. Spacing of the chamber was adjusted by removing the bottom wall of the chamber and sliding the required spacers into the chamber.
2. Constant temperature bath was energized to verify there was no external and internal leakage.
3. Chamber was filled with dielectric liquid by ensuring no air bubbles were left in it.
4. The desired power level was applied to the components by adjusting the current dial on power supply.
5. As power level increased, the dial on constant temperature bath was adjusted subsequently in order to keep the average top boundary temperature at 10°C.

B. DATA ACQUISITION

Data were recorded when steady state conditions were reached. It took approximately 4-5 hours to reach the steady state depending upon the dielectric and spacing. Since the magnitude of the fluctuations (from peak to valley) at

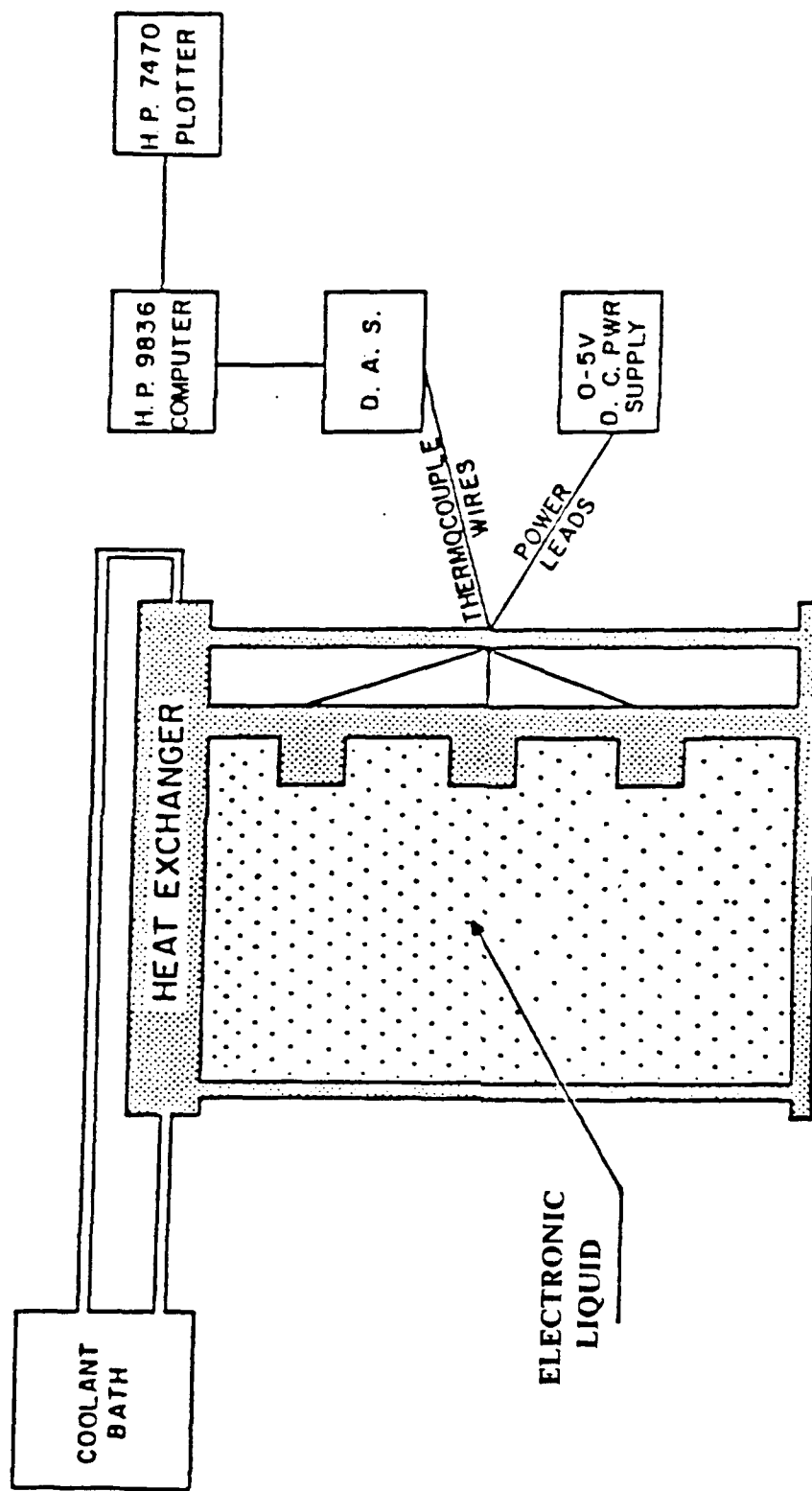


Figure 3.1. Schematic of Entire Assembly

steady state changed with the location of the component in the chamber and spacing, steady state conditions were defined separately.

When a majority of the temperatures were fluctuating less than 0.4°C (for dielectric FC-43) and less than 1.0°C (for dielectric FC-75) during 4-5 separate runs with 5-10 minute intervals, steady state was assumed.

Raw *emf* readings were recorded and analyzed by the software programs ACQUIRE, CALCDIEL, FASTSCAN and PLOT. These programs were the same as used by Pamuk (1987), Benedict (1988), Torres (1988), and Powell (1989) with some minor modifications to take care of the changing channel numbering scheme and dielectric fluid.

C. DATA ANALYSIS

Data was analyzed in following fashion to get the non-dimensional heat transfer parameters (Nu_1 , Nu_2 , Ra_r , Ra_i) of the entire array at prescribed conditions. These parameters are defined in nomenclature.

1. Calculation of the Average Wetted Surface Temperature of Component.

Upon converting the thermocouple *emfs* to temperatures ($^{\circ}\text{C}$) (See sample calculations)

$$T_{avg} = \frac{\sum_{i=1}^5 A_i T_i}{A_{total}} \quad (1)$$

where,

A_i, T_i \equiv Area and temperature of the i^{th} surface
 A_{total} \equiv Total wetted surface area of the component.

2. Calculation of the Power Dissipated by Heater

$$Power = emf (voltage - emf) / R_p \quad (2)$$

where,

$voltage$ \equiv Power supply voltage (Channel 61)
 emf \equiv Voltage across the heaters (Channels 62 to 70)
 R_p \equiv Resistance of precision resistors connected in series to the heaters ($2 \Omega \pm 2.5\%$).

3. Calculation of the Conduction Loss Through the Circuit Board

Assuming 1-D conduction through the back surface area of the components

$$Q_{loss} = \frac{\sum_{n=1}^9 (\Delta T_n / R_c)}{9} \quad (3)$$

$$R_c = t / k_p A \quad (4)$$

$$\Delta T = T_{cb} - T_{bp} \quad (5)$$

where,

- $R_c \equiv$ Conductive resistance of the plexiglass
- $T_{cb} \equiv$ Component back surface temperatures
- $T_{bp} \equiv$ Back circuit board temperatures
- $t \equiv$ Thickness of the circuit board (Length of the conduction path)
- $k_p \equiv$ Thermal conductivity of the plexiglass
- $A \equiv$ Back surface area of the component.

4. Calculation of the Heat Transfer Coefficient

Average heat transfer coefficient around the wetted surface of the component was defined as:

$$h = \frac{Q_{net}}{A_{total} (T_{avg} - T_{sink})} \quad (6)$$

$$Q_{net} = Power - Q_{loss} \quad (7)$$

$$T_{sink} = \frac{T(54) + T(55) + T(56)}{3} \quad (8)$$

where,

- $Q_{net} \equiv$ Net power dissipated by the heater
- $T_{sink} \equiv$ Average temperature of the heat exchanger, i.e., top boundary temperature of the chamber (Channels 54, 55, and 56 on hardware).

5. Calculation of the Thermophysical Properties of the Dielectrics

Functional relationships between the thermophysical properties and the film temperatures are listed below, where film temperature was defined as:

$$T_{film} = (T_{avg} + T_{sink}) / 2 \quad (9)$$

a. Thermal Conductivity $k(W/mK)$

$$FC-75 \quad [0.65 - 7.8947E - 4 * T_{film}] / 10 \quad (10)$$

$$FC-43 \quad [0.666 - 9.864E - 5 * T_{film}] / 10 \quad (11)$$

b. Density $\rho(kg/m^3)$

$$FC-75 \quad [1.825 - 0.00246 * T_{film}] * 1000 \quad (12)$$

$$FC-43 \quad [1.913 - 0.00218 * T_{film}] * 1000 \quad (13)$$

c. Specific Heat $C_p (J/kg K)$

For all dielectrics

$$[0.241111 + 3.7037E - 4 * T_{film}] * 4180 \quad (14)$$

d. Kinematic viscosity $\nu(m^2/s)$

$$FC-75 \quad [1.4074 - 2.964E - 2 * T_{film} + 3.8018E - 4 * T_{film}^2 - 2.7308E - 6 * T_{film}^3 + 8.1679E - 9 * T_{film}^4] * E^{-6} \quad (15)$$

$$FC-43 \quad [8.8750 - 0.47007 * T_{film} + 1.387E - 2 * T_{film}^2 - 2.1469E - 4 * T_{film}^3 + 1.3139E - 6 * T_{film}^4] * E^{-6} \quad (16)$$

e. Thermal Expansion Coefficient β (K^{-1})

$$FC-75 \quad [0.00246 / (1.825 - 0.00246 * T_{film})] \quad (17)$$

$$FC-43 \quad [0.00218 / (1.913 - 0.00218 * T_{film})] \quad (18)$$

f. Thermal Diffusivity α (m^2/s)

$$\alpha = k / (\rho C_p) \quad (19)$$

6. Calculation of the Nusselt Numbers

a. Nusselt Number Based on the Height of the Component

$$Nu1 = h * L1 / k_f \quad (20)$$

where,

$L1 \equiv$ Height of the components in the direction of the gravity vector

$k_f \equiv$ Thermal conductivity of the dielectric fluid at film temperature.

b. Nusselt Number Based on the Ratio (Area/Perimeter) of the Component

$$Nu_2 = h * L_2 / k_f \quad (21)$$

$$L_2 = \sum_{i=1}^5 (A_i / P_i) \quad (22)$$

where,

A_i, P_i \equiv Area and the perimeter of the i^{th} surface of the component.

7. Calculation of the Grashof Number

Grashof Number in this study was defined as,

$$Gr = (g \beta L^3 \Delta T) / \nu^2 \quad (23)$$

where,

$$\Delta T = T_{avg} - T_{sink} \quad (24)$$

g \equiv Gravitational acceleration

8. Calculation of the Prandtl Number

$$Pr = \nu / \alpha \quad (25)$$

9. Calculation of the Rayleigh Numbers

a. Temperature Based Rayleigh Number

$$Ra_i = Gr Pr \quad (26)$$

b. Flux Based Rayleigh Number

$$Ra_i = g \beta L^4 Q_{net} / (k_i \nu \alpha A_{total}) \quad (27)$$

The above procedure was repeated for each component.

IV. RESULTS AND DISCUSSION

A. HEAT TRANSFER MEASUREMENTS

Heat transfer measurements were done in the power level range of 0.115 W to 2.9 W per component to examine the effect of chamber width (i.e., spacing) on heat transfer parameters of the components. Two dielectric liquids, FC-75 and FC-43, were used. Five different spacings from maximum obtainable with the available chamber to minimum were applied to the chamber for each liquid. These spacings were 42 mm, 30 mm, 18 mm, 11 mm and 7 mm. During the experiments top and bottom boundary conditions were kept constant at 10°C and insulated respectively.

Component surface temperatures and nondimensional heat transfer parameters were both tabulated and plotted. Array-averaged component temperatures and nondimensional parameters (i.e., $Nu1$ and Ra_i) of the entire array were also plotted for each fluid to present the effect of spacing in both dimensional and nondimensional terms.

Due to the similar behavior of the components on the same row, correlation formulas which relate the row-averaged and array-averaged $Nu1$ and Ra_i were obtained in the form of $Nu1 = a Ra_i^b$, where a and b are constant.

In the case of FC-75 and spacings of 30 mm and 7 mm, and in the case of FC-43 and spacing of 7 mm, surface temperature fluctuations of Channel 0 (i.e., Chip #1 front surface temperature), 12 (i.e., Chip #3 front surface temperature), 31

(i.e., Chip #6 top surface temperature) were recorded at steady state for a period of 200 sec.

1. Results for FC-75

Surface temperature measurements and nondimensional form of the data in terms of Ra_i , Ra_o , $Nu1$ and $Nu2$ for each spacing are presented in Tables 1 through 35 in Appendix C.

For the graphical representation of the results, two sets of plots were generated. The first set from Figure 4.1 to 4.5 represents the heat transfer behavior of the components in nondimensional terms (i.e., Ra_i vs. $Nu1$). The second set represents the averaged behavior of the entire array in both temperature (Figure 4.6) and nondimensional terms (Figure 4.7).

As is seen from the first set, the data reveal almost a single slope in the range $10^2 < Ra_i < 2 * 10^8$. The data obtained at the lowest power level tended to deviate from this behavior. The maximum spread in magnitude of Rayleigh numbers of the components at a power setting of 2.9 W and 7 mm spacing was less than 7% of the highest Ra_i . The maximum deviation in Nusselt numbers ($Nu1$) of the components was met at Rayleigh number of $1.8 * 10^8$ for the spacings of 42 mm and 30 mm. The magnitude of the maximum deviation from the array-averaged $Nu1$ was ± 1.45 (i.e., $\pm 7\%$) which corresponds to 6°C temperature difference between the components having maximum and minimum average temperatures. Deviation from the array averaged $Nu1$ was less than ± 0.5 for other spacings (i.e., 18 mm, 11 mm, 7 mm).

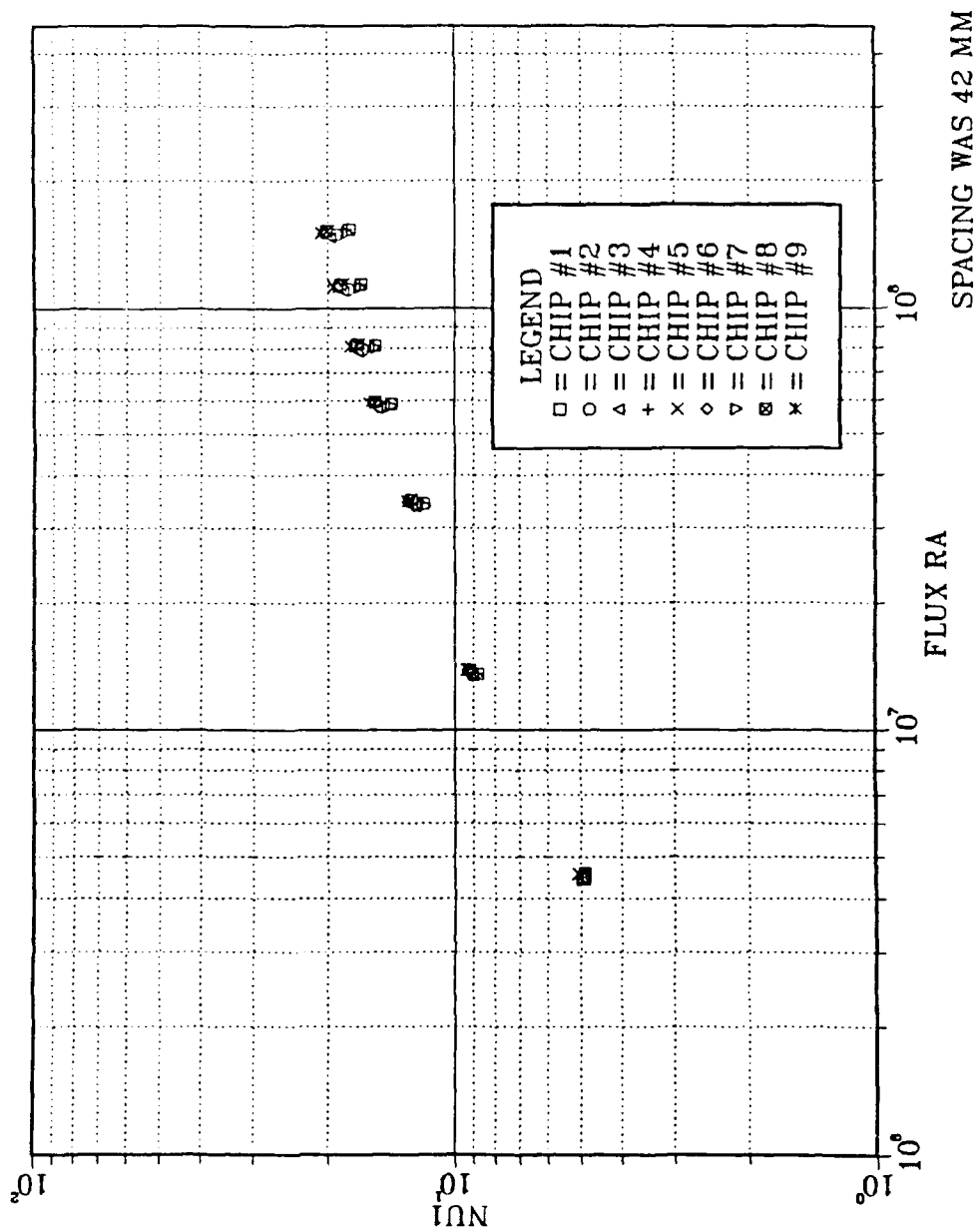


Figure 4.1.1. Plot of Nu1 vs. Ra, for FC-75 and 42 mm Spacing

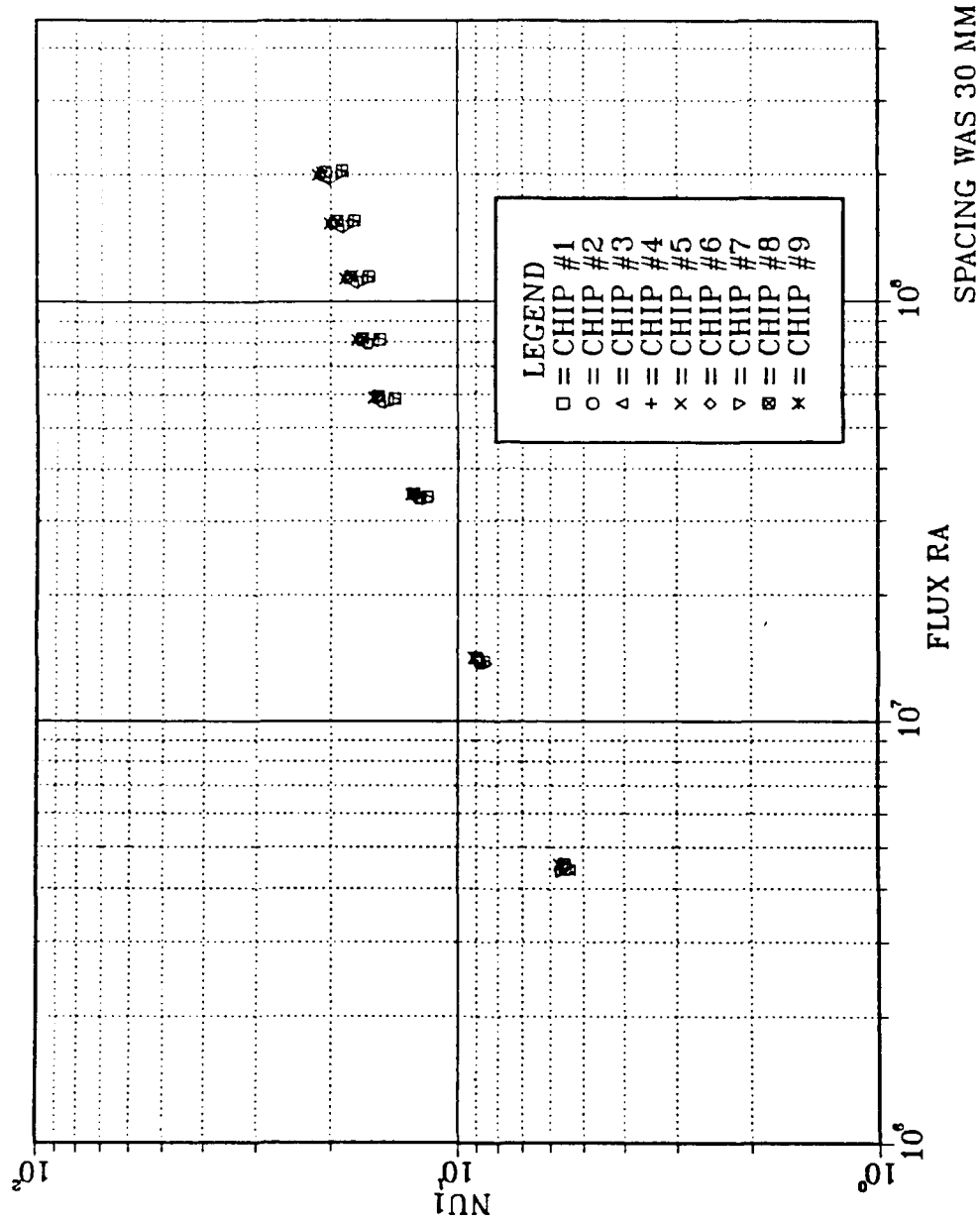


Figure 4.2. Plot of Nu1 vs. Ra, for FC-75 and 30 mm Spacing

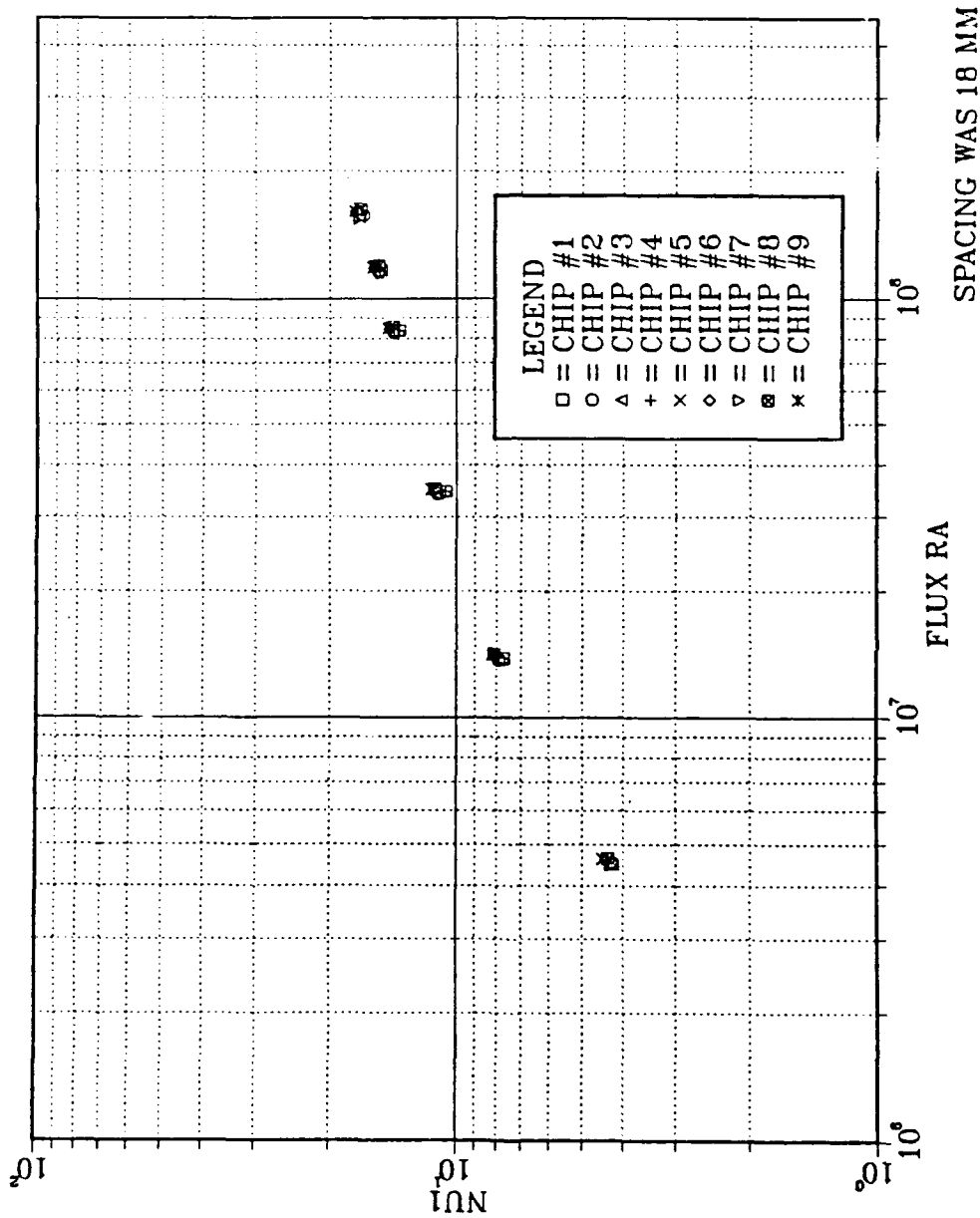


Figure 4.3. Plot of Nu1 vs. Ra, for FC-75 and 18 mm Spacing

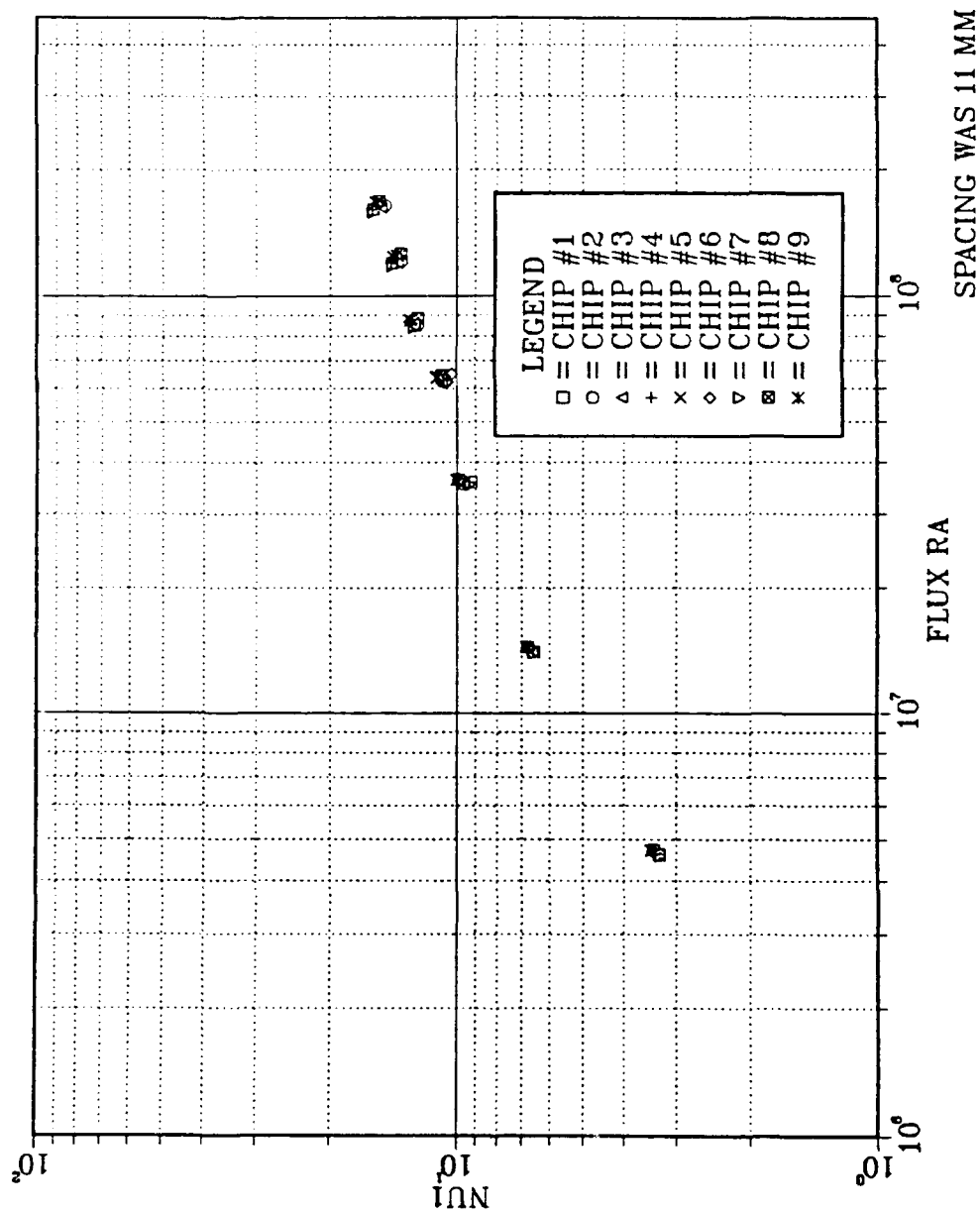


Figure 4.4. Plot of Nu1 vs. Ra, for FC-75 and 11 mm spacing

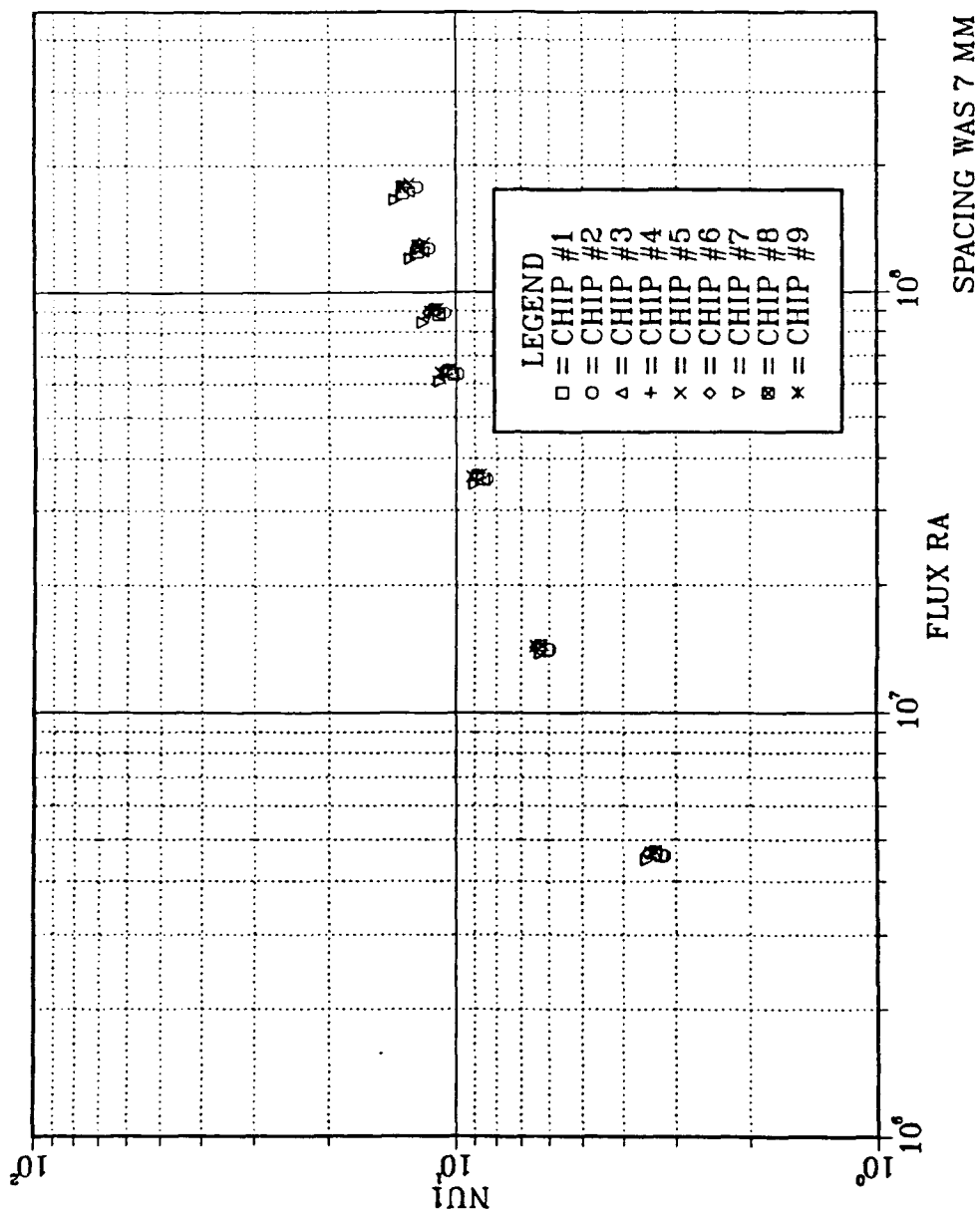


Figure 4.5. Plot of Nu1 vs. Ra, for FC-75 and 7 mm spacing

Due to similar behaviors of the components in the array, array-averaged plots in both nondimensional (Ra , vs. $Nu1$) and dimensional terms were generated. These plots then allowed discussion of the effect of spacing on heat transfer characteristics of the entire array.

Reviewing Figure 4.7, an interesting phenomena arises in the range $10^7 < Ra, < 2 * 10^8$. In this Rayleigh Number range data points indicate almost a constant slope regardless of spacing. The slopes of best fit lines obtained excluding the data points at Rayleigh Number of $4.5 * 10^6$ were between 0.296 and 0.340. This behavior then allowed the correlation of the effect of spacing (see section 5).

Reviewing Figure 4.6, a decrease in spacing caused an increase in component average temperatures throughout the array. Array-averaged temperature increase reveal almost a single slope for each spacing, but it became steeper as spacing decreases. The magnitude of temperature increase between the chamber widths of 42 mm and 7 mm was almost 3°C at 0.115 W power level. It increased up to 15°C at 2.9 W power level. A possible explanation may be that, at low power levels there is very little effect of decrease in spacing on weak circulating flow, so boundary conditions of the chamber dominates the heat transfer characteristics. At high power levels, decrease in spacing disturbs the strong flow around the components and this affects the heat transfer characteristics. The temperature difference between the surfaces of the each individual components was not significant and it was less than 0.5°C during the experiments. The

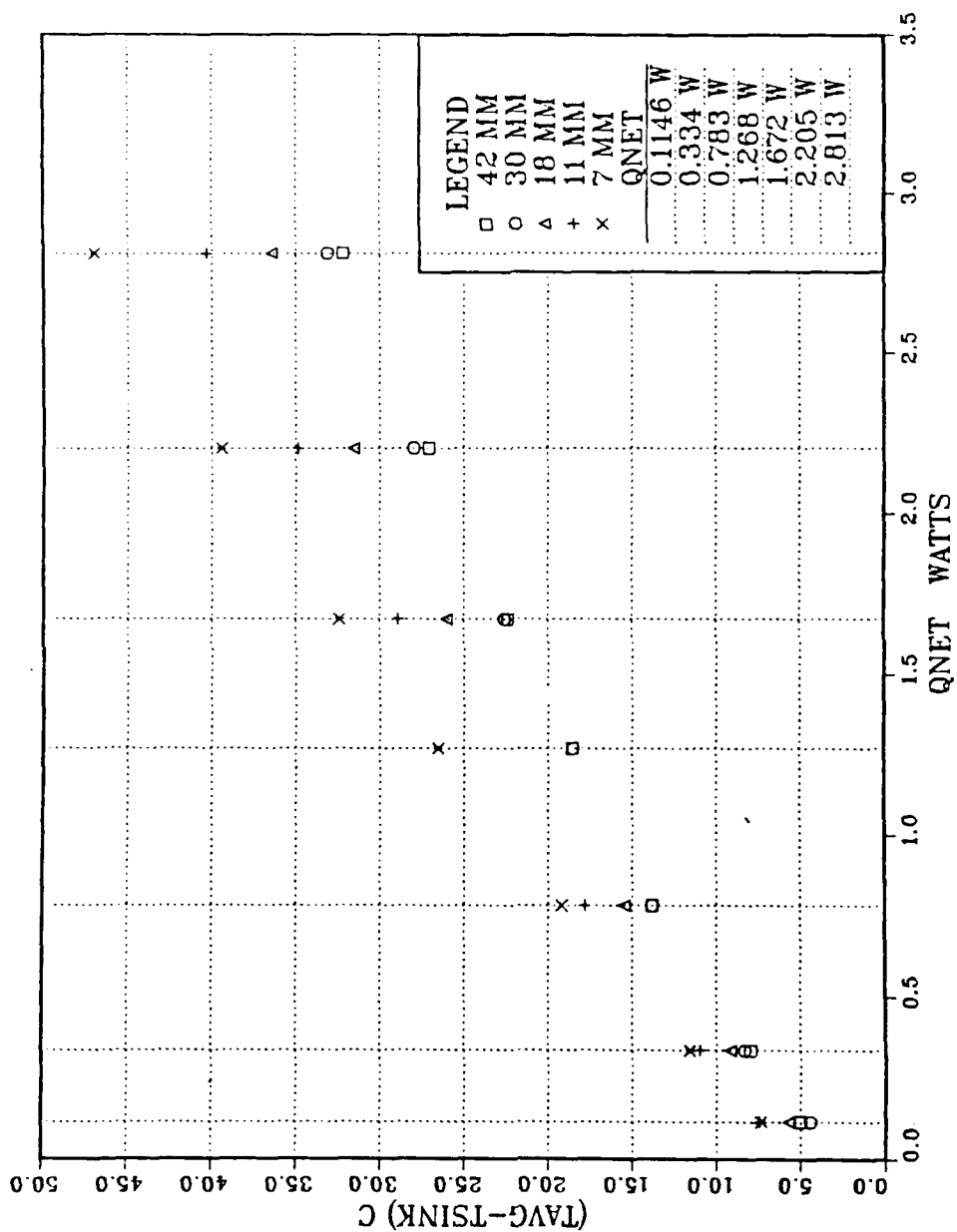


Figure 4.6. Plot of Array-averaged ($T_{avg} - T_{sink}$) vs. Q_{net} for FC-75 and all Spacings

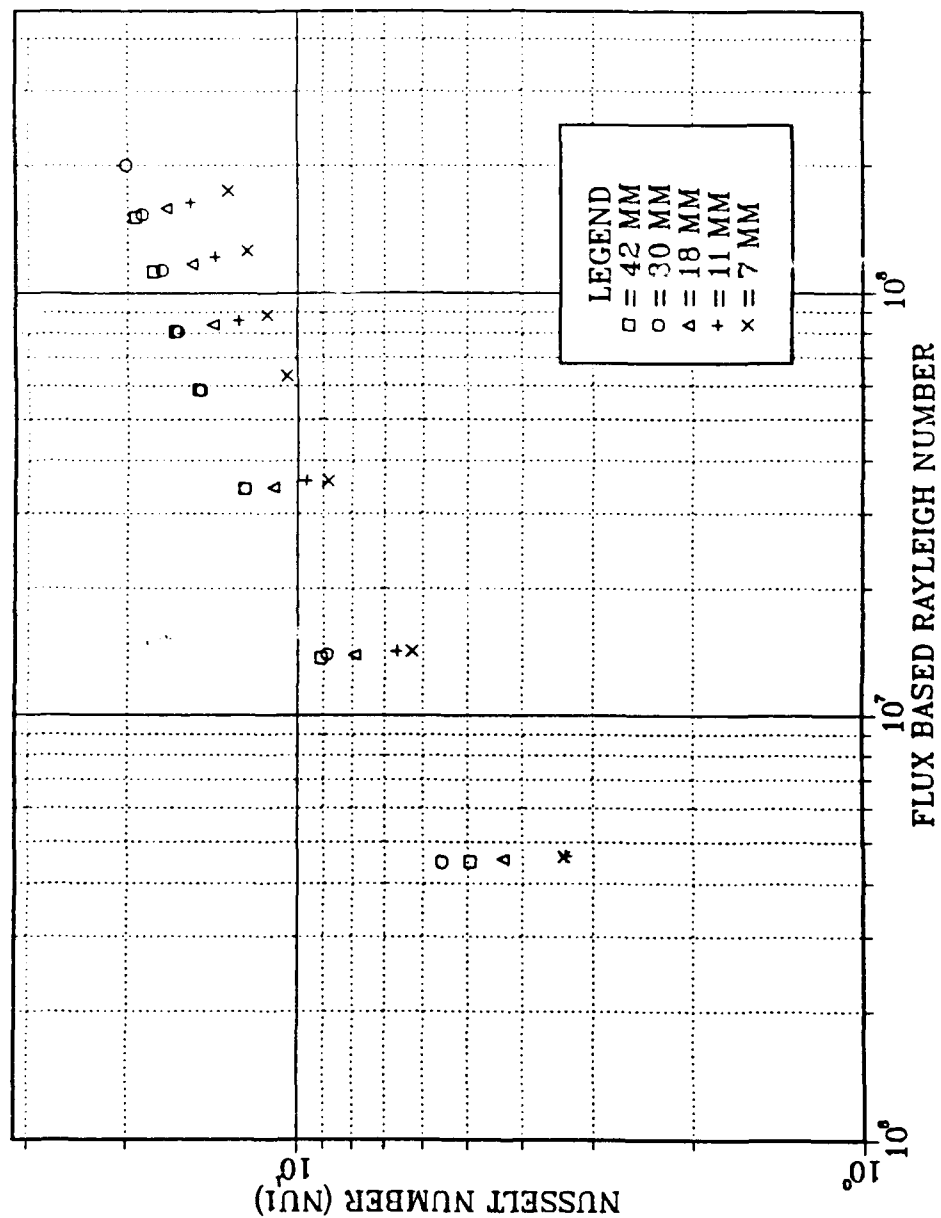


Figure 4.7. Plot of Array-averaged Nu_1 vs. Ra_1 for FC-75 and all Spacings

components in the same row behaved similarly in both temperature and nondimensional parameters except at the smaller spacings.

Mass flow rate of coolant through the effective width of the heat exchanger was decreased subsequently with decreasing spacing. This caused some increase between the coolant outlet and inlet temperature. As a result of that, the components in the column closer to the outlet of the heat exchanger had higher temperatures than the components in the same row but in the other two columns.

For the chamber widths of 42 mm and 30 mm, the order of increasing surface temperatures of the rows was bottom, middle, top. Up to power level of 2.25 W for 18 mm and 1.7 W for 11 and 7 mm, this trend did not change. After the power levels described above, the middle row components had the highest average temperatures and the bottom row components had the lower average temperatures. In any case, the maximum temperature difference between the components on different rows did not exceed 6°C.

2. Comparison with Earlier Data

Using dielectric fluid FC-75, setting the top and bottom boundaries to 10°C and insulated respectively, data for 30 mm chamber width were presented in Figure 4.2 as Ra , vs. $Nu1$.

Averaged non-dimensional heat transfer parameters of the entire array for various power levels both from this study and that of Torres (1988) were plotted in Figure 4.8.

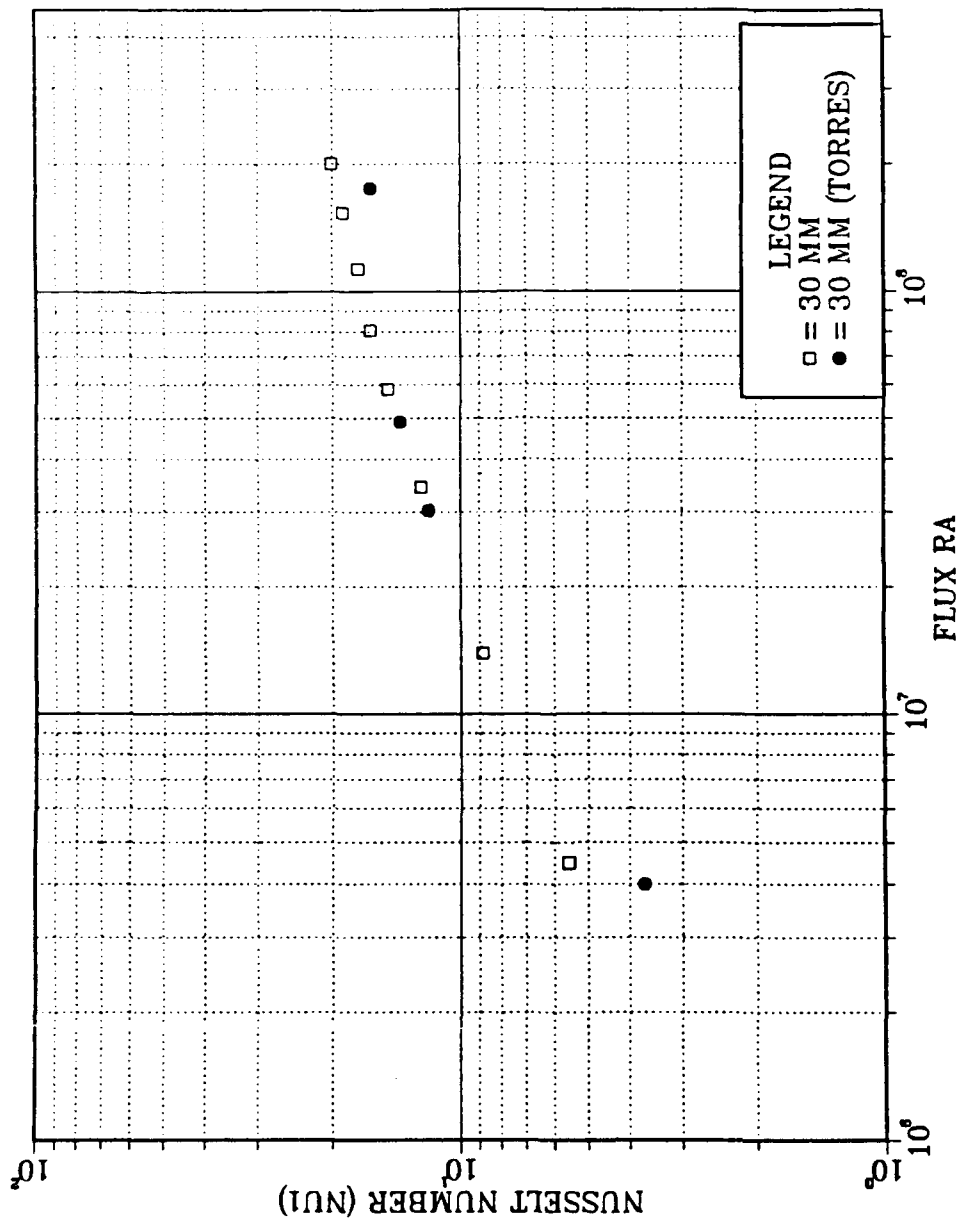


Figure 4.8. Plot of Array-averaged Nu1 vs. Ra, From Both This Study and Torres (1988) for FC-75 and 30 mm Spacing

Comparing the results with Torres' data obtained with the same boundary conditions and chamber width but different spacing on component arrangement and smaller chamber dimensions, good agreement was found at the middle range power levels. At very high and very low power levels, Torres (1988) obtained smaller Nusselt numbers. This may be due to effect of the differences in the amount of the liquid in the two chambers.

3. Results for FC-43

Surface temperature measurements and Nusselt number versus Rayleigh number form of the data for each spacing are presented in Tables 36 through 69 in Appendix C.

Two sets of plots as in the FC-75 case were produced to present the data graphically.

The first observation as a result of high fluid Prandtl number was an increase in average component surface temperatures and decrease in Rayleigh numbers of the components.

Reviewing Figures 4.9 to 4.13, the data indicate almost a single slope except the one obtained at 0.115 W power level. This was the general trend of data which was experienced in the case of FC-75 and also in previous studies.

The maximum spread in magnitude of Rayleigh numbers was almost 12% of the highest Ra , after the power level of 1.3 W for spacings of 11 and 7 mm. Maximum spread in magnitude of $Nu1$ met at 2.9 W power level for 7 mm spacing was 1.51. The deviation from the array averaged $Nu1$ was $\pm 7\%$ which

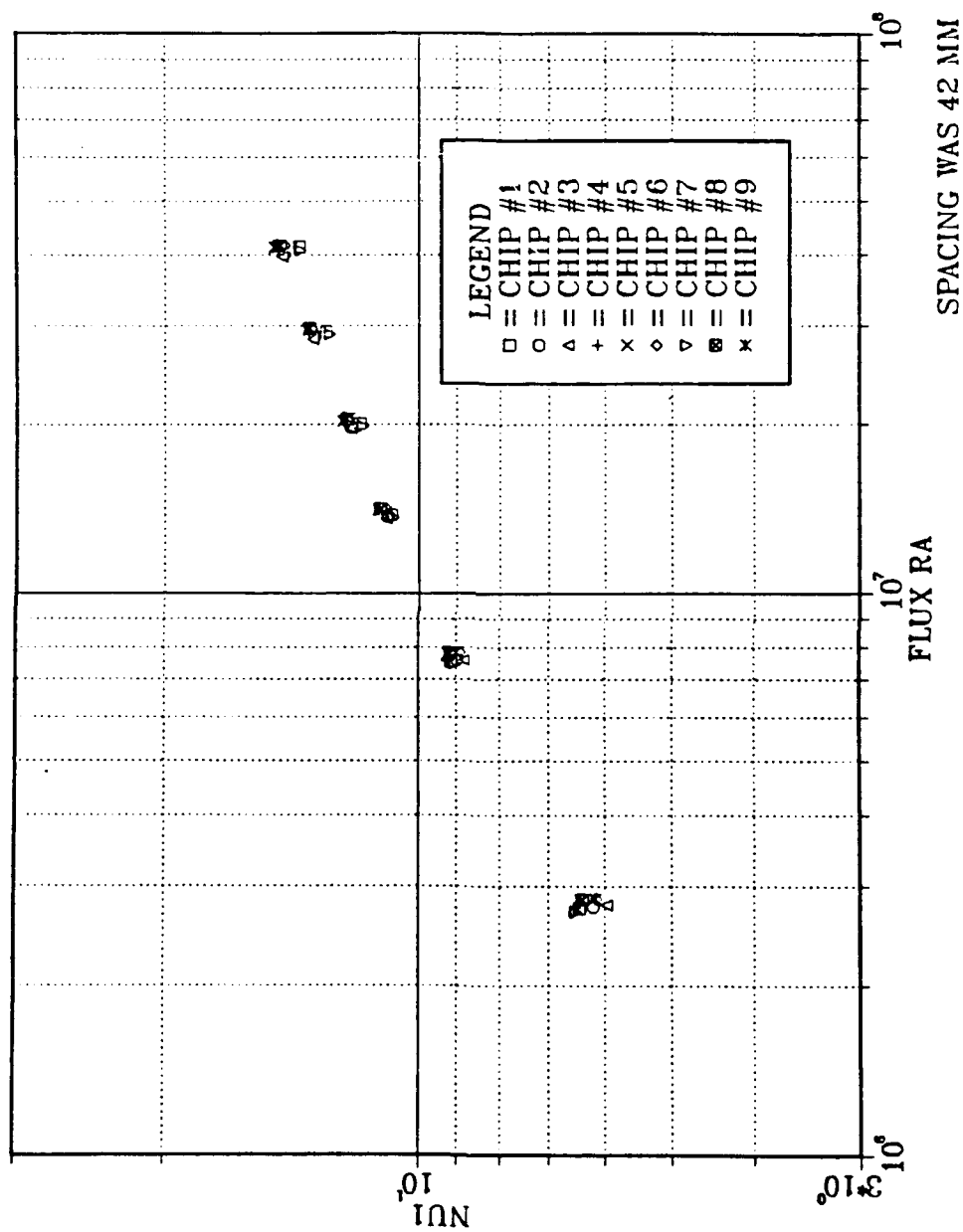


Figure 4.9. Plot of Nu1 vs. Ra, for FC-43 and 42 mm Spacing

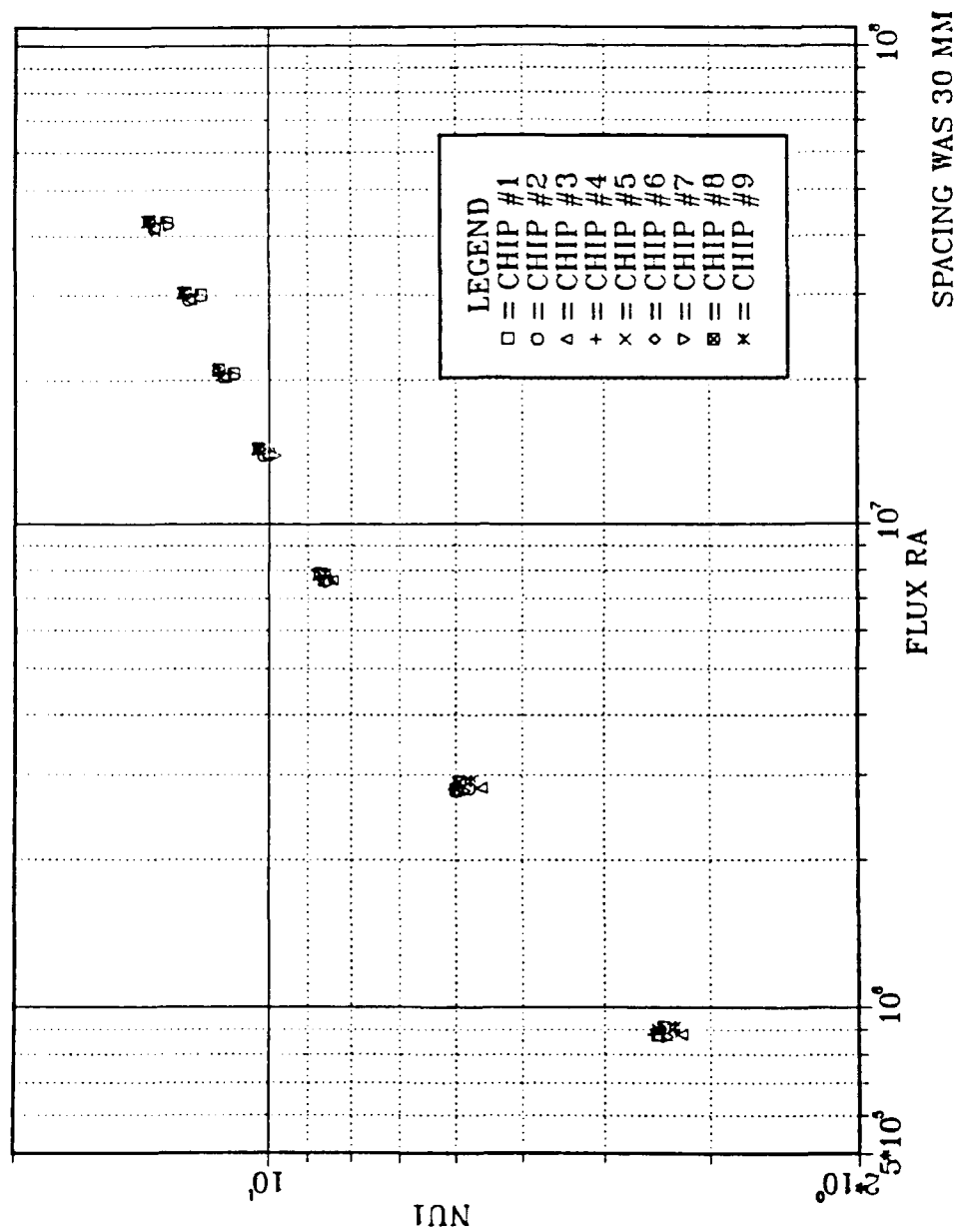


Figure 4.10. Plot of Nu1 vs. Ra, for FC-43 and 30 mm Spacing

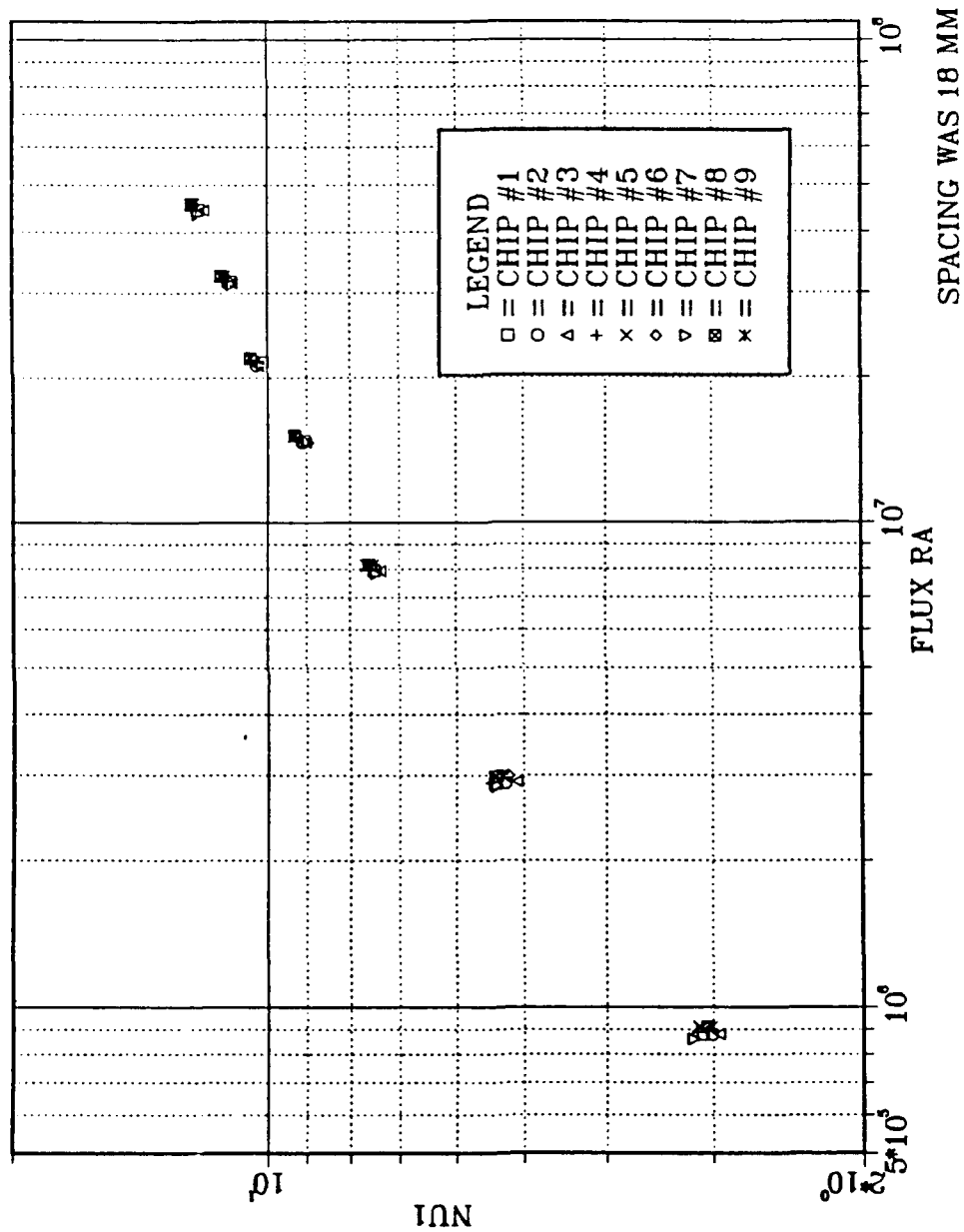


Figure 4.11. Plot of Nu1 vs. Ra, for FC-43 and 18 mm Spacing

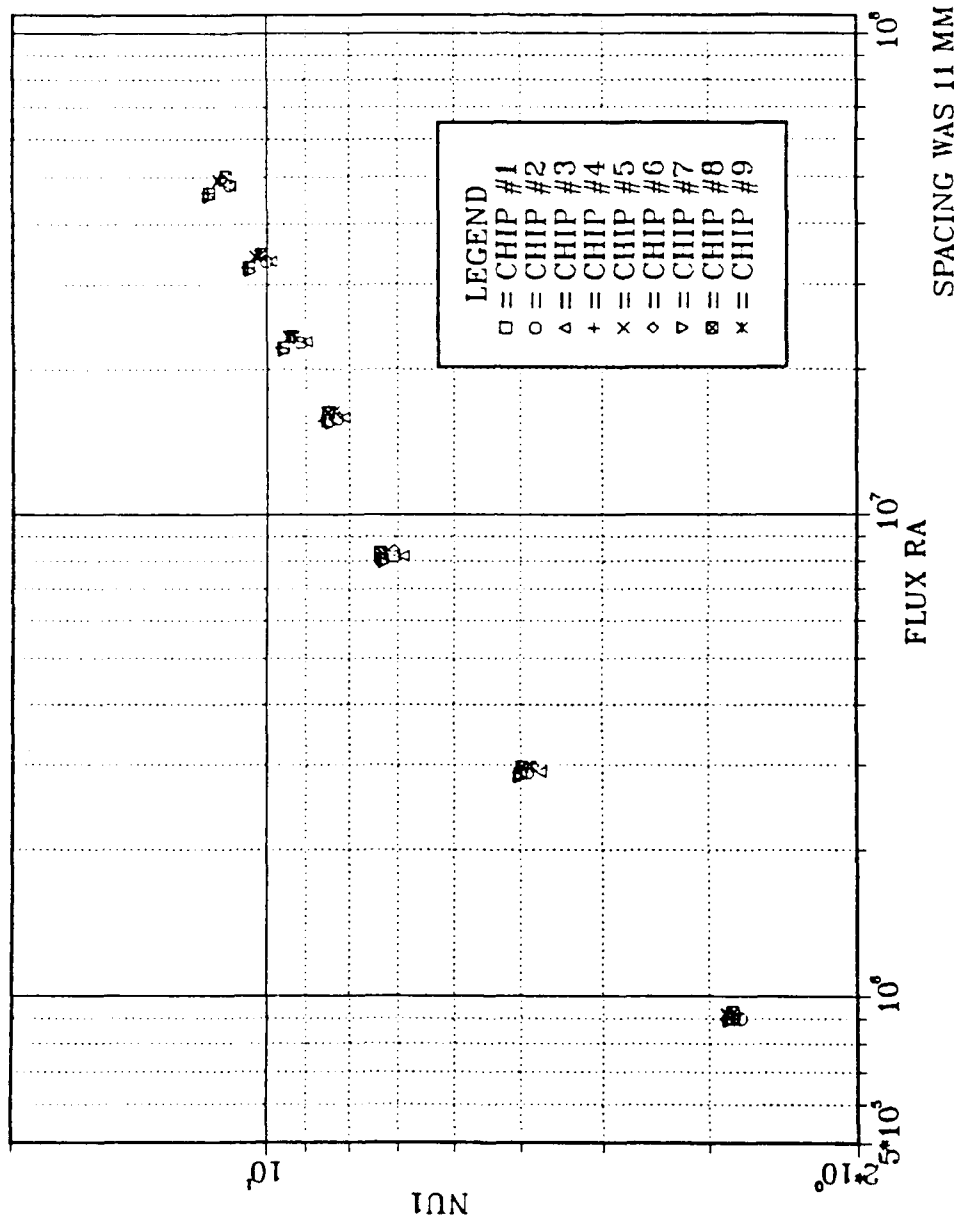


Figure 4.12. Plot of Nu1 vs. Ra, for FC-43 and 11 mm Spacing

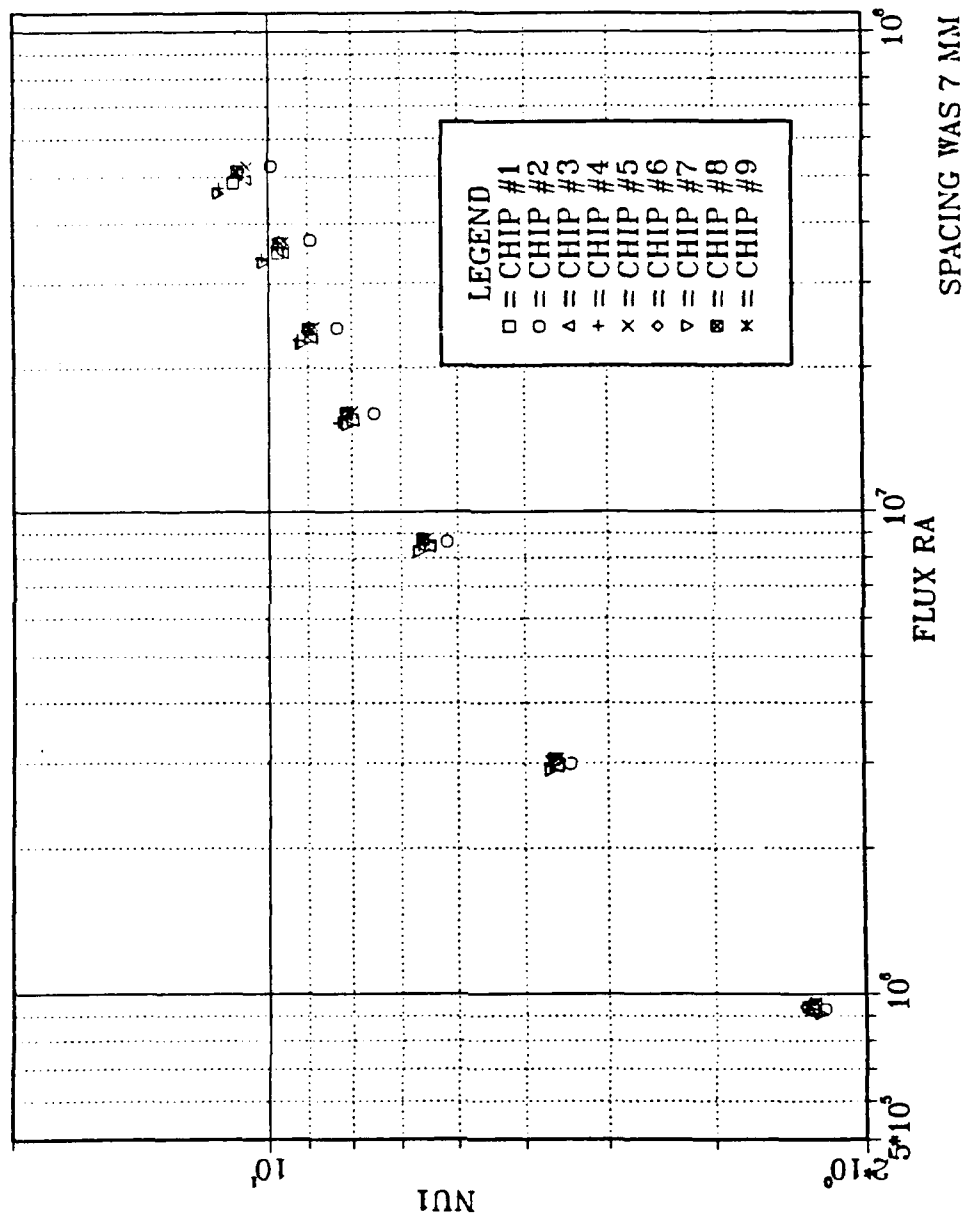


Figure 4.13. Plot of Nu1 vs. Ra, for FC-43 and 7 mm Spacing

corresponds to 8°C temperature difference between the components having maximum and minimum average temperatures.

As is seen in Figure 4.13, for the spacing of 7 mm, Chips #2 and 7 tend to deviate from other data points. As was mentioned before, a possible reason for that is, almost 2.5°C temperature difference between the ends (correspond to inlet and outlet of the heat exchanger) of the top boundary. Some change in design of the heat exchanger which allows an increase in the mass flow rate of the coolant would result obtaining better data for this spacing.

Reviewing Figure 4.14, the same behavior of data points as in FC-75 was observed. In the range $3 * 10^6 < Ra_f < 5 * 10^7$ data points reveal almost a constant slope regardless of spacing. The slopes of best fit lines were between 0.293 and 0.308.

As is seen from Figure 4.15, decreasing spacing caused an increase in component surface temperatures throughout the array. The magnitude of the temperature increase between the chamber widths of 42 mm and 7 mm was almost 3°C at 0.115 W power level and 13°C at 2.9 W power level.

For the spacings of 42 and 30 mm, the temperature difference between the components having maximum and minimum surface temperatures in the array was less than 1.5°C. For 18 mm spacing, the component surface temperatures were almost equal regardless of power level. For the spacings of 11 mm and 7 mm, the bottom row had the lowest temperatures. The middle and top row

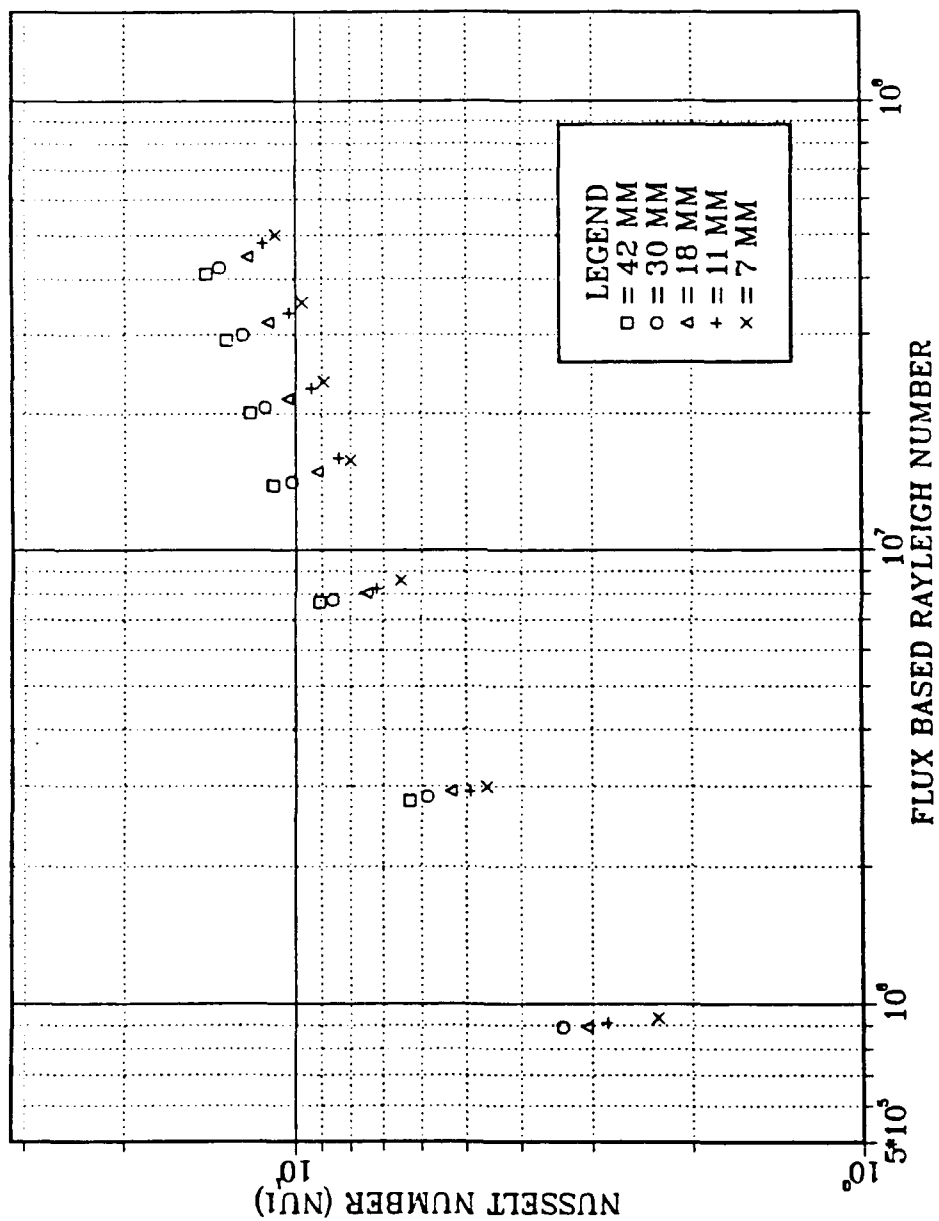


Figure 4.14. Plot of Array-averaged Nu1 vs. Ra, for FC-43 and All Spacings

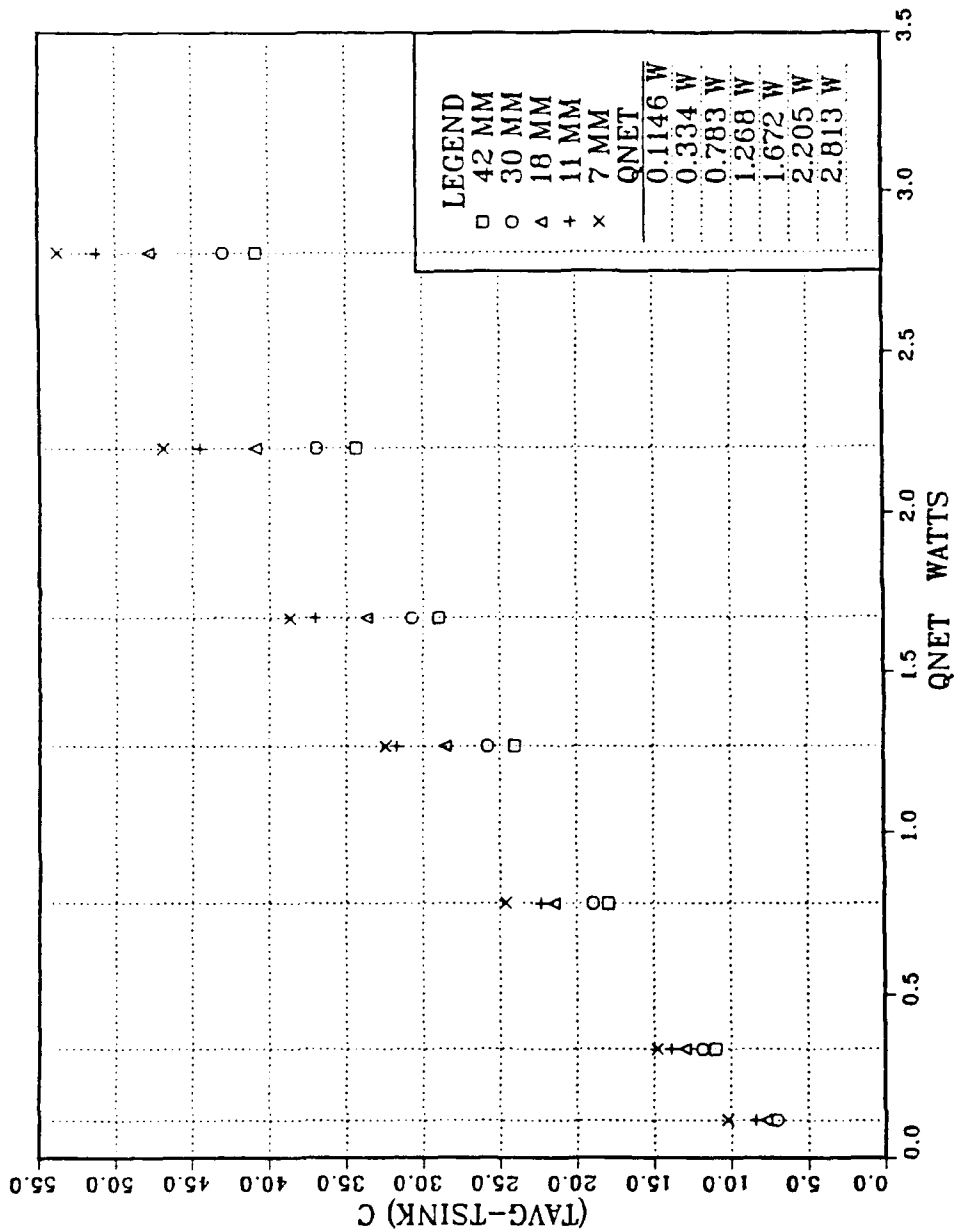


Figure 4.15. Plot of Array-averaged ($T_{avg} - T_{sink}$) vs. Q_{net} for FC-43 and All Spacings

behaved similarly at 11 mm spacing but an increase in middle row temperatures over the top row was observed at 7 mm spacing.

4. Correlations of the Non-dimensional Data

Due to the similar behavior of the components in the same row, plots of row-averaged and entire array-averaged $Nu1$ vs. Ra_r were produced for each spacing and fluid. Using a computer software program "TABLECURVE," the best fit correlation formulas were obtained for each case in the form of $Nu1 = a Ra_r^b$ where a and b are constant. Both the nondimensional row-averaged and array-averaged data and correlation formulas were plotted in Figures 4.16 through 4.20 for FC-75, and Figures 4.21 through 4.25 for FC-43.

5. Formulation of Effect of Spacing

To formulate the effect of spacing on nondimensional parameters (i.e., Ra_r and $Nu1$), constant slope behavior of the data in the range $10^7 < Ra_r < 2 * 10^8$ for FC-75 and $3 * 10^6 < Ra_r < 5 * 10^7$ for FC-43 were used. Only array-averaged nondimensional parameters were considered in this study.

Since the slope was independent of the chamber width and fluid Prandtl number which was covered in this study, best fit equations were modified to the equations in the form of $Nu1 = a Ra_r^{0.3}$ to give minimum deviation from original best fit equations.

The data points and modified best fit equations for each fluid were presented in Figures 4.26 and 4.27.

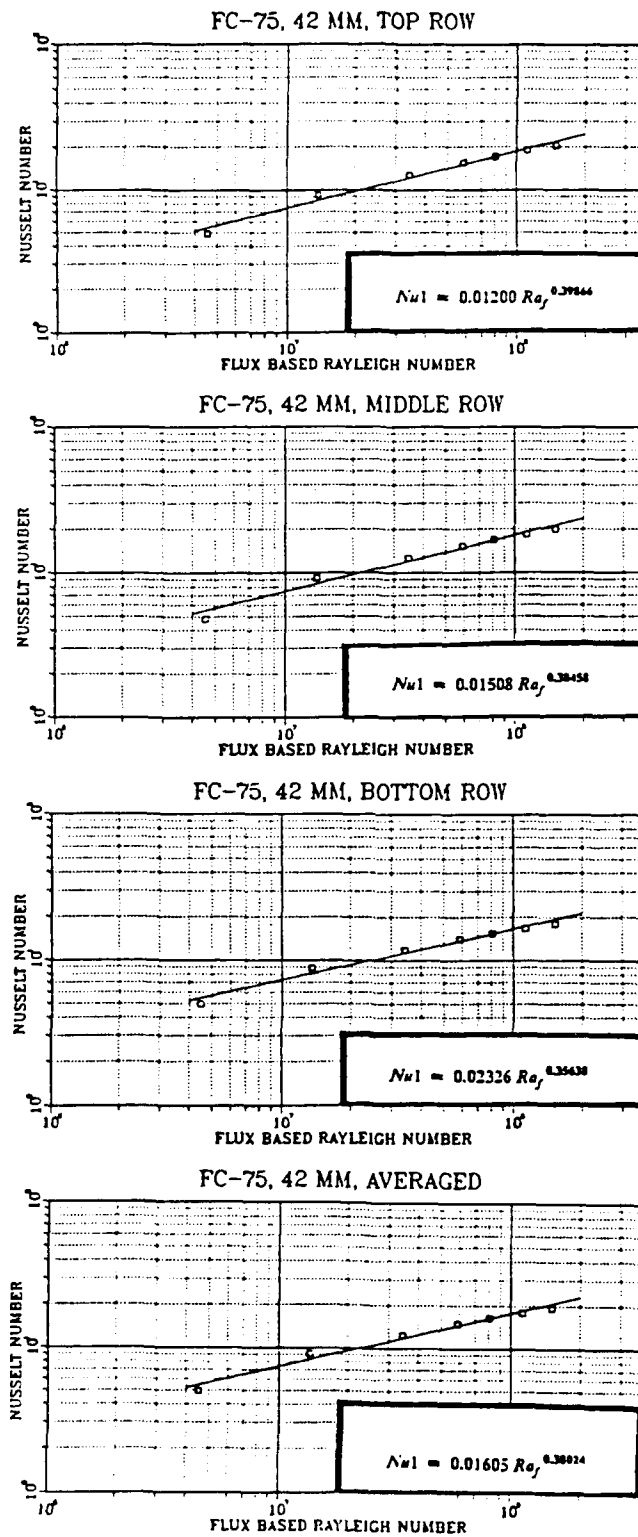


Figure 4.16. Plot of Row/Array-averaged Nu_1 vs. Ra_f and Curve Fit Equations for FC-75 and 42 mm Spacing

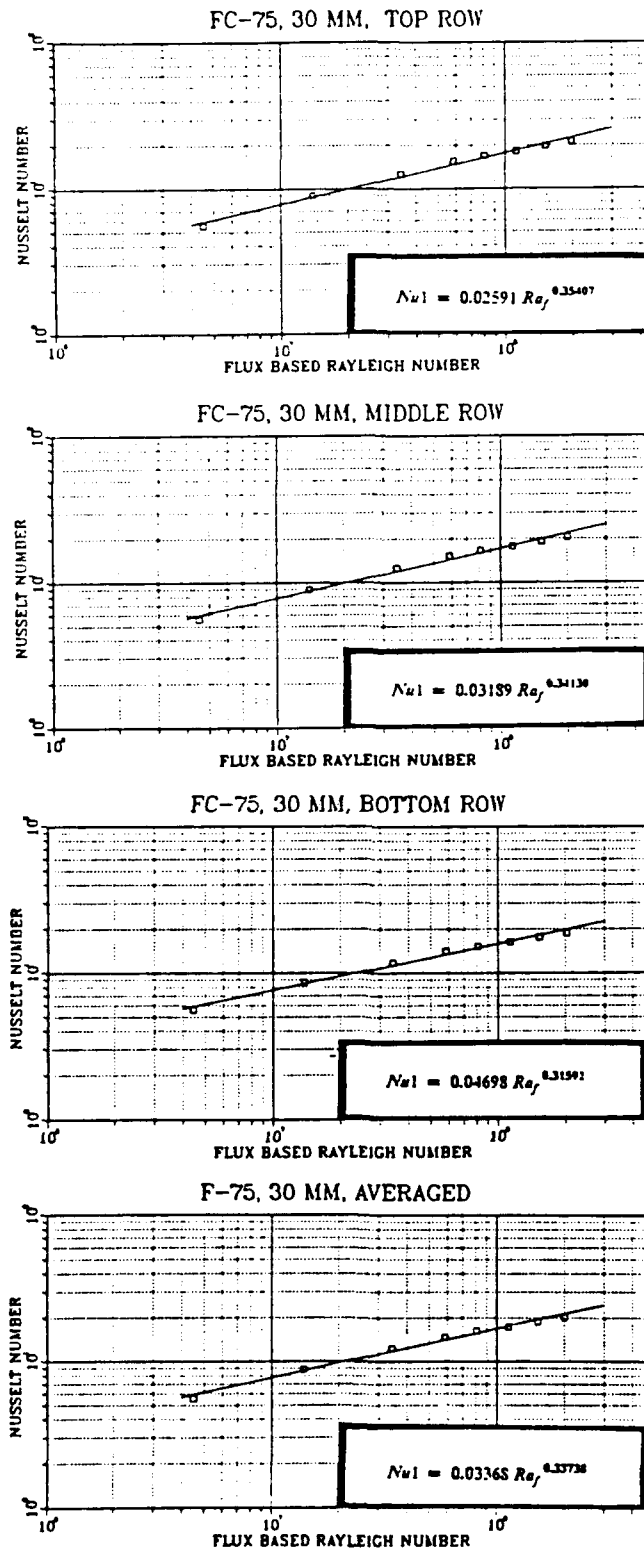


Figure 4.17. Plot of Row/Array-averaged Nu_1 vs. Ra_f and Curve Fit Equations for FC-75 and 30 mm Spacing

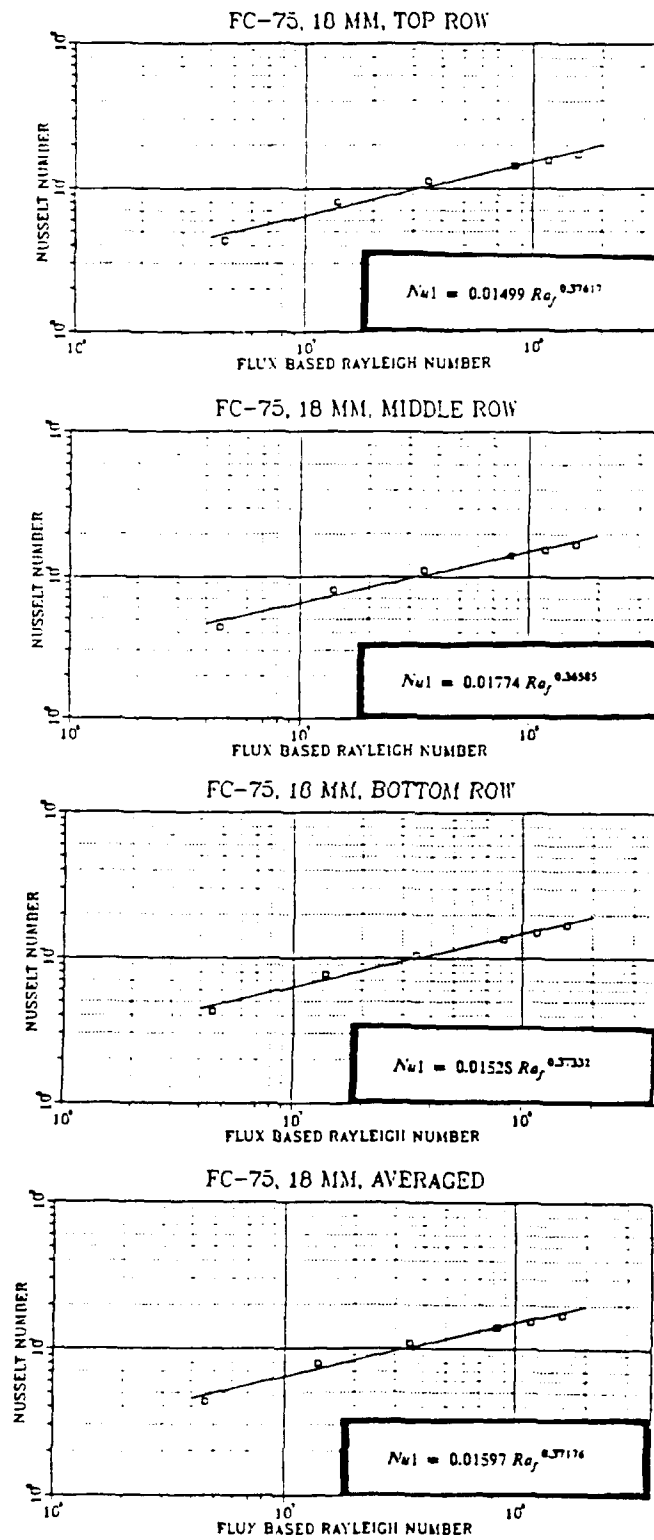


Figure 4.18. Plot of Row/Array-averaged Nu_1 vs. Ra_f and Curve Fit Equations for FC-75 and 18 mm Spacing

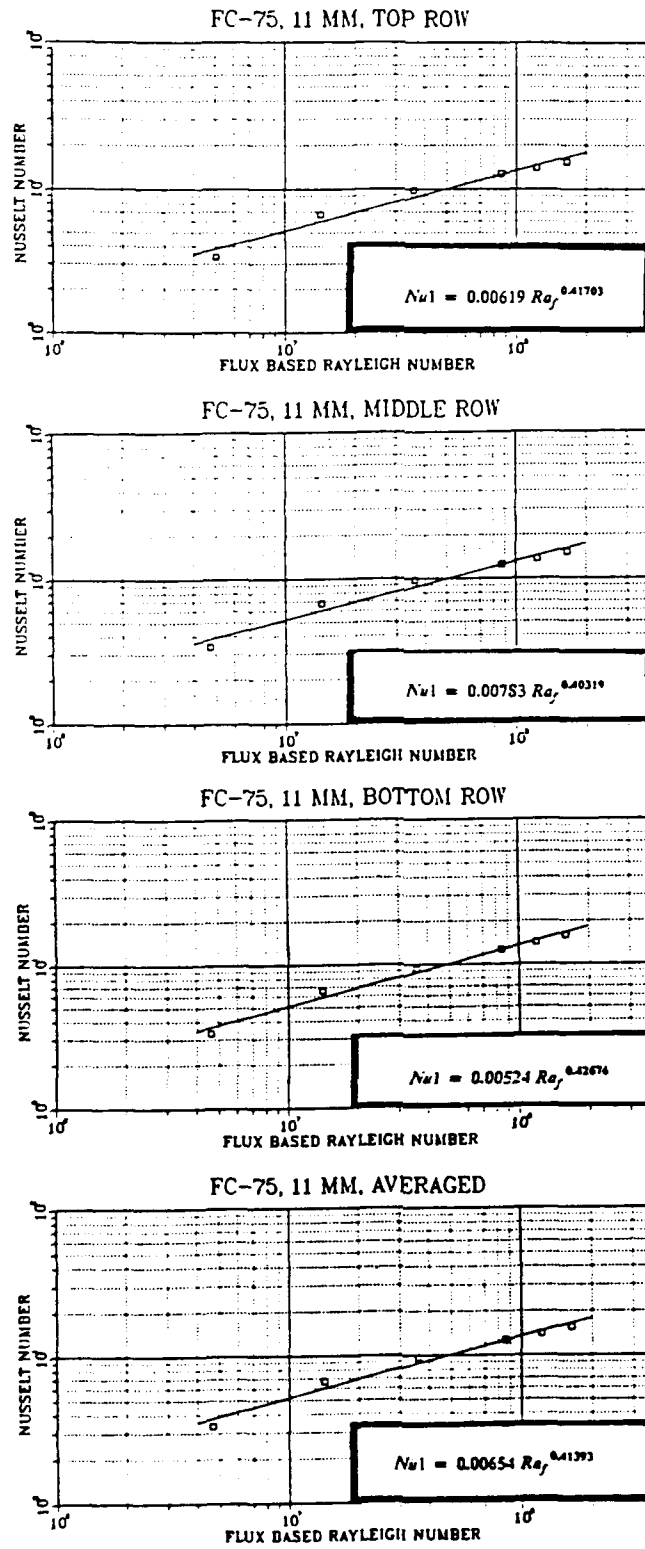


Figure 4.19. Plot of Row/Array-averaged $Nu1$ vs. Ra_f and Curve Fit Equations for FC-75 and 11 mm Spacing

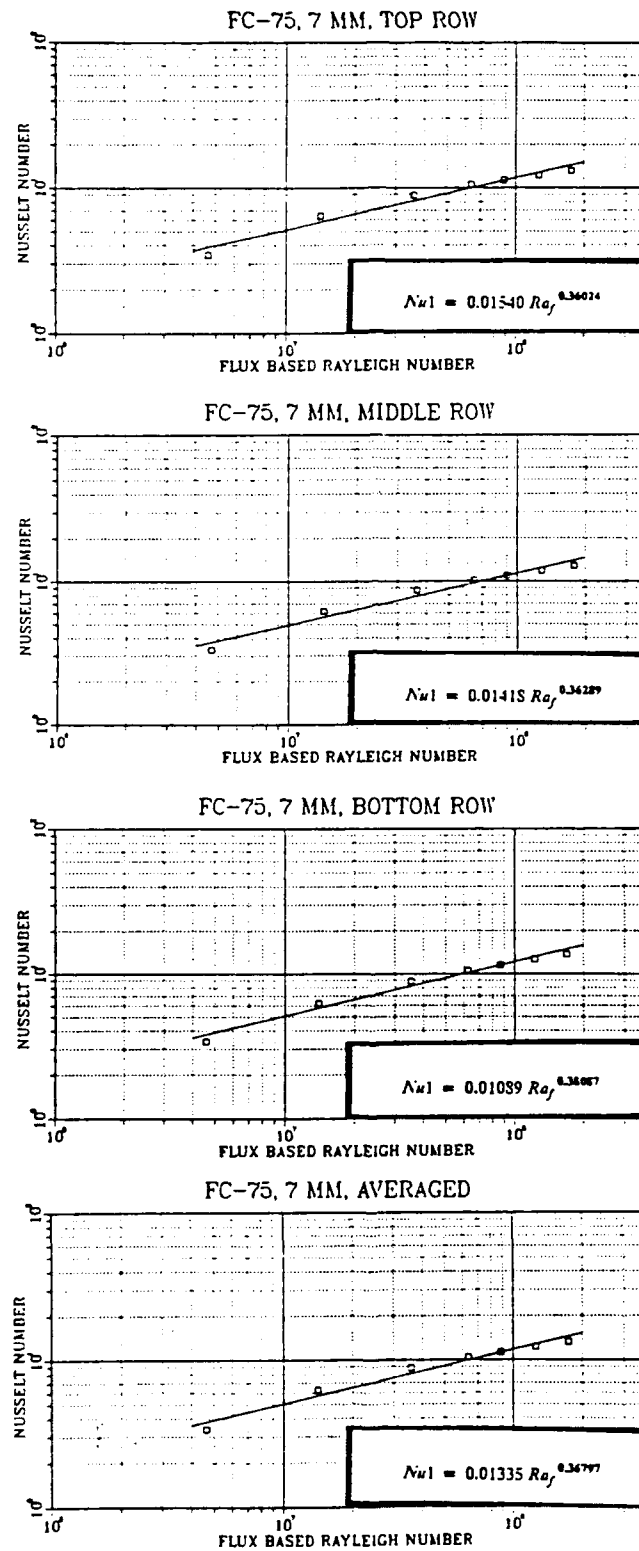


Figure 4.20. Plot of Row/Array-averaged $Nu1$ vs. Ra_f and Curve Fit Equations for FC-75 and 7 mm Spacing

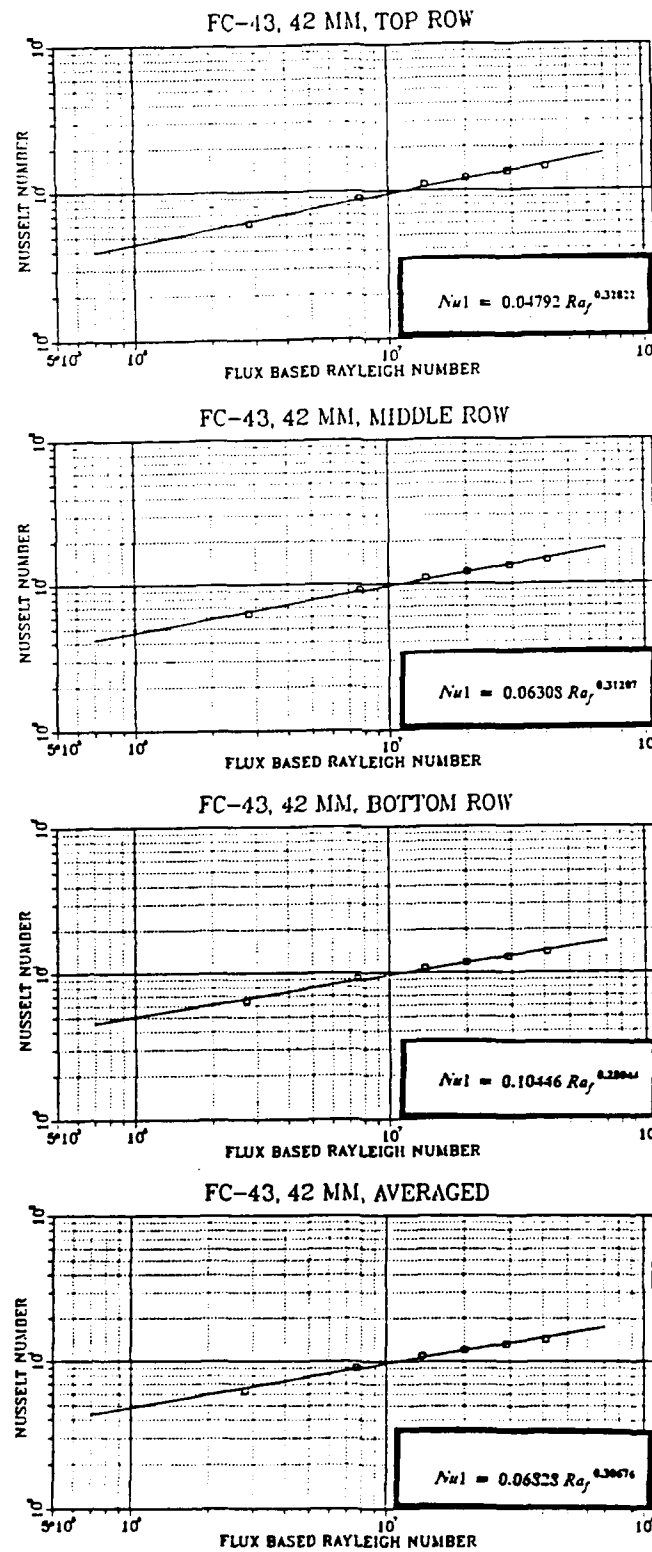


Figure 4.21. Plot of Row/Array-averaged $Nu1$ vs. Ra_f and Curve Fit Equations for FC-43 and 42 mm Spacing

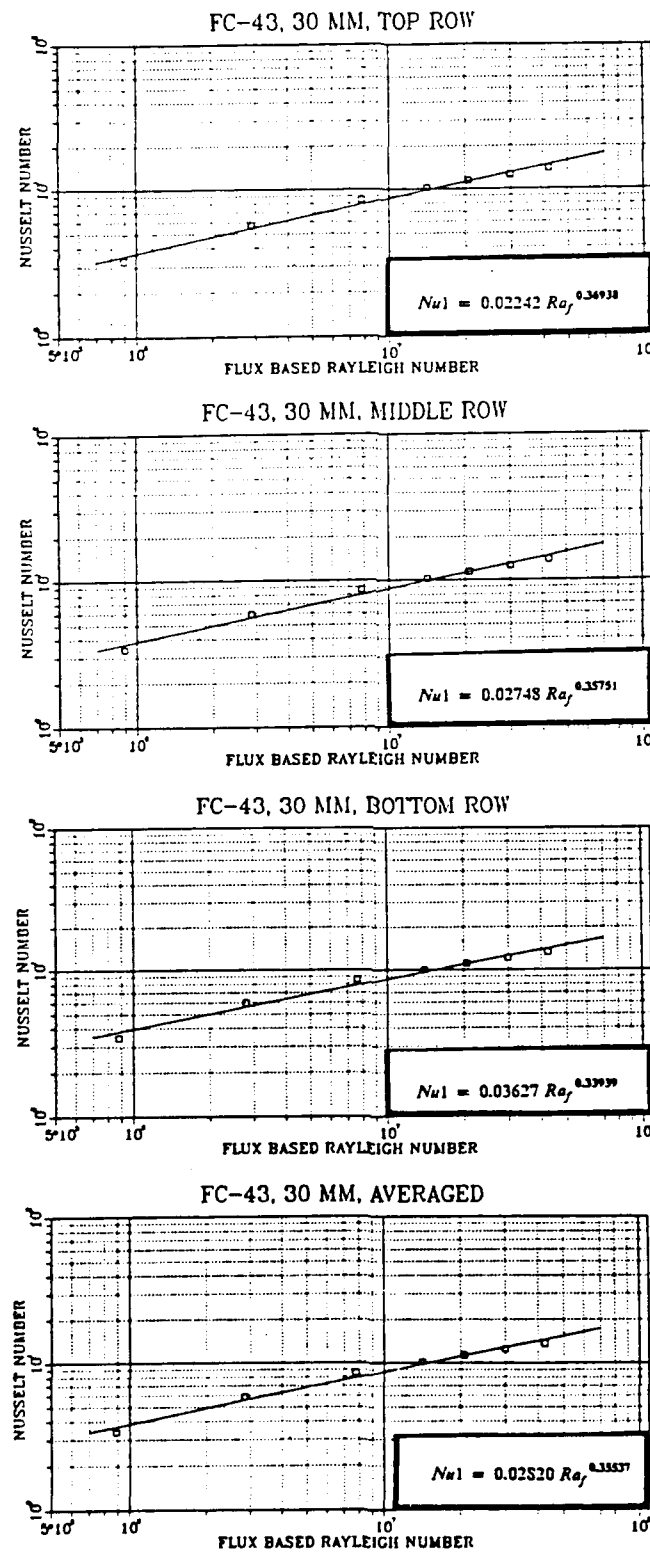


Figure 4.22. Plot of Row/Array-averaged $Nu1$ vs. Ra_f and Curve Fit Equations for FC-43 and 30 mm Spacing

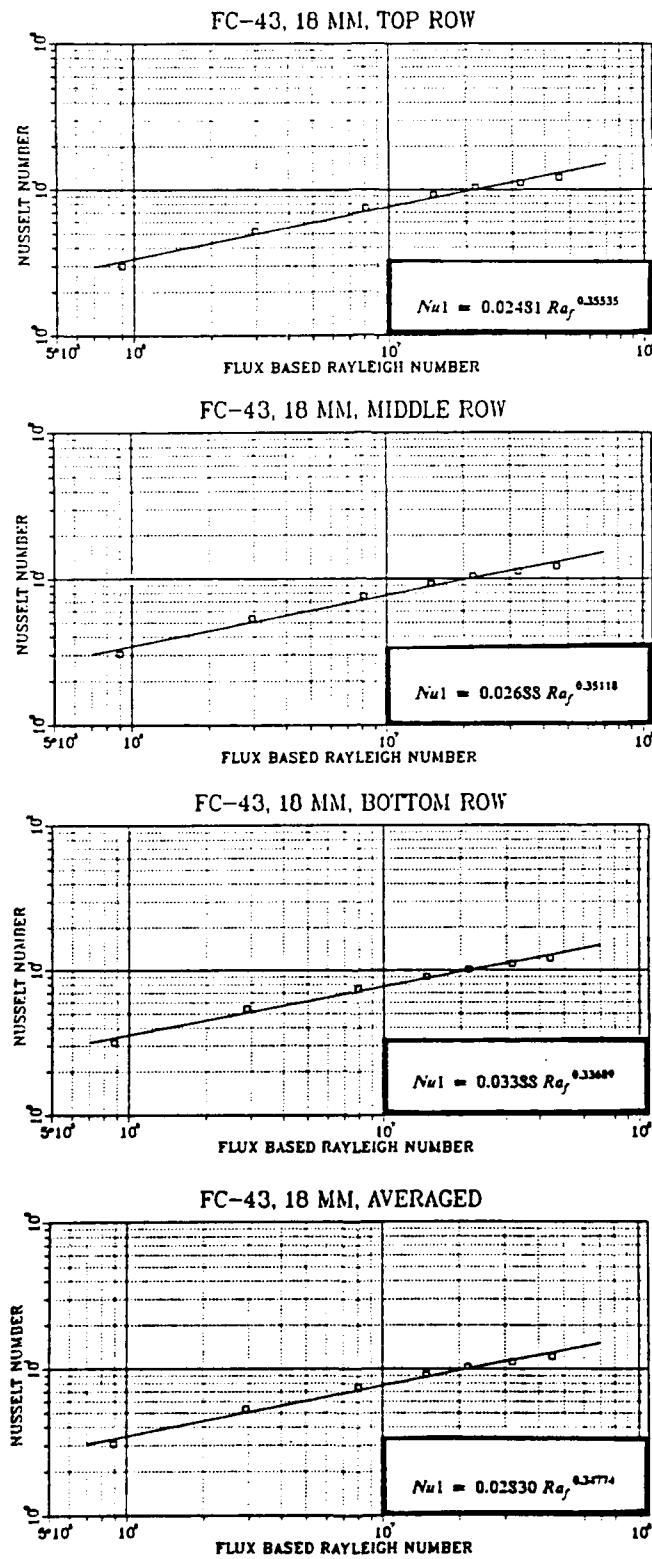


Figure 4.23. Plot of Row/Array-averaged $Nu1$ vs. Ra_f and Curve Fit Equations for FC-43 and 18 mm Spacing

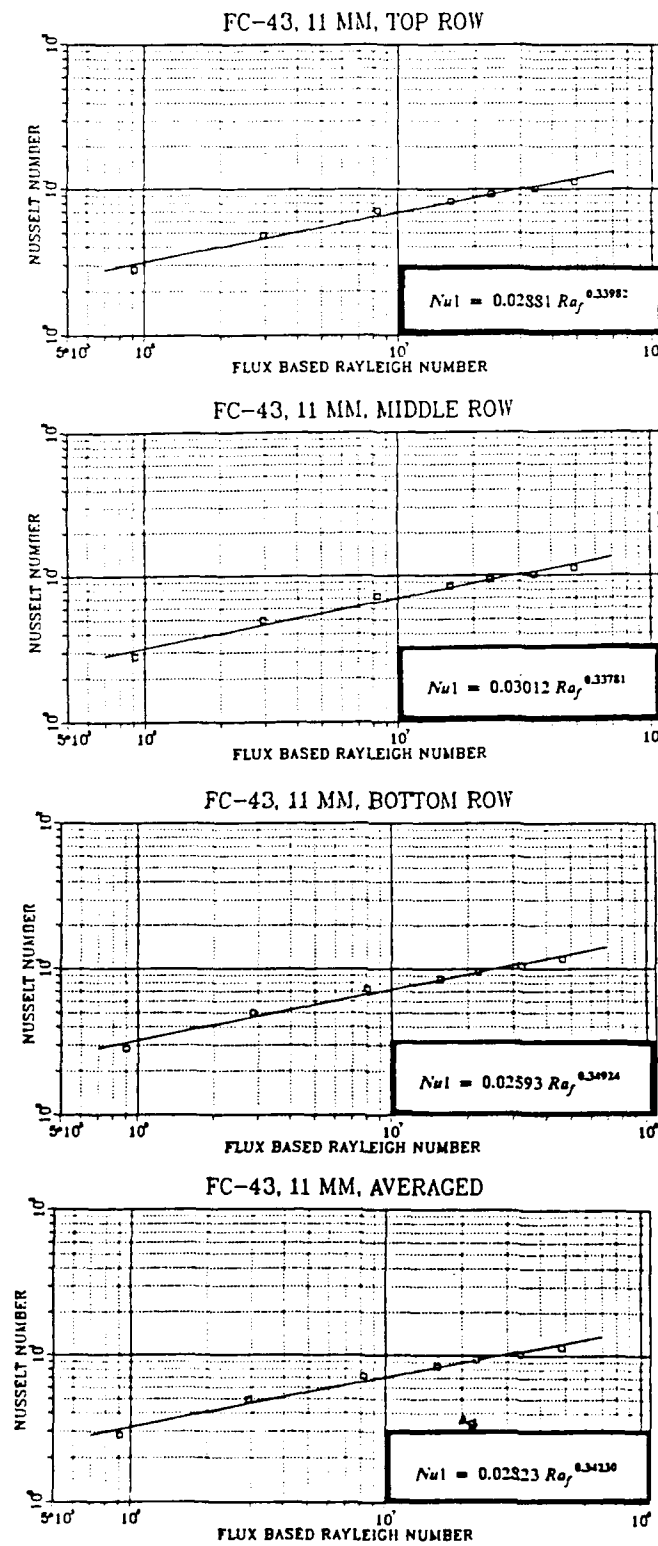


Figure 4.24. Plot of Row/Array-averaged Nu₁ vs. Ra_f and Curve Fit Equations for FC-43 and 11 mm Spacing

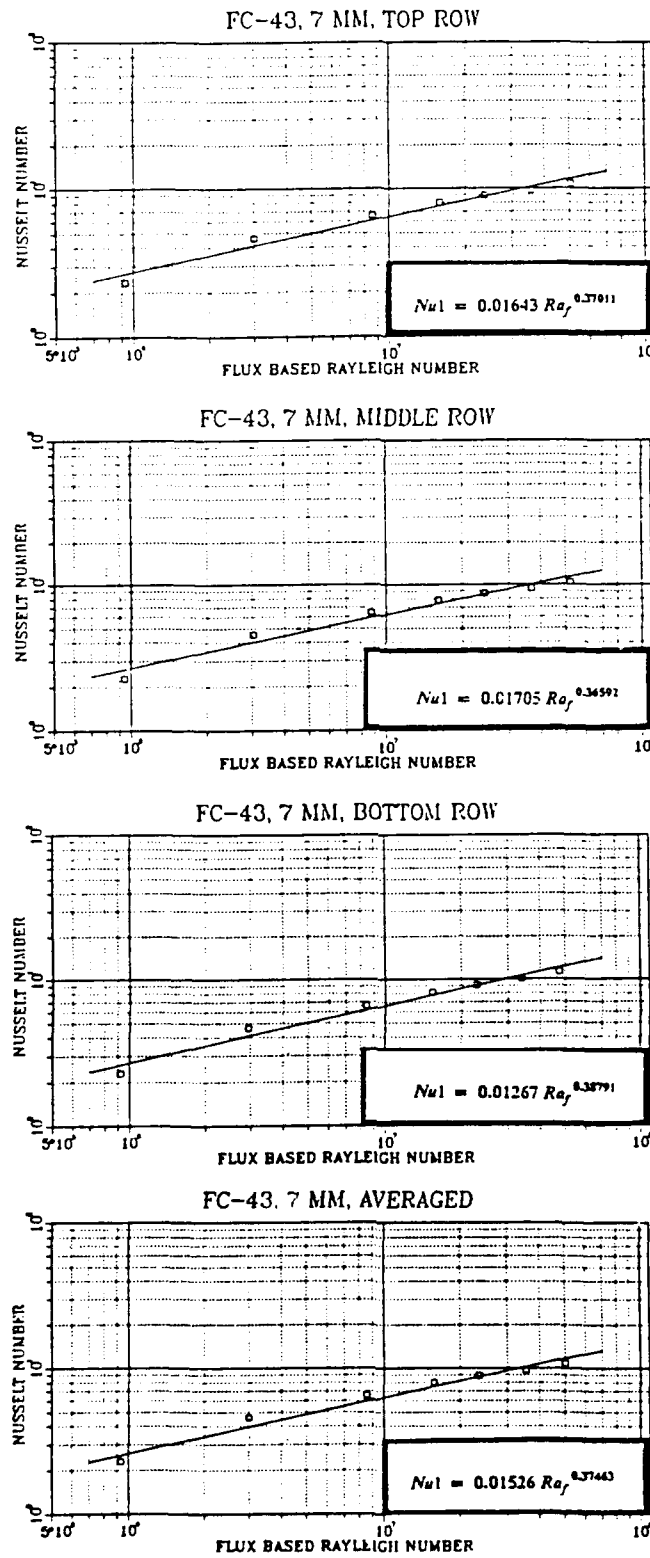


Figure 4.25. Plot of Row/Array-averaged Nu_1 vs. Ra_f and Curve Fit Equations for FC-43 and 7 mm Spacing

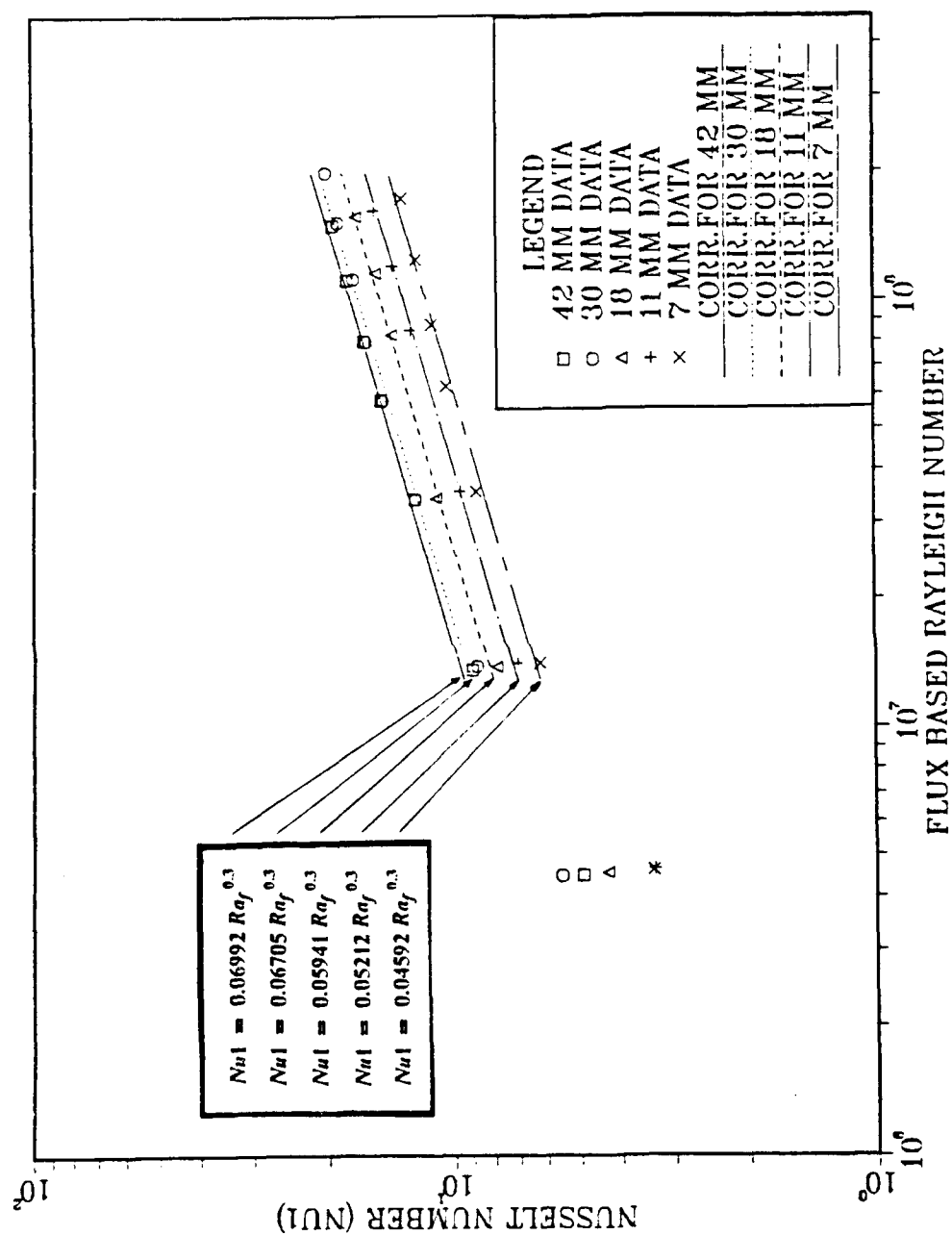


Figure 4.26. Plot of Array-averaged Nu_1 vs Ra , and the Curve Fit Equations for FC-75 and All Spacings

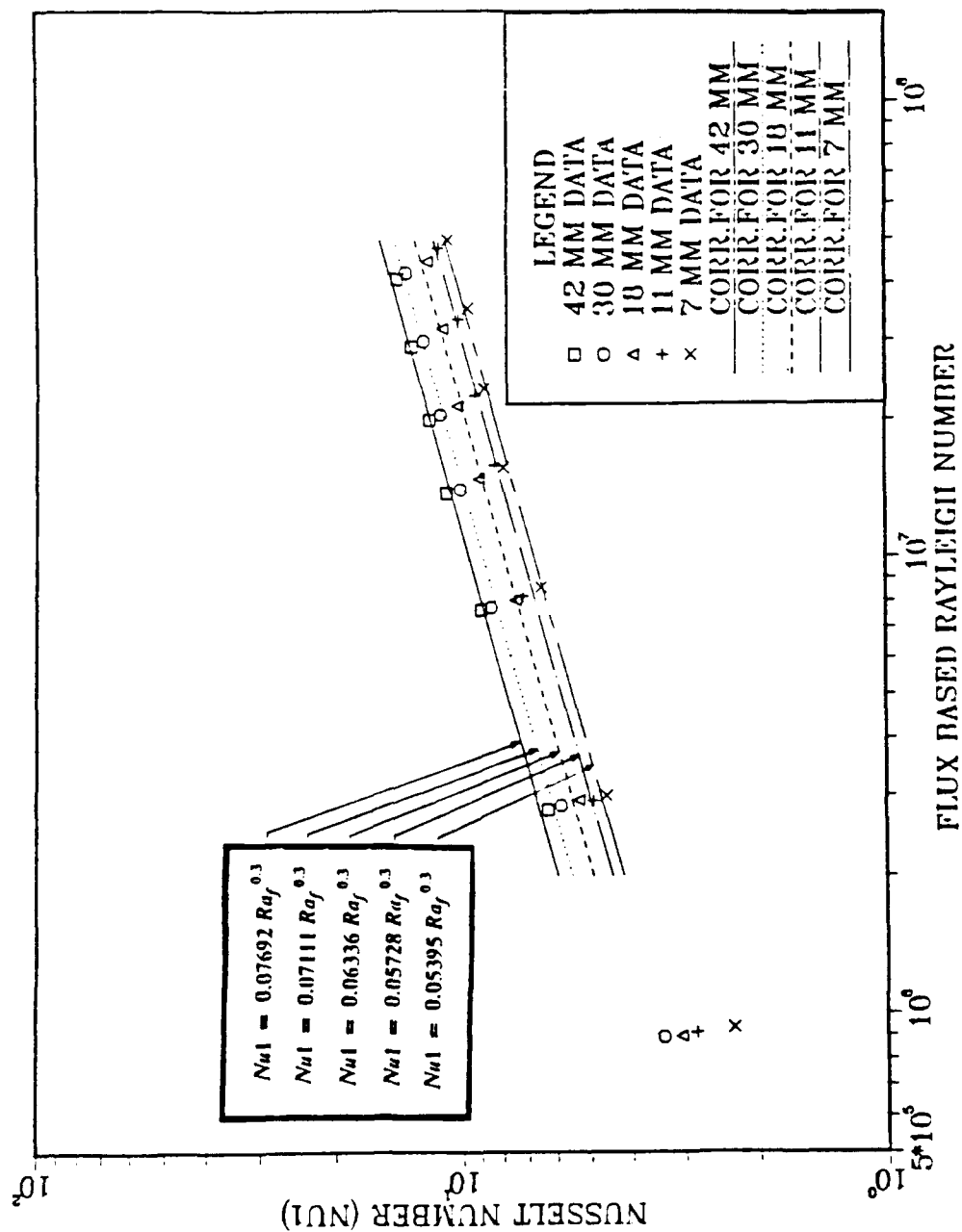


Figure 4.27. Plot of Array-averaged $Nu1$ vs. Ra , and the Curve Fit Equations for FC-43 and All Spacings

Introducing nondimensional spacing x^*

$$x^* = \frac{w}{H} \quad (28)$$

where,

w \equiv Chamber width
 H \equiv Height of the component

The functional relationship between the correlation constant (a) and nondimensional spacing (X^*) in the form of $a = c (X^*)^m$ where c and m are constant was determined for each fluid. These are presented in Figures 4.28 and 4.29.

a. Single Correlation for FC-75

A general form of correlation equation was obtained as

$$\begin{aligned} Nu_1 &= 0.04561 (x^*)^{0.23139} Ra_1^{0.3} \\ 1.3 * 10^7 &< Ra_1 < 2 * 10^8 \\ 21.8 &< Pr < 31.8 \end{aligned} \quad (29)$$

Using the above equation correlates the data with less than 8% (for 42 mm and 7 mm spacings) and less than 1.7% (for other spacings) deviation from the original best fit equations.

b. Single Correlation for FC-43

A general form of correlation equation was obtained as

$$\begin{aligned} Nu_1 &= 0.05142 (x^*)^{0.20191} Ra_1^{0.3} \\ 3 * 10^6 &< Ra_1 < 5 * 10^7 \\ 57.4 &< Pr < 131 \end{aligned} \quad (30)$$

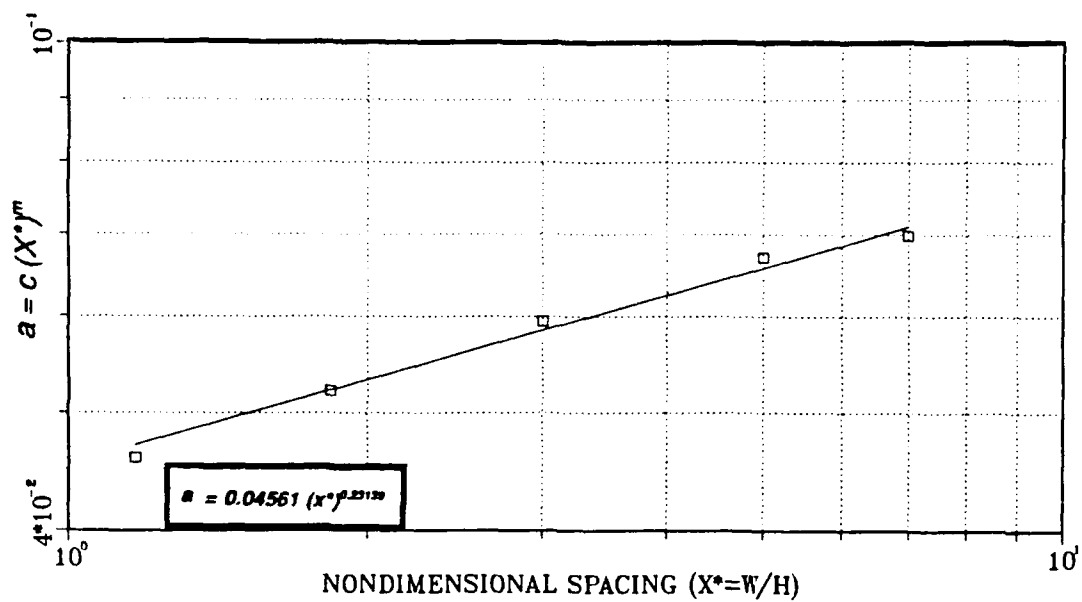


Figure 4.28. Plot of X^* vs. a for FC-75

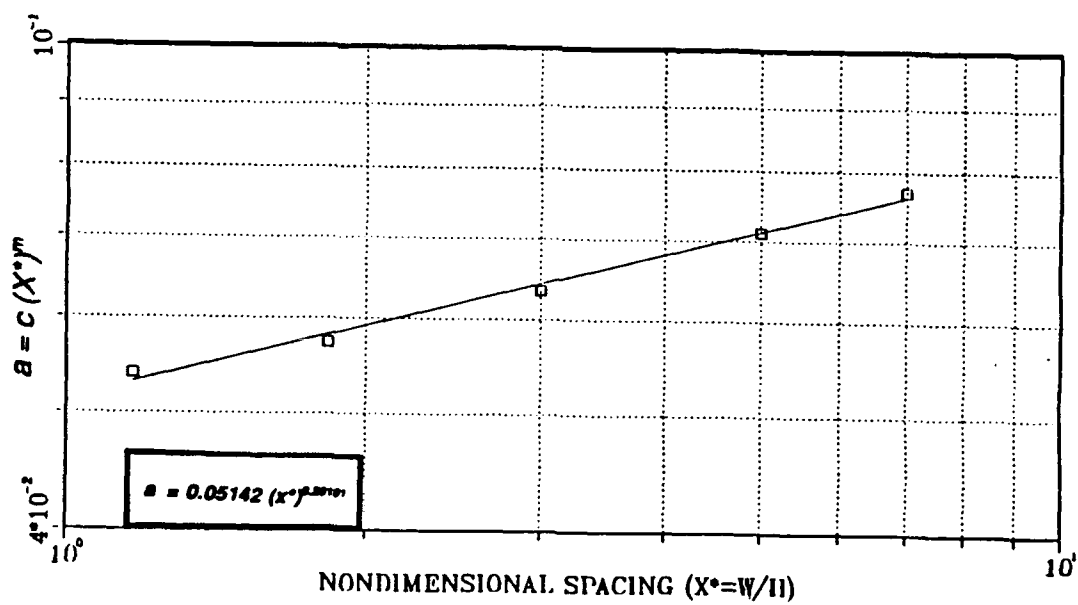


Figure 4.29. Plot of X^* vs. a for FC-43

Using the above equation, correlates the data with less than 2.5% (for 30 mm and 18 mm) and less than 1% (for other spacings) deviation from the original best fit equations.

B. TEMPERATURE FLUCTUATIONS IN STEADY STATE

Temperature fluctuations in steady state were measured and plotted for the spacings of 30 mm (for FC-75 only) and 7 mm in the power range of 0.115 W to 2.9 W per component. Three channels were scanned at a rate of approximately 3 times per second for a period of 200 seconds. The location of the thermocouples which are Chip #1 front surface (Channel 0), Chip #3 front surface (Channel 12) and Chip #6 top surface (Channel 31) were the same as previous experiments to compare the results. See Figure 4.39 for the location of the scanned thermocouples.

1. General Observations

Temperature fluctuations at low power levels were not significant regardless of dielectric liquid and spacing. Almost no fluctuation was observed at the bottom row at any power level and spacing. Increase in fluctuation magnitude was observed as the spacing decreases and location of the heater approaches to top heat exchanger. Dielectric fluid Prandtl number also effected the fluctuation magnitude. For 7 mm spacing in case of FC-75 maximum fluctuation magnitude was almost 1°C, in case of FC-43 it was less than 0.4°C.

2. Surface Temperature Fluctuations for FC-75

Plots of temperature fluctuations are presented in Figures 4.30 through 4.32 for 30 mm spacing and Figures 4.33 through 4.35 for 7 mm spacing. At low power levels (0.115 W and 0.34 W) almost no fluctuations were observed in any of the channels. Reducing chamber width from 30 mm to 7 mm didn't effect the temperature fluctuations significantly in the bottom row. The fluctuation amplitude was less than 0.2°C. Almost three order of magnitude increase was observed in the top row due to the effect of reducing spacing from 30 mm to 7 mm. It increased from 0.35°C to 1°C in both channels 12 and 31. Benedict (1988) reported the maximum fluctuation amplitude for the same arrangement and 30 mm spacing but with different boundary conditions (i.e., 10°C to 10°C) as 0.85°C. Torres (1988) reported it for vertical arrangement and 30 mm spacing as 1.7°C and for 9 mm spacing as 2°C. Reducing chamber width didn't cause significant effect on temperature fluctuations.

3. Surface Temperature Fluctuations for FC-43

Surface temperature fluctuations were measured for the chamber width of 7 mm and presented in Figures 4.36 through 4.38. Fluctuation magnitude in any of the channels was not significant. It was less than 0.2°C in channel 0 and less than 0.4°C in channel 12 and 31 at any power level.

Decrease in fluctuation magnitude from FC-75 to 43 may be due to the effect of fluid Prandtl number, since in the case of FC-75 and 7 mm spacing Rayleigh number was almost 1.8×10^8 , in the case of FC-43 it was 5×10^7 .

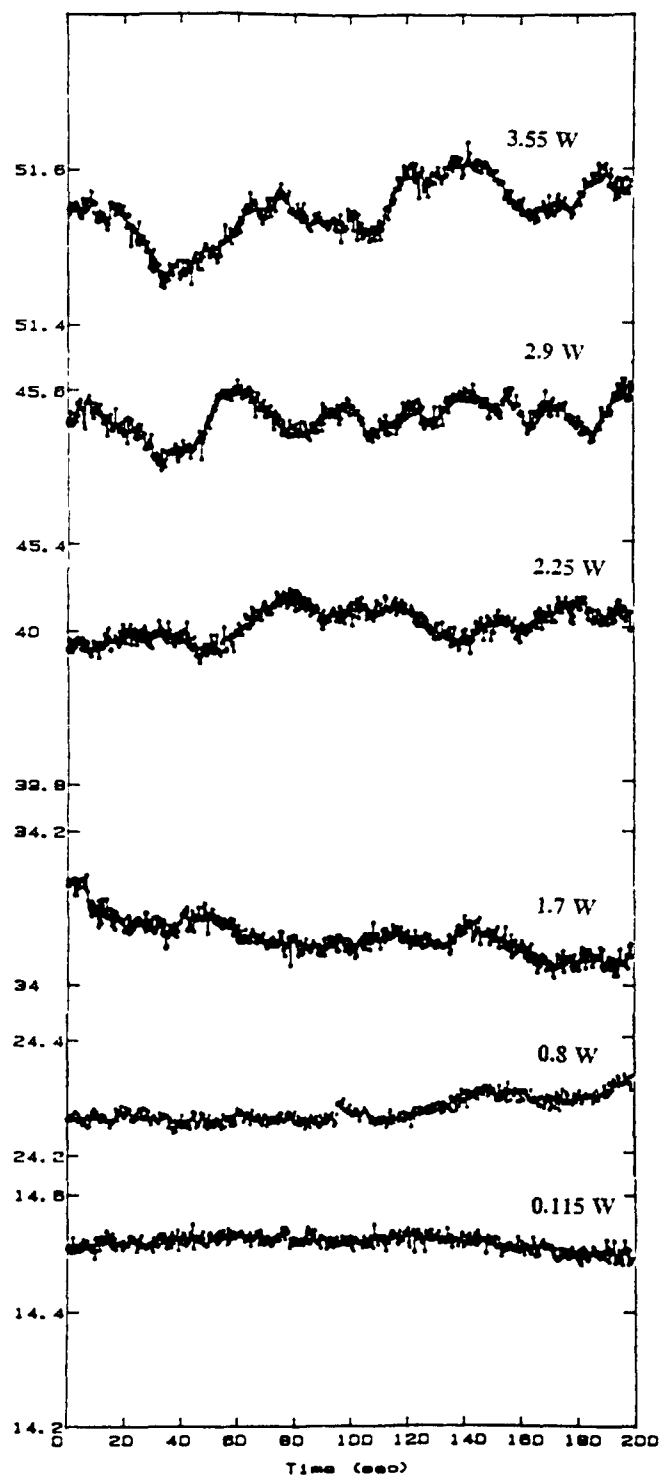


Figure 4.30. Temperature Fluctuations for Thermocouple No. 0 at Different Power Levels (FC-75 and 30 mm Spacing)

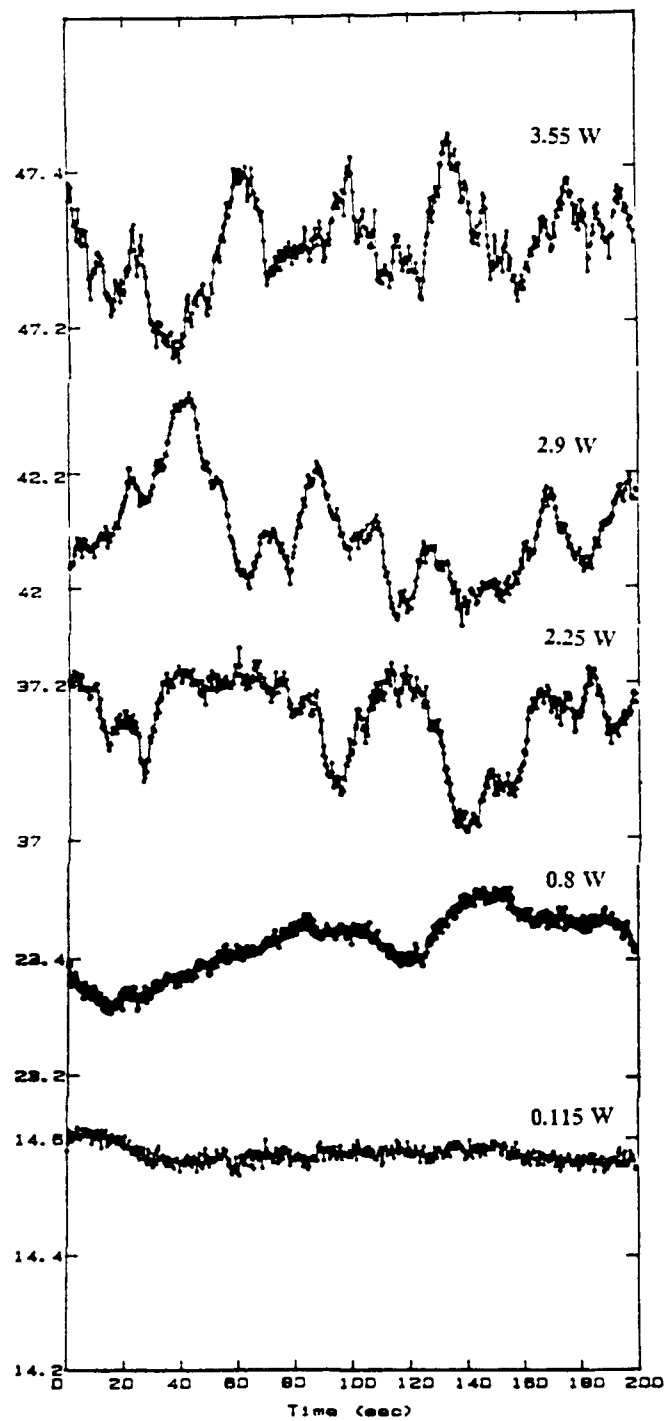


Figure 4.31. Temperature Fluctuations for Thermocouple No. 12 at Different Power Levels (FC-75 and 30 mm Spacing)

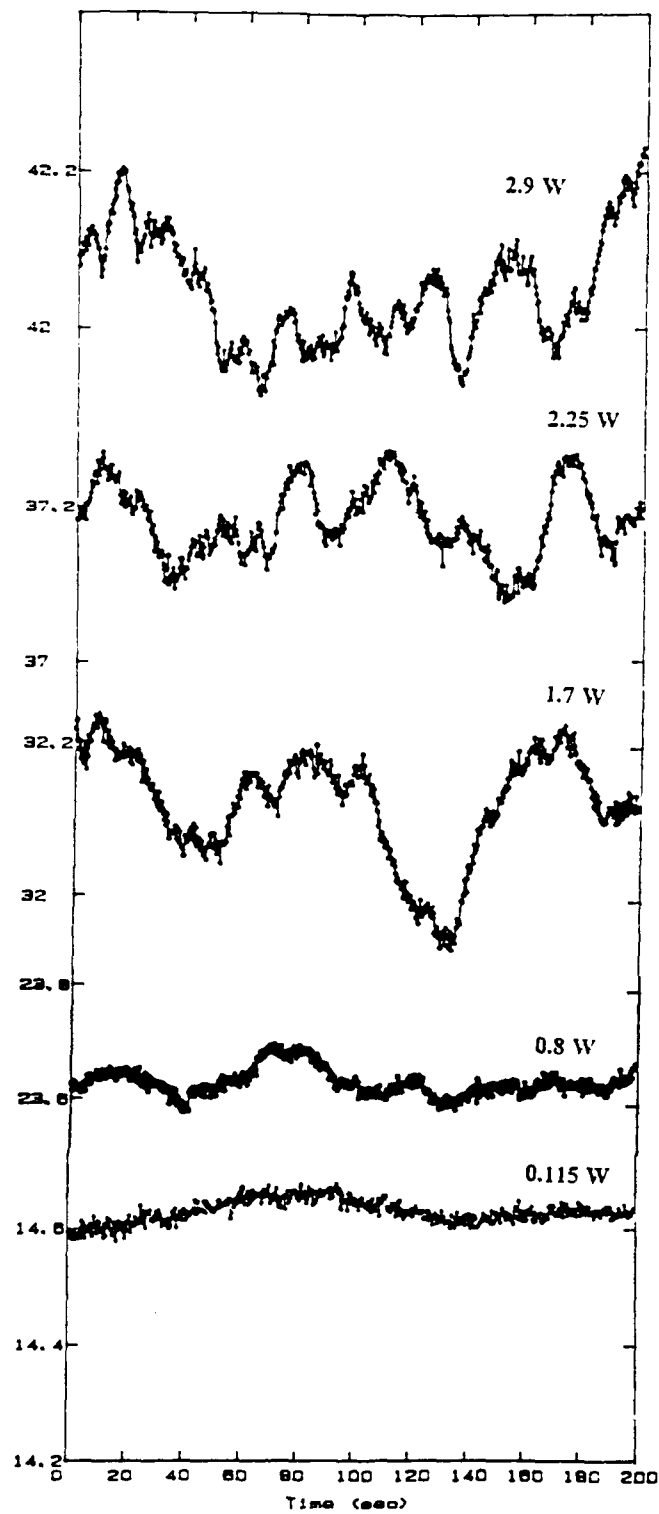


Figure 4.32. Temperature Fluctuations for Thermocouple No. 31 at Different Power Levels (FC-75 and 30 mm Spacing)

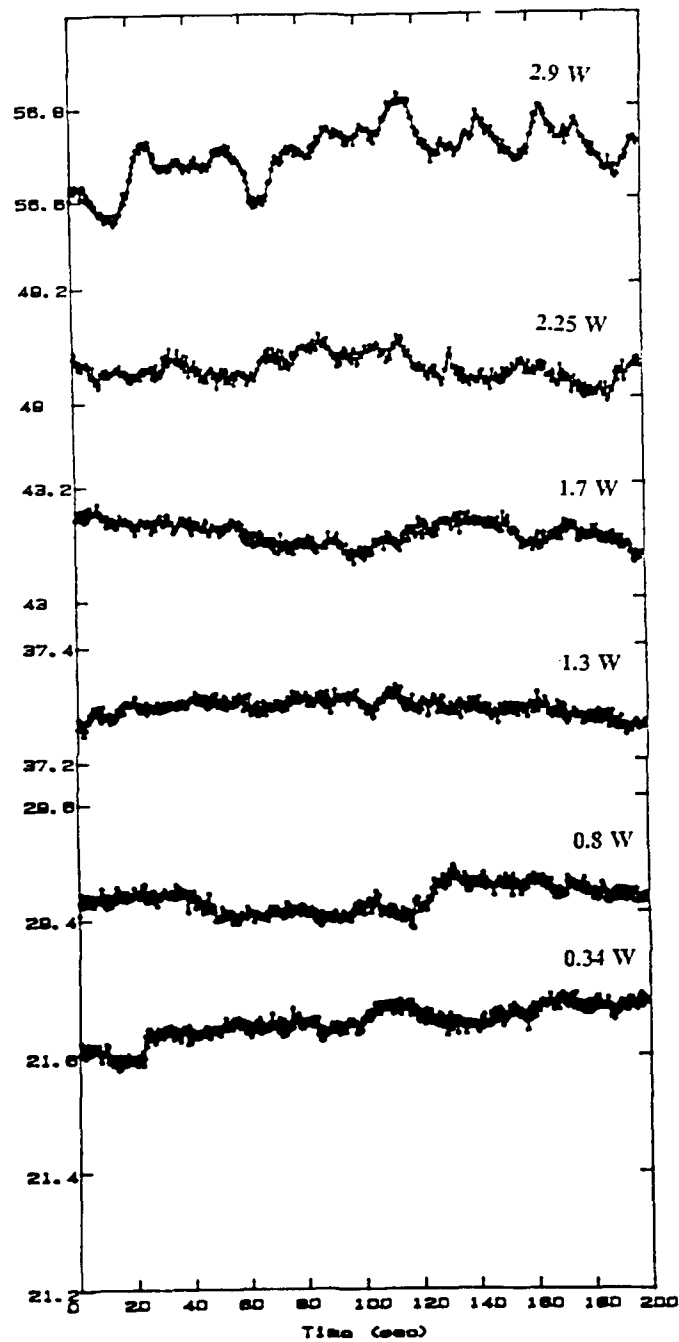


Figure 4.33. Temperature Fluctuations for Thermocouple No. 0 at Different Power Levels (FC-75 and 7 mm Spacing)

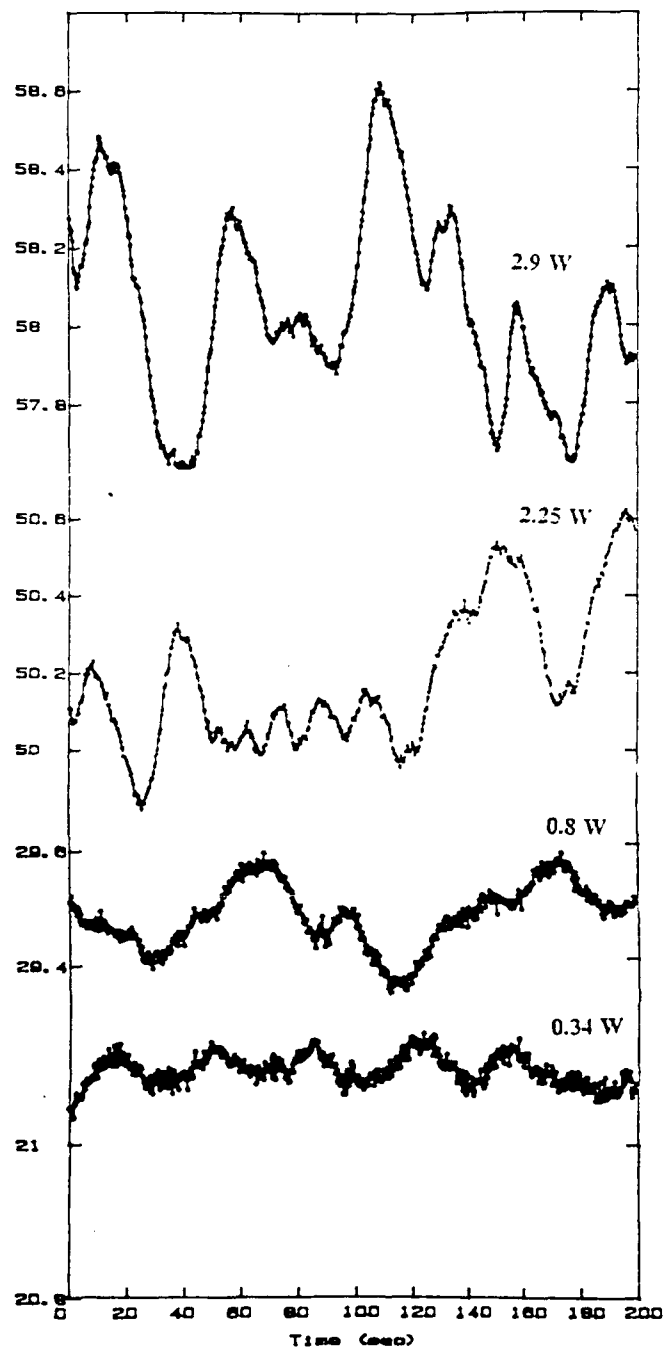


Figure 4.34. Temperature Fluctuations for Thermocouple No. 12 at Different Power Levels (FC-75 and 7 mm Spacing)

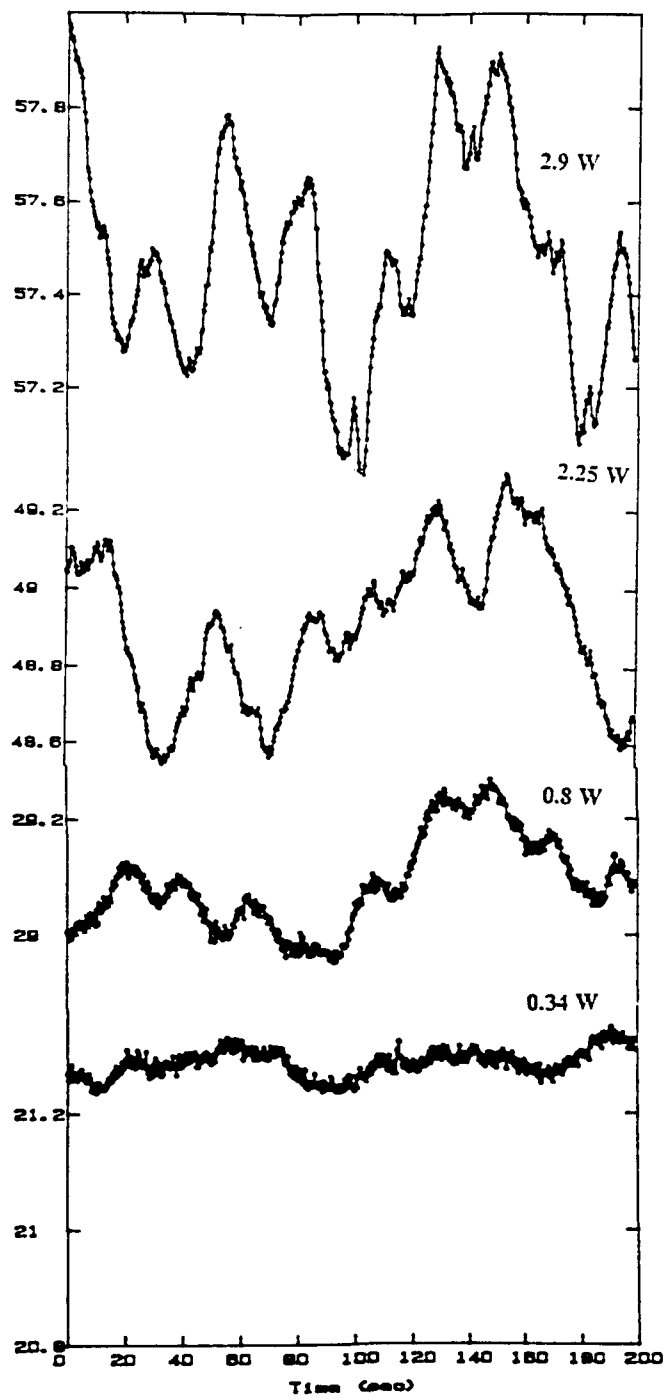


Figure 4.35. Temperature Fluctuations for Thermocouple No. 31 at Different Power Levels (FC-75 and 7 mm Spacing)

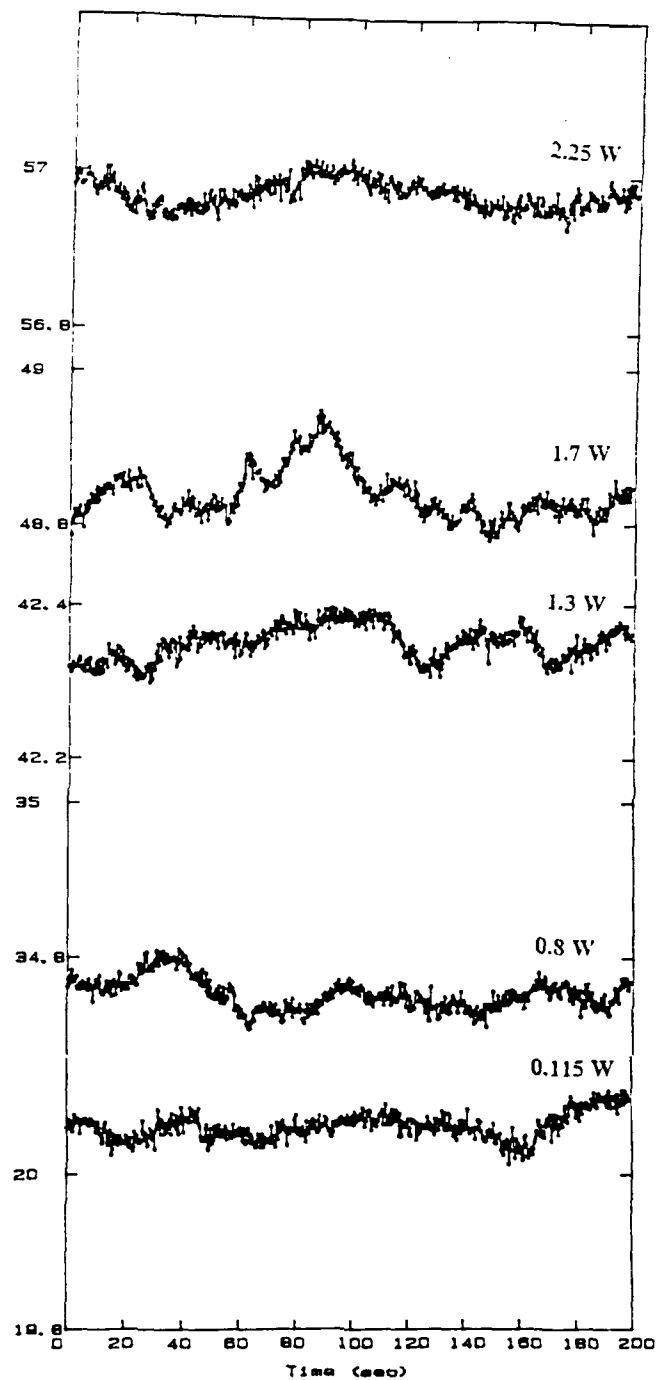


Figure 4.36. Temperature Fluctuations for Thermocouple No. 0 at Different Power Levels (FC-43 and 7 mm Spacing)

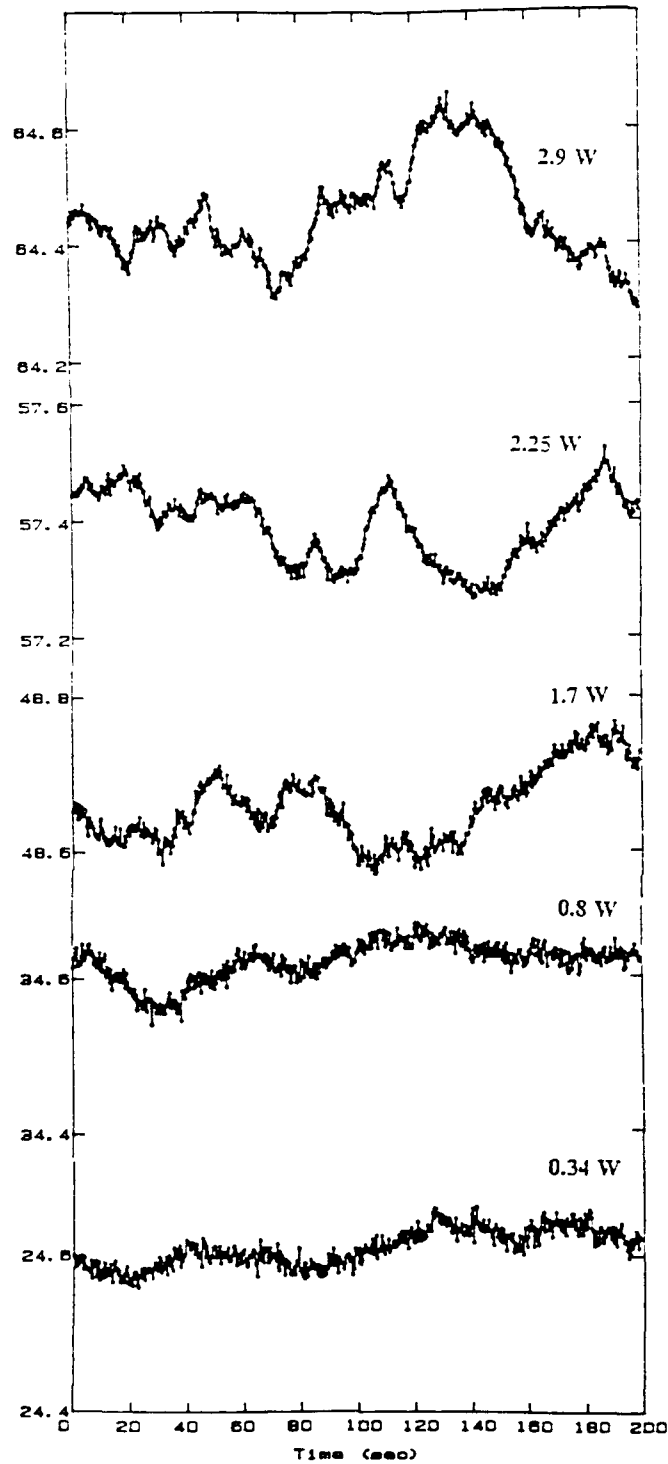


Figure 4.37. Temperature Fluctuations for Thermocouple No. 12 at Different Power Levels (FC-43 and 7 mm Spacing)

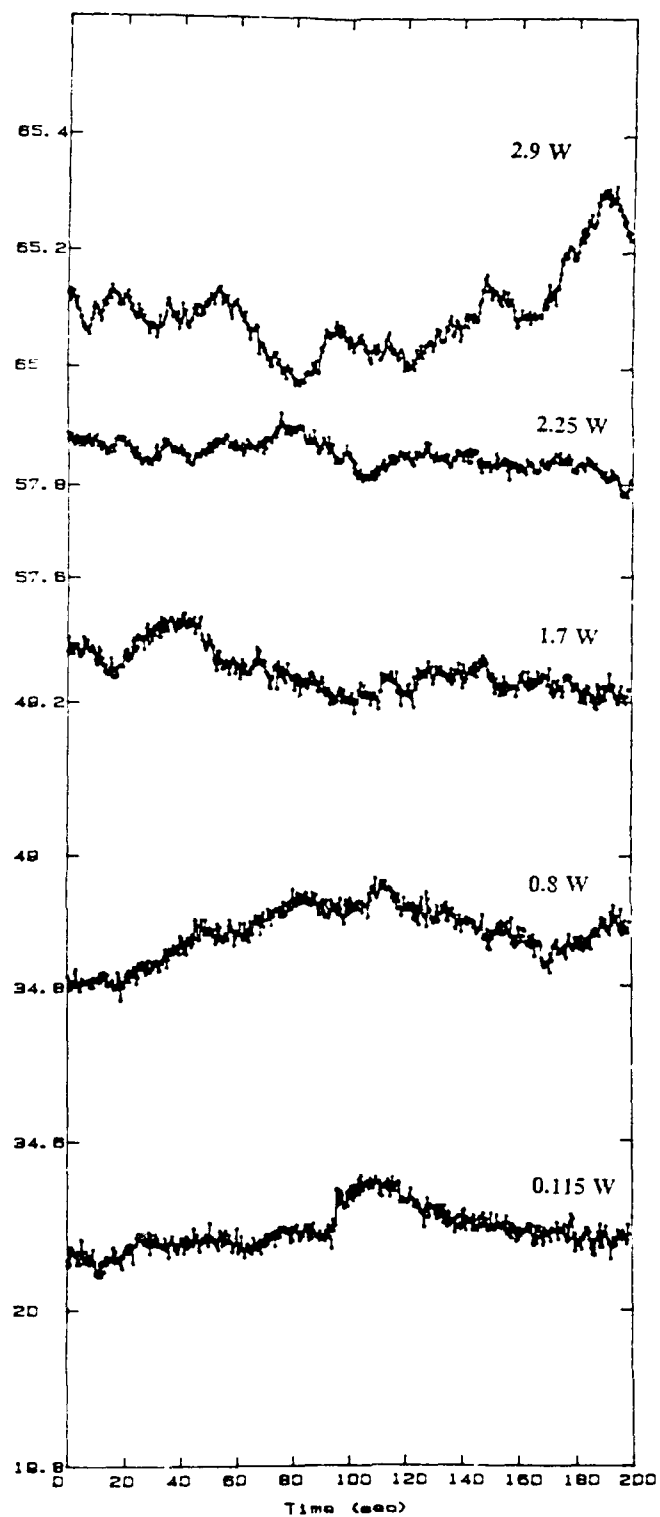


Figure 4.38. Temperature Fluctuations for Thermocouple No. 31 at Different Power Levels (FC-43 and 7 mm Spacing)

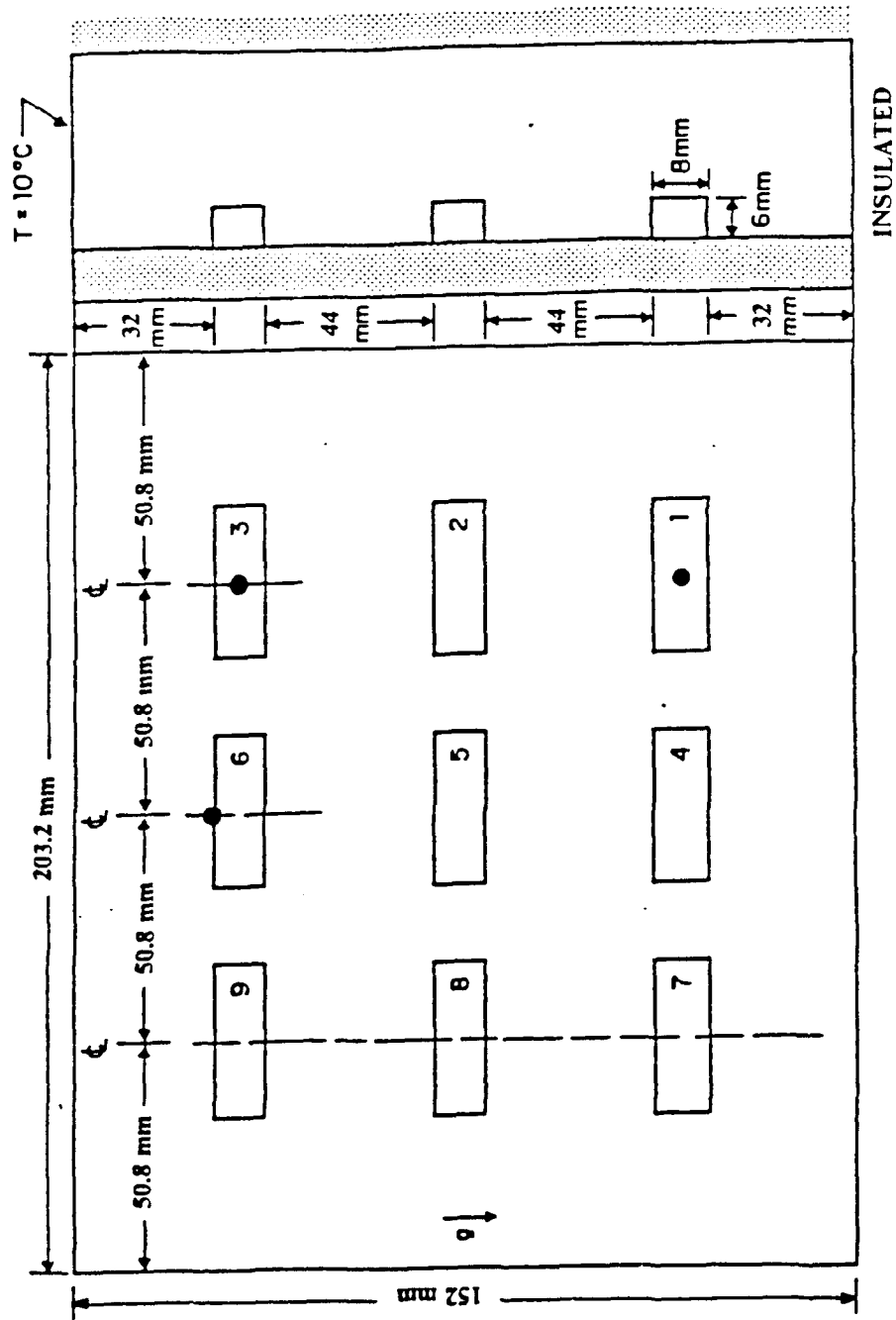


Figure 4.39. Location of Thermocouples Scanned for Measurements of Fluctuations

V. RECOMMENDATIONS

1. Continuation of this experiment using dielectric liquids other than used in this study to investigate the effects of fluid Prandtl number.
2. Investigate the variation in heat transfer characteristics of the components in the array at specific spacing and power level by conducting detailed flow visualization experiments for each fluid at selective spacings.
3. Change the design of the heat exchanger to allow an increase in the mass flow rate of coolant through the effective area of the heat exchanger to obtain better data, especially at 7 mm spacing.
4. Investigate the effect of vertical orientation of the chips.
5. Four unused channels of the data acquisition system out of 80 can be used to measure the temperatures within the dielectric fluid or on circuit board.

APPENDIX A. SAMPLE CALCULATIONS

Sample calculations were carried out for component #4 at 0.8 W power level. Spacing was 7 mm and dielectric liquid was FC-75.

A. CALCULATION OF THE AVERAGE COMPONENT WETTED SURFACE TEMPERATURE

1. Conversion of Thermocouple Voltages to Temperatures

Using conversion formula and the constants for copper constantan thermocouples.

$$T = D1 + D2 * emf + D3 * emf^2 + D4 * emf^3 + D5 * emf^4 + D6 * emf^5 + D7 * emf^6 + D8 * emf^7 \quad (31)$$

where,

D1 =	0.10086091	D5 =	-9247486589.6
D2 =	25727.9	D6 =	6.98E11
D3 =	-767345.8	D7 =	-2.66E13
D4 =	7802.5596	D8 =	=3.94E14

Using thermocouple #18, from Equation (31)

$$emf(18) = 1.151E-3 \text{ V}$$

$$T(18) = 28.84^{\circ}\text{C}$$

2. Average Component Surface Temperature

Wetted surface areas of component,

$$A_{cen} = 1.92\text{E-}4 \text{ m}^2$$

$$A_{top} = A_{bot} = 4.85\text{E-}5 \text{ m}^2$$

$$A_{right} = A_{left} = 1.44\text{E-}4 \text{ m}^2$$

$$A_{total} = 5.76\text{E-}4 \text{ m}^2$$

Surface temperatures of component

$$T(18) = 28.84^\circ\text{C}$$

$$T(19) = 28.87^\circ\text{C}$$

$$T(20) = 28.7^\circ\text{C}$$

$$T(21) = 28.6^\circ\text{C}$$

$$T(22) = 28.6^\circ\text{C}$$

From Equation (1)

$$T_{avg} = 28.73^\circ\text{C}$$

B. CALCULATION OF THE HEATER POWER

$$\text{Volt} = emf(61) = 3.453 \text{ V}$$

$$emf(65) = 2.899 \text{ V}$$

$$R_p = 2 \text{ Ohm}$$

From Equation (2)

$$\text{Power}(4) = 2.899 (3.453 - 2.899) / 2$$

$$\text{Power}(4) = 0.8030 \text{ W}$$

C. CALCULATION OF CONDUCTION LOSS

$$T_{cb} = T(23) = 31.01^{\circ}\text{C}$$

$$T_{bp} = T(60) = 20.79^{\circ}\text{C}$$

$$t = 00.012 \text{ m}$$

$$k = 0.195 \text{ W/mk}$$

$$A = 1.92\text{E-}4 \text{ m}^2$$

From Equation (4)

$$R_c = 0.012 / (0.195 * 1.92\text{E-}4) = 320.51 \text{ K/W}$$

From Equation (5)

$$\Delta T_4 = 31.01 - 20.79 = 10.22^{\circ}\text{C}$$

Then from Equation (3)

$$Q_{loss} = 0.035 \text{ W}$$

D. HEAT TRANSFER COEFFICIENT

$$T(54) = 9.048^{\circ}\text{C}$$

$$T(55) = 10.55^{\circ}\text{C}$$

$$T(56) = 10.35^{\circ}\text{C}$$

From Equation (8)

$$T_{sink} = (9.048 + 10.55 + 10.35) / 3 = 9.98^{\circ}\text{C}$$

From Equation (7)

$$Q_{net} = 0.8030 - 0.035 = 0.768 \text{ W}$$

Then from Equation 6

$$h = 0.768 / [5.76\text{E-}4 (28.73 - 9.98)]$$

$$h = 71.11 \text{ W/m}^2\text{K}$$

E. THERMOPHYSICAL PROPERTIES OF FC-75 AT FILM TEMPERATURE

From Equation (9)

$$T_{film} = (28.73 + 9.98) / 2 = 19.36^\circ\text{C}$$

1. Thermal Conductivity

From Equation (10),

$$k = (0.65 - 7.8947\text{E-}4 * 19.36) / 10$$

$$k = 0.06347 \text{ W/mK}$$

2. Density

From Equation (12)

$$\rho = (1.825 - 0.00246 * 19.36) * 1000$$

$$\rho = 1777.37 \text{ kg/m}^3$$

3. Specific Heat

From Equation (14),

$$C_p = (0.24111 + 3.7037\text{E-}4 * 19.36) 4180$$

$$C_p = 1037.82 \text{ J/kg K}$$

4. Kinematic Viscosity

From Equation (15)

$$\begin{aligned} \nu = & [1.4074 - 2.964\text{E-}2 * 19.36 + 3.8018\text{E-}4 * (19.36)^2 \\ & - 2.7308\text{E-}6 * (19.36)^3 + 8.1679\text{E-}9 * (19.36)^4] \text{E-}6 \end{aligned}$$

$$v = 9.574\text{E-}7 \text{ m}^2/\text{s}$$

5. Thermal Expansion Coefficient

From Equation (17)

$$\beta = 0.00246 / (1.825 - 0.00246 * 19.36)$$

$$\beta = 0.001384 \text{ K}^{-1}$$

6. Thermal Diffusivity

From Equation 19,

$$\alpha = 0.06347 / (1777.37 * 1037.82)$$

$$\alpha = 3.4409\text{E-}8 \text{ m}^2/\text{s}$$

F. CALCULATION OF THE NUSSELT NUMBERS

1. Nusselt Number Based on the Height of the Component

$$L1 = 0.008 \text{ m}$$

From Equation (20)

$$Nu1 = 71.11 * 0.008 / 0.06347$$

$$Nu1 = 8.966$$

2. Nusselt Number Based on the Ratio (Area/Perimeter) of the Component

From Equation (22)

$$L2 = [(24 * 8/64) + 2 (8 * 6/28) + 2 (24 * 6/60)]\text{E-}3$$

$$L2 = 11.229\text{E-}3 \text{ m}$$

Then from Equation 21

$$Nu_2 = 71.11 * 11.229E-3 / 0.06347$$

$$Nu_2 = 12.584$$

G. CALCULATION OF THE GRASHOF NUMBER

From Equation (24)

$$\Delta T = 28.73 - 9.98 = 18.75^\circ\text{C}$$

Then from Equation (23),

$$Gr = 9.81 * 0.001384 (0.008)^3 * 18.75 / (9.574E-7)^2$$

$$Gr = 142196.69$$

H. CALCULATION OF THE PRANDTL NUMBER

From Equation (25)

$$Pr = 9.574E-7 / 3.4409E-8$$

$$Pr = 27.82$$

I. CALCULATION OF THE RAYLEIGH NUMBERS

1. Temperature Based Rayleigh Number

From Equation (26),

$$Ra_t = 142196.69 * 27.82 = 3.96E6$$

2. Flux Based Rayleigh Number

From Equation (27)

$$Ra_f = 9.81 * 0.001384 (0.008)^4 * 0.786 / [0.06347 \\ * 9.574E-7 * 3.4409E-8 * 5.76E-4]$$

$$Ra_f = 3.547E7$$

APPENDIX B. UNCERTAINTY ANALYSIS

Sample calculations of the uncertainty analysis are carried out for component #4 at 0.8 W power level. Spacing was 7 mm and dielectric liquid was FC-75.

A. UNCERTAINTIES IN THE NET HEAT CONVECTED INTO THE FLUID

Starting with the power dissipated by the heater

$$Power = emf(I) * (Volt - emf(I)) / R_p$$

$$Power = function (emf(I), Volt, R_p)$$

$$P1 = \frac{\partial Power}{\partial emf(I)} = \frac{Volt - 2 emf(I)}{R_p}$$

$$P2 = \frac{\partial Power}{\partial Volt} = \frac{emf(I)}{R_p}$$

$$P3 = \frac{\partial Power}{\partial R_p} = \frac{- emf(I) (Volt - emf(I))}{R_p^2}$$

$$UPower = [(P1 * Uemf(I))^2 + (P2 * UVolt)^2 + (P3 * UR_p)^2]^{1/2}$$

where,

$$Uemf(I) = UVolt = \pm 0.001 \text{ V Resolution/Precision of Measuring Device}$$

$$UR_p = \pm 0.05 \Omega$$

Substituting numerical values,

$$emf(61) = Volt = 3.453 \text{ V}$$

$$emf(65) = 2.899 \text{ V}$$

$$R_p = 2 \Omega$$

$$Power = 0.803 \text{ W}$$

$$P1 = (3.453 - 2 * 2.899) / 2 = -1.1725$$

$$P2 = 2.899/2 = 1.2604$$

$$P3 = - [2.899 (3.453 - 2.899)] / 2^2 = -0.4015$$

$$UPower = [(1.1725 * 0.001)^2 + (1.2604 * 0.001)^2 + (0.4015 * 0.05)^2]^{1/2}$$

$$UPower = 0.02015 \text{ W}$$

$$\frac{UPower}{Power} * 100\% = \frac{0.02015}{0.8030} * 100\% = 2.51\%$$

$$\underline{Power = 0.803 \pm 2.51 \text{ W}}$$

Conduction loss through the back of the circuit board

$$Q_{loss} = \Delta T / R_c$$

$$Q_{loss} = \text{function} (\Delta T, R_c)$$

$$Q1 = \frac{\partial Q_{loss}}{\partial \Delta T} = 1 / R_c$$

$$Q2 = \frac{\partial Q_{loss}}{\partial R_c} = -\Delta T / R_c^2$$

$$UQ_{loss} = [(Q1 * U\Delta T)^2 + (Q2 * UR_c)^2]^{1/2}$$

where,

$$U\Delta T = 10\%$$

$$UR_c = 10\%$$

Substituting numerical values,

$$\Delta T = 10.22^\circ C$$

$$R_c = 320.51 \text{ K/W}$$

$$Q_{loss} = 0.035 \text{ W}$$

$$U\Delta T = 1.022^\circ C$$

$$UR_c = 32.051 \text{ K/W}$$

$$Q1 = 1/320.51 = 0.00312$$

$$Q2 = -10.22 / 320.51^2 = -9.949E-5$$

$$UQ_{loss} = [(0.00312 * 1.022)^2 + (9.949E-5 * 32.051)^2]^{1/2}$$

$$UQ_{loss} = 0.00451 \text{ W}$$

$$\frac{UQ_{loss}}{Q_{loss}} * 100\% = \frac{0.00451}{0.035} * 100\% = 12.89\%$$

$$\underline{Q_{loss} = 0.035 \pm 12.9\% \text{ W}}$$

Net heat added to the FC-75

$$Q_{net} = \text{Power} - Q_{loss}$$

$$UQ_{net} = [U\text{Power}^2 + UQ_{loss}^2]^{1/2}$$

Substituting numerical values,

$$Q_{net} = 0.768 \text{ W}$$

$$UPower = 0.02015 \text{ W}$$

$$UQ_{loss} = 0.00451 \text{ W}$$

$$UQ_{net} = (0.02015^2 + 0.00451^2)^{1/2}$$

$$UQ_{net} = 0.02065 \text{ W}$$

$$\frac{UQ_{net}}{Q_{net}} * 100\% = \frac{0.02065}{0.768} * 100\% = 2.69\%$$

$$\underline{Q_{net} = 0.768 \pm 2.69\% \text{ W}}$$

B. UNCERTAINTIES IN NUSSELT NUMBER

Starting with average heat transfer coefficient,

$$h = Q_{net} / [A_{total} (T_{avg} - T_{sink})]$$

$$h = \text{function} (Q_{net}, A_{total}, \Delta T)$$

$$h1 = \frac{\partial h}{\partial Q_{net}} = \frac{1}{A_{total} * \Delta T}$$

$$h2 = \frac{\partial h}{\partial A_{total}} = - \frac{Q_{net}}{A_{total}^2 * \Delta T}$$

$$h3 = \frac{\partial h}{\partial \Delta T} = - \frac{Q_{net}}{A_{total} * \Delta T^2}$$

$$Uh = [(h1 * UQ_{net})^2 + (h2 * UA_{total})^2 + (h3 * U\Delta T)^2]^{1/2}$$

where,

$$U\Delta T = 1\%$$

Calculation of uncertainty in A_{total}

$$A_{total} = 2BH + 2LH + LB$$

where,

L, B, H = Length, width, and height of the component

$$A1 = \frac{\partial A_{total}}{\partial L} = 2H + B$$

$$A2 = \frac{\partial A_{total}}{\partial B} = 2H + L$$

$$A3 = \frac{\partial A_{total}}{\partial H} = 2B + 2L$$

$$UA_{total} = [(A1 * UL)^2 + (A2 * UB)^2 + (A3 * UH)^2]^{1/2}$$

Substituting numerical values

$$UL = UH = UB = 1E-4 \text{ m}$$

$$L = 0.024 \text{ m}$$

$$B = 0.008 \text{ m}$$

$$H = 0.006 \text{ m}$$

$$A1 = 2 * 0.006 + 0.008 = 0.02$$

$$A2 = 2 * 0.006 + 0.024 = 0.036$$

$$A3 = 2(0.008 + 0.024) = 0.064$$

$$UA_{total} = [(0.02 * 0.0001)^2 + (0.036 * 0.0001)^2 + (0.064 * 0.0001)^2]^{1/2}$$

$$UA_{total} = 7.61E-6 \text{ m}^2$$

Going back to calculation of the uncertainty in heat transfer coefficient and substituting numerical values,

$$h = 71.11 \text{ W/m}^2 \text{ K}$$

$$\Delta T = 18.75^\circ\text{C}$$

$$U\Delta T = 0.1875^\circ\text{C}$$

$$A_{total} = 5.76E-6 \text{ m}^2$$

$$h1 = \frac{1}{5.76E-4 * 18.75} = 92.59$$

$$h2 = - \frac{0.768}{(5.76E-4)^2 18.75} = - 123456.79$$

$$h_3 = - \frac{0.768}{5.76E-4 * 18.75^2} = - 3.79$$

$$U_h = [(92.59 * 0.02065)^2 + (123456.79 * 7.61E-6)^2 + (3.79 * 0.1875)^2]^{1/2}$$

$$U_h = 2.2457 \text{ W/m}^2\text{K}$$

$$\frac{U_h}{h} * 100\% = \frac{2.2457}{71.11} * 100\% = 3.16\%$$

$$h = 71.11 \pm 3.16\% \text{ W/m}^2\text{K}$$

From Equation (20)

$$Nu_1 = hL_1 / k$$

$$Nu_1 = \text{function}(h, L_1, k)$$

$$N_1 = \frac{\partial Nu_1}{\partial h} = \frac{L_1}{k}$$

$$N_2 = \frac{\partial Nu_1}{\partial L} = \frac{h}{k}$$

$$N_3 = \frac{\partial Nu_1}{\partial k} = - \frac{hL}{k^2}$$

$$UNu1 = [(N1 * Uh)^2 + (N2 * UL1)^2 + (N3 * Uk)^2]^{1/2}$$

Assuming no uncertainties in FC-75 properties

$$UNu1 = [(N1 * Uh)^2 + (N2 * UL1)^2]^{1/2}$$

Substituting numerical values

$$L1 = 0.008 \text{ m}$$

$$h = 71.11 \text{ W/m}^2\text{K}$$

$$k = 0.06347 \text{ W/mK}$$

$$N1 = 0.008 / 0.06347 = 0.126$$

$$N2 = 71.11 / 0.06347 = 1120.37$$

$$UNu1 = [(0.126 * 2.2457)^2 + (1120.37 * E-4)^2]^{1/2}$$

$$UNu1 = 0.3043$$

$$\frac{UNu1}{Nu1} * 100\% = \frac{0.3043}{8.966} = 3.39\%$$

$$\underline{Nu1 = 8.966 \pm 3.39\%}$$

C. UNCERTAINTIES IN FLUX BASED RAYLEIGH NUMBER

From Equation (27)

$$Ra_r = g\beta L^4 Q_{net} / k_r \nu \alpha A_{total}$$

Again, assuming no uncertainties in FC-75 properties and gravitational acceleration,

$$Ra_r = \text{function } (L^4, Q_{net}, A_{total})$$

$$R1 = \frac{\partial Ra_f}{\partial L^4} = \frac{4g\beta Q_{net}}{kv\alpha A_{total}} L^3$$

$$R2 = \frac{\partial Ra_f}{\partial Q_{net}} = \frac{g\beta L^4}{kv\alpha A_{total}}$$

$$R3 = \frac{\partial Ra_f}{\partial A_{total}} = - \frac{g\beta L^4 Q_{net}}{A_{total}^2}$$

$$URa_f = [(R1 * UL^4)^2 + (R2 * UQ_{net})^2 + (R3 * UA_{total})^2]^{1/2}$$

Substituting numerical values

$$\beta = 0.001384 \text{ K}^{-1}$$

$$k = 0.06347 \text{ W/mK}$$

$$v = 9.574E-7 \text{ m}^2/\text{s}$$

$$\alpha = 3.4409E-8 \text{ m}^2/\text{s}$$

$$Q_{net} = 0.768 \text{ W}$$

$$UQ_{net} = 0.02065 \text{ W}$$

$$A_{total} = 5.76E-4 \text{ m}^2$$

$$UA_{total} = 7.61E-6 \text{ m}^2$$

$$L = 0.008 \text{ m}$$

$$UL = 1E-4 \text{ m}$$

$$R1 = 1.7731E10$$

$$R2 = 46175179.2$$

$$R3 = 6.1567E10$$

$$URa_i = [(1.7731E10 * E-4)^2 + (46175179.2 * 0.02065)^2 + (6.1567E10 * 7.61E-6)^2]^{1/2}$$

$$URa_i = 2066398$$

$$\frac{URa_i}{Ra_i} * 100\% = \frac{2066398}{3.547E7} * 100\% = 5.83\%$$

$$Ra_i = 3.547E7 \pm 5.83\%$$

APPENDIX C. TABLES

TABLE 1. REDUCED DATA FOR FC-75 AND 42 MM SPACING

THE RAW Emf DATA ARE FROM THE FILE: 12DEC2020
 THE POWER SETTING PER CHIP WAS: 0.115 W
 THE DISTANCE TO THE FRONT WALL WAS 42 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	.113	4.991	4.933	6.923
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .90				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.46				
AVERAGE TEMPERATURE: 14.848				
SINK TEMPERATURE: 9.857				
2	.113	4.981	4.932	6.922
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .90				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.45				
AVERAGE TEMPERATURE: 14.836				
SINK TEMPERATURE: 9.857				
3	.113	4.991	4.914	6.897
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .90				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.44				
AVERAGE TEMPERATURE: 14.848				
SINK TEMPERATURE: 9.857				
4	.114	4.950	4.995	7.011
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .90				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.49				
AVERAGE TEMPERATURE: 14.807				
SINK TEMPERATURE: 9.857				
5	.116	4.369	5.085	7.137
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .90				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.57				
AVERAGE TEMPERATURE: 14.826				
SINK TEMPERATURE: 9.857				
6	.116	5.060	4.967	6.971
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .92				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.55				
AVERAGE TEMPERATURE: 14.917				
SINK TEMPERATURE: 9.857				
7	.113	4.928	4.958	6.958
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .89				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.42				
AVERAGE TEMPERATURE: 14.785				
SINK TEMPERATURE: 9.857				
8	.117	5.157	4.905	6.885
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .94				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.59				
AVERAGE TEMPERATURE: 15.014				
SINK TEMPERATURE: 9.857				
9	.117	5.179	4.861	6.851
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .94				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.59				
AVERAGE TEMPERATURE: 15.036				
SINK TEMPERATURE: 9.957				

TABLE 2. REDUCED DATA FOR FC-75 AND 42 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 13DEC0740
 THE POWER SETTING PER CHIP WAS: 0.34 W
 THE DISTANCE TO THE FRONT WALL WAS 42 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	.330	8.153	8.808	12.363
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.54				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.56				
AVERAGE TEMPERATURE: 18.307				
SINK TEMPERATURE: 10.155				
2	.329	7.900	9.062	12.720
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.49				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.48				
AVERAGE TEMPERATURE: 18.055				
SINK TEMPERATURE: 10.155				
3	.329	7.664	9.089	12.757
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.48				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.45				
AVERAGE TEMPERATURE: 18.019				
SINK TEMPERATURE: 10.155				
4	.331	8.073	8.927	12.530
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.52				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.60				
AVERAGE TEMPERATURE: 18.226				
SINK TEMPERATURE: 10.155				
5	.339	7.268	9.367	13.147
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.48				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.87				
AVERAGE TEMPERATURE: 18.023				
SINK TEMPERATURE: 10.155				
6	.337	7.885	9.295	13.047
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.48				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.80				
AVERAGE TEMPERATURE: 18.040				
SINK TEMPERATURE: 10.155				
7	.327	8.059	8.821	12.380
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.52				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.41				
AVERAGE TEMPERATURE: 18.213				
SINK TEMPERATURE: 10.155				
8	.339	7.994	9.211	12.928
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.51				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.88				
AVERAGE TEMPERATURE: 18.148				
SINK TEMPERATURE: 10.155				
9	.338	7.922	9.262	13.028
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.49				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.85				
AVERAGE TEMPERATURE: 18.076				
SINK TEMPERATURE: 10.155				

TABLE 3. REDUCED DATA FOR FC-75 AND 42 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 13DEC1205
 THE POWER SETTING PER CHIP WAS: 0.8 W
 THE DISTANCE TO THE FRONT WALL WAS 42 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	.776	14.283	11.865	16.653
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 2.89				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 34.25				
AVERAGE TEMPERATURE: 24.492				
SINK TEMPERATURE: 10.210				
2	.774	13.691	12.337	17.316
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 2.75				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 33.92				
AVERAGE TEMPERATURE: 23.901				
SINK TEMPERATURE: 10.210				
3	.772	13.510	12.472	17.506
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 2.71				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 33.78				
AVERAGE TEMPERATURE: 23.720				
SINK TEMPERATURE: 10.210				
4	.779	14.217	11.958	16.784
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 2.87				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 34.34				
AVERAGE TEMPERATURE: 24.426				
SINK TEMPERATURE: 10.210				
5	.796	13.692	12.689	17.810
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 2.75				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 34.89				
AVERAGE TEMPERATURE: 23.902				
SINK TEMPERATURE: 10.210				
6	.792	13.385	12.902	18.109
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 2.68				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 34.57				
AVERAGE TEMPERATURE: 23.595				
SINK TEMPERATURE: 10.210				
7	.768	14.279	11.739	16.476
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 2.89				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 33.88				
AVERAGE TEMPERATURE: 24.488				
SINK TEMPERATURE: 10.210				
8	.796	13.728	12.647	17.751
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 2.76				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 34.88				
AVERAGE TEMPERATURE: 23.937				
SINK TEMPERATURE: 10.210				
9	.795	13.416	12.922	18.137
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 2.69				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 34.72				
AVERAGE TEMPERATURE: 23.626				
SINK TEMPERATURE: 10.210				

TABLE 4. REDUCED DATA FOR FC-75 AND 42 MM SPACING

THE RAW Emf DATA ARE FROM THE FILE: 13DEC1620
 THE POWER SETTING PER CHIP WAS: 1.3 W
 THE DISTANCE TO THE FRONT WALL WAS 42 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	1.256	19.496	14.108	19.801
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.18				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 58.97				
AVERAGE TEMPERATURE: 29.858				
SINK TEMPERATURE: 10.362				
2	1.252	18.304	14.971	21.013
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.88				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 58.02				
AVERAGE TEMPERATURE: 28.666				
SINK TEMPERATURE: 10.362				
3	1.250	17.922	15.259	21.418
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.78				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 57.66				
AVERAGE TEMPERATURE: 28.283				
SINK TEMPERATURE: 10.362				
4	1.261	19.358	14.266	20.023
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.14				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 59.12				
AVERAGE TEMPERATURE: 29.720				
SINK TEMPERATURE: 10.362				
5	1.288	18.447	15.288	21.459
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.91				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 59.80				
AVERAGE TEMPERATURE: 28.808				
SINK TEMPERATURE: 10.362				
6	1.282	18.197	15.415	21.636
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.85				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 59.32				
AVERAGE TEMPERATURE: 28.559				
SINK TEMPERATURE: 10.362				
7	1.244	19.317	14.102	19.793
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.13				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 58.29				
AVERAGE TEMPERATURE: 29.676				
SINK TEMPERATURE: 10.362				
8	1.288	18.255	15.443	21.675
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.86				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 59.65				
AVERAGE TEMPERATURE: 28.617				
SINK TEMPERATURE: 10.362				
9	1.287	17.705	15.905	22.324
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.72				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 59.24				
AVERAGE TEMPERATURE: 28.066				
SINK TEMPERATURE: 10.362				

TABLE 5. REDUCED DATA FOR FC-75 AND 42 MM SPACING

THE RAW Exp DATA ARE FROM THE FILE: 13DEC1950
 THE POWER SETTING PER CHIP WAS: 1.7 W
 THE DISTANCE TO THE FRONT WALL WAS 42 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	NU1	NU2
1	1.857	23.602	15.413	21.633
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 5.27				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 81.26				
AVERAGE TEMPERATURE: 32.864				
SINK TEMPERATURE: 10.256				
2	1.853	21.950	16.506	23.168
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.82				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 79.58				
AVERAGE TEMPERATURE: 32.216				
SINK TEMPERATURE: 10.256				
3	1.649	21.254	17.010	23.874
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.63				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 76.79				
AVERAGE TEMPERATURE: 31.511				
SINK TEMPERATURE: 10.256				
4	1.853	23.495	15.549	21.824
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 5.24				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 81.46				
AVERAGE TEMPERATURE: 33.741				
SINK TEMPERATURE: 10.256				
5	1.701	22.261	16.760	23.524
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.90				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 82.17				
AVERAGE TEMPERATURE: 32.517				
SINK TEMPERATURE: 10.256				
6	1.691	22.232	16.681	23.412
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.90				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 81.68				
AVERAGE TEMPERATURE: 32.494				
SINK TEMPERATURE: 10.256				
7	1.640	23.464	15.342	21.534
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 5.23				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 80.29				
AVERAGE TEMPERATURE: 33.721				
SINK TEMPERATURE: 10.256				
8	1.696	21.933	16.980	23.833
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.81				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 81.74				
AVERAGE TEMPERATURE: 32.189				
SINK TEMPERATURE: 10.256				
9	1.697	21.117	17.618	24.728
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.60				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 80.96				
AVERAGE TEMPERATURE: 31.373				
SINK TEMPERATURE: 10.256				

TABLE 6. REDUCED DATA FOR FC-75 AND 42 MM SPACING

THE RAW Emf DATA ARE FROM THE FILE: 13DEC2240
 THE POWER SETTING PER CHIP WAS: 2.25 W
 THE DISTANCE TO THE FRONT WALL WAS 42 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	2.185	28.871	16.672	23.400
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.82				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 113.62				
AVERAGE TEMPERATURE: 39.174				
SINK TEMPERATURE: 10.303				
2	2.179	26.795	17.890	25.110
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.19				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 110.77				
AVERAGE TEMPERATURE: 37.057				
SINK TEMPERATURE: 10.303				
3	2.174	25.970	18.412	25.842
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 5.95				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 109.56				
AVERAGE TEMPERATURE: 36.272				
SINK TEMPERATURE: 10.303				
4	2.193	28.694	16.836	23.631
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.76				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 113.63				
AVERAGE TEMPERATURE: 38.996				
SINK TEMPERATURE: 10.303				
5	2.242	27.053	18.336	25.595
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.27				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 114.30				
AVERAGE TEMPERATURE: 37.355				
SINK TEMPERATURE: 10.303				
6	2.229	25.819	18.984	26.645
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 5.91				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 112.13				
AVERAGE TEMPERATURE: 36.122				
SINK TEMPERATURE: 10.303				
7	2.163	28.376	16.784	23.557
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.66				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 111.86				
AVERAGE TEMPERATURE: 38.679				
SINK TEMPERATURE: 10.303				
8	2.240	26.440	18.637	26.158
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.09				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 113.45				
AVERAGE TEMPERATURE: 36.742				
SINK TEMPERATURE: 10.303				
9	2.239	25.408	19.372	27.191
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 5.79				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 112.13				
AVERAGE TEMPERATURE: 35.711				
SINK TEMPERATURE: 10.303				

TABLE 7. REDUCED DATA FOR FC-75 AND 42 MM SPACING

THE RAW Emf DATA ARE FROM THE FILE: 14DEC0200
 THE POWER SETTING PER CHIP WAS: 2.9 W
 THE DISTANCE TO THE FRONT WALL WAS 42 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	2.788	34.586	17.817	25.007
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 8.60				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 153.28				
AVERAGE TEMPERATURE: 44.624				
SINK TEMPERATURE: 10.038				
2	2.780	32.098	19.109	25.820
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.79				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 148.80				
AVERAGE TEMPERATURE: 42.136				
SINK TEMPERATURE: 10.038				
3	2.773	30.893	19.791	27.779
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.40				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 146.53				
AVERAGE TEMPERATURE: 40.931				
SINK TEMPERATURE: 10.038				
4	2.798	34.254	18.047	25.330
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 8.49				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 153.25				
AVERAGE TEMPERATURE: 44.292				
SINK TEMPERATURE: 10.038				
5	2.861	31.696	19.912	27.947
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.66				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 152.51				
AVERAGE TEMPERATURE: 41.736				
SINK TEMPERATURE: 10.038				
6	2.843	30.671	20.439	28.668
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.33				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 149.91				
AVERAGE TEMPERATURE: 40.709				
SINK TEMPERATURE: 10.038				
7	2.757	33.861	17.967	25.247
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 8.36				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 150.40				
AVERAGE TEMPERATURE: 43.899				
SINK TEMPERATURE: 10.038				
8	2.857	31.223	20.177	28.320
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.51				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 151.50				
AVERAGE TEMPERATURE: 41.261				
SINK TEMPERATURE: 10.038				
9	2.856	30.362	20.735	29.103
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.24				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 150.08				
AVERAGE TEMPERATURE: 40.400				
SINK TEMPERATURE: 10.038				

TABLE 8. REDUCED DATA FOR FC-75 AND 30 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 24DEC1945
 THE POWER SETTINGS PER CHIP WAS: 0.115 W
 THE DISTANCE TO THE FRONT WALL WAS 30 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	.114	4.466	5.521	7.749
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .81				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.46				
AVERAGE TEMPERATURE: 14.580				
SINK TEMPERATURE: 10.114				
2	.113	4.490	5.464	7.669
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .81				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.44				
AVERAGE TEMPERATURE: 14.604				
SINK TEMPERATURE: 10.114				
3	.113	4.533	5.395	7.573
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .82				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.43				
AVERAGE TEMPERATURE: 14.647				
SINK TEMPERATURE: 10.114				
4	.114	4.401	5.604	7.866
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .60				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.46				
AVERAGE TEMPERATURE: 14.514				
SINK TEMPERATURE: 10.114				
5	.116	4.408	5.710	8.014
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .80				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.55				
AVERAGE TEMPERATURE: 14.522				
SINK TEMPERATURE: 10.114				
6	.115	4.458	5.613	7.878
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .81				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.53				
AVERAGE TEMPERATURE: 14.572				
SINK TEMPERATURE: 10.114				
7	.112	4.302	5.649	7.929
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .78				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.39				
AVERAGE TEMPERATURE: 14.416				
SINK TEMPERATURE: 10.114				
8	.116	4.532	5.559	7.802
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .82				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.57				
AVERAGE TEMPERATURE: 14.646				
SINK TEMPERATURE: 10.114				
9	.116	4.540	5.550	7.789
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .82				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.57				
AVERAGE TEMPERATURE: 14.653				
SINK TEMPERATURE: 10.114				

TABLE 9. REDUCED DATA FOR FC-75 AND 30 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 19DEC1755
 THE POWER SETTING PER CHIP WAS: 0.34 W
 THE DISTANCE TO THE FRONT WALL WAS 30 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	.338	8.472	8.661	12.157
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.60				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.83				
AVERAGE TEMPERATURE: 18.390				
SINK TEMPERATURE: 9.918				
2	.336	8.273	8.838	12.405
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.56				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.75				
AVERAGE TEMPERATURE: 18.191				
SINK TEMPERATURE: 9.918				
3	.335	8.207	8.862	12.467
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.54				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.70				
AVERAGE TEMPERATURE: 18.125				
SINK TEMPERATURE: 9.918				
4	.338	8.489	8.666	12.164
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.60				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.87				
AVERAGE TEMPERATURE: 18.407				
SINK TEMPERATURE: 9.918				
5	.346	8.218	9.140	12.629
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.54				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.12				
AVERAGE TEMPERATURE: 18.136				
SINK TEMPERATURE: 9.918				
6	.344	8.289	9.013	12.651
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.56				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.05				
AVERAGE TEMPERATURE: 18.207				
SINK TEMPERATURE: 9.918				
7	.333	8.494	8.533	11.977
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.60				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.67				
AVERAGE TEMPERATURE: 18.412				
SINK TEMPERATURE: 9.918				
8	.345	8.366	8.974	12.596
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.58				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.14				
AVERAGE TEMPERATURE: 18.284				
SINK TEMPERATURE: 9.918				
9	.345	8.276	9.062	12.720
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.56				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.11				
AVERAGE TEMPERATURE: 18.195				
SINK TEMPERATURE: 9.918				

TABLE 10. REDUCED DATA FOR FC-75 AND 30 MM SPACING

THE RAW Emf DATA ARE FROM THE FILE: 19DEC2115
 THE POWER SETTING PER CHIP WAS: 0.8 W
 THE DISTANCE TO THE FRONT WALL WAS 30 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	.774	14.305	11.819	16.589
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: 2.90				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 34.29				
AVERAGE TEMPERATURE: 24.657				
SINK TEMPERATURE: 10.352				
2	.772	13.655	12.338	17.318
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: 2.75				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 33.93				
AVERAGE TEMPERATURE: 24.007				
SINK TEMPERATURE: 10.352				
3	.770	13.463	12.487	17.526
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: 2.71				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 33.78				
AVERAGE TEMPERATURE: 23.815				
SINK TEMPERATURE: 10.352				
4	.777	14.239	11.914	16.722
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: 2.89				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 34.38				
AVERAGE TEMPERATURE: 24.591				
SINK TEMPERATURE: 10.352				
5	.794	13.725	12.620	17.713
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: 2.77				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 34.91				
AVERAGE TEMPERATURE: 24.078				
SINK TEMPERATURE: 10.352				
6	.789	13.584	12.673	17.788
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: 2.73				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 34.64				
AVERAGE TEMPERATURE: 23.936				
SINK TEMPERATURE: 10.352				
7	.765	14.270	11.697	16.417
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: 2.89				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 33.84				
AVERAGE TEMPERATURE: 24.622				
SINK TEMPERATURE: 10.352				
8	.792	13.618	12.699	17.824
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: 2.74				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 34.81				
AVERAGE TEMPERATURE: 23.970				
SINK TEMPERATURE: 10.352				
9	.792	13.423	12.877	18.073
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: 2.70				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 34.72				
AVERAGE TEMPERATURE: 23.775				
SINK TEMPERATURE: 10.352				

TABLE 11. REDUCED DATA FOR FC-75 AND 30 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 19DEC2300
 THE POWER SETTING PER CHIP WAS: 1.3 W
 THE DISTANCE TO THE FRONT WALL WAS 30 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	1.250	19.467	14.063	19.738
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.17				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 58.71				
AVERAGE TEMPERATURE: 29.854				
SINK TEMPERATURE: 10.387				
2	1.246	18.143	15.031	21.097
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.84				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 57.67				
AVERAGE TEMPERATURE: 28.531				
SINK TEMPERATURE: 10.387				
3	1.243	17.749	15.322	21.505
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.74				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 57.26				
AVERAGE TEMPERATURE: 28.136				
SINK TEMPERATURE: 10.387				
4	1.254	19.327	14.215	19.951
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.14				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 58.83				
AVERAGE TEMPERATURE: 29.715				
SINK TEMPERATURE: 10.387				
5	1.282	18.473	15.196	21.329
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.92				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 59.57				
AVERAGE TEMPERATURE: 28.860				
SINK TEMPERATURE: 10.387				
6	1.275	18.125	15.395	21.608
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.83				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 58.99				
AVERAGE TEMPERATURE: 28.512				
SINK TEMPERATURE: 10.387				
7	1.236	19.304	14.023	19.683
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.13				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 57.95				
AVERAGE TEMPERATURE: 29.691				
SINK TEMPERATURE: 10.387				
8	1.281	18.222	15.389	21.600
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.86				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 59.35				
AVERAGE TEMPERATURE: 28.609				
SINK TEMPERATURE: 10.387				
9	1.280	17.805	15.736	22.086
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.75				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 59.03				
AVERAGE TEMPERATURE: 28.192				
SINK TEMPERATURE: 10.367				

TABLE 12. REDUCED DATA FOR FC-75 AND 30 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 21DEC1900
 THE POWER SETTING PER CHIP WAS: 1.7 W
 THE DISTANCE TO THE FRONT WALL WAS 30 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	1.653	23.773	15.265	21.426
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 5.32				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 81.16				
AVERAGE TEMPERATURE: 34.003				
SINK TEMPERATURE: 10.230				
2	1.648	22.177	16.303	22.883
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.88				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 79.52				
AVERAGE TEMPERATURE: 32.407				
SINK TEMPERATURE: 10.230				
3	1.645	21.949	16.440	23.075
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.62				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 79.17				
AVERAGE TEMPERATURE: 32.179				
SINK TEMPERATURE: 10.230				
4	1.659	23.708	15.365	21.567
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 5.30				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 81.41				
AVERAGE TEMPERATURE: 33.938				
SINK TEMPERATURE: 10.230				
5	1.695	22.360	16.631	23.343
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.93				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 81.94				
AVERAGE TEMPERATURE: 32.590				
SINK TEMPERATURE: 10.230				
6	1.685	21.725	17.013	23.879
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.76				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 80.90				
AVERAGE TEMPERATURE: 31.955				
SINK TEMPERATURE: 10.230				
7	1.634	23.736	15.115	21.215
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 5.31				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 80.20				
AVERAGE TEMPERATURE: 33.966				
SINK TEMPERATURE: 10.230				
8	1.693	22.117	16.787	23.562
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.86				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 81.61				
AVERAGE TEMPERATURE: 32.347				
SINK TEMPERATURE: 10.230				
9	1.692	21.481	17.273	24.244
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.69				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 81.01				
AVERAGE TEMPERATURE: 31.711				
SINK TEMPERATURE: 10.230				

TABLE 13. REDUCED DATA FOR FC-75 AND 30 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 21DEC2125
 THE POWER SETTINGS PER CHIP WAS: 2.25 W
 THE DISTANCE TO THE FRONT WALL WAS 30 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	NU1	NU2
1	2.180	29.628	16.217	22.762
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.03				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 114.00				
AVERAGE TEMPERATURE: 39.800				
SINK TEMPERATURE: 10.172				
2	2.175	27.604	17.341	24.339
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.41				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 111.24				
AVERAGE TEMPERATURE: 37.776				
SINK TEMPERATURE: 10.172				
3	2.170	26.629	17.732	24.888
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.21				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 110.19				
AVERAGE TEMPERATURE: 37.100				
SINK TEMPERATURE: 10.172				
4	2.189	29.503	16.348	22.946
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.99				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 114.28				
AVERAGE TEMPERATURE: 39.675				
SINK TEMPERATURE: 10.172				
5	2.238	27.782	17.730	24.825
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.47				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 114.68				
AVERAGE TEMPERATURE: 37.954				
SINK TEMPERATURE: 10.172				
6	2.225	26.825	18.247	25.611
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.18				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 112.84				
AVERAGE TEMPERATURE: 36.997				
SINK TEMPERATURE: 10.172				
7	2.157	29.272	16.237	22.790
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.92				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 112.35				
AVERAGE TEMPERATURE: 39.444				
SINK TEMPERATURE: 10.172				
8	2.234	27.395	17.948	25.192
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.35				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 114.02				
AVERAGE TEMPERATURE: 37.567				
SINK TEMPERATURE: 10.172				
9	2.234	26.566	18.482	25.941
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.11				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 113.00				
AVERAGE TEMPERATURE: 36.758				
SINK TEMPERATURE: 10.172				

TABLE 14. REDUCED DATA FOR FC-75 AND 30 MM SPACING

THE RAW Emf DATA ARE FROM THE FILE: 21DEC2340
 THE POWER SETTING PER CHIP WAS: 2.9 W
 THE DISTANCE TO THE FRONT WALL WAS 30 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	2.791	35.184	17.542	24.621
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 8.83				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 154.91				
AVERAGE TEMPERATURE: 45.374				
SINK TEMPERATURE: 10.190				
2	2.783	32.753	18.761	26.332
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 8.02				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 150.52				
AVERAGE TEMPERATURE: 42.943				
SINK TEMPERATURE: 10.190				
3	2.778	31.890	19.221	26.978
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.74				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 148.85				
AVERAGE TEMPERATURE: 42.080				
SINK TEMPERATURE: 10.190				
4	2.802	34.976	17.713	24.861
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 8.76				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 155.17				
AVERAGE TEMPERATURE: 45.166				
SINK TEMPERATURE: 10.190				
5	2.866	32.795	19.294	27.080
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 8.04				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 155.05				
AVERAGE TEMPERATURE: 42.985				
SINK TEMPERATURE: 10.190				
6	2.849	31.674	19.849	27.860
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.67				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 152.34				
AVERAGE TEMPERATURE: 41.664				
SINK TEMPERATURE: 10.190				
7	2.763	34.610	17.647	24.769
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 8.64				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 152.42				
AVERAGE TEMPERATURE: 44.800				
SINK TEMPERATURE: 10.190				
8	2.861	32.709	19.311	27.104
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 8.01				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 154.66				
AVERAGE TEMPERATURE: 42.899				
SINK TEMPERATURE: 10.190				
9	2.861	31.416	20.089	28.197
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.59				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 152.53				
AVERAGE TEMPERATURE: 41.606				
SINK TEMPERATURE: 10.190				

TABLE 15. REDUCED DATA FOR FC-75 AND 30 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 22DEC0200
 THE POWER SETTING PER CHIP WAS: 3.55 W
 THE DISTANCE TO THE FRONT WALL WAS 30 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	NU1	NU2
1	3.449	40.914	16.712	26.263
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 10.89				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 203.86				
AVERAGE TEMPERATURE: 51.251				
SINK TEMPERATURE: 10.337				
2	3.438	38.073	20.007	28.081
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 9.66				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 197.29				
AVERAGE TEMPERATURE: 48.410				
SINK TEMPERATURE: 10.337				
3	3.429	36.710	20.680	29.026
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 9.38				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 194.01				
AVERAGE TEMPERATURE: 47.047				
SINK TEMPERATURE: 10.337				
4	3.458	40.842	18.795	26.381
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 10.87				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 204.27				
AVERAGE TEMPERATURE: 51.179				
SINK TEMPERATURE: 10.337				
5	3.537	37.556	20.864	29.284
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 9.68				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 201.92				
AVERAGE TEMPERATURE: 47.893				
SINK TEMPERATURE: 10.337				
6	3.516	36.790	21.162	29.703
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 9.41				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 199.12				
AVERAGE TEMPERATURE: 47.127				
SINK TEMPERATURE: 10.337				
7	3.411	40.358	18.757	26.327
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 10.69				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 200.49				
AVERAGE TEMPERATURE: 50.695				
SINK TEMPERATURE: 10.337				
8	3.532	38.186	20.496	28.768
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 9.90				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 202.94				
AVERAGE TEMPERATURE: 48.523				
SINK TEMPERATURE: 10.337				
9	3.533	36.567	21.391	30.023
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 9.33				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 199.61				
AVERAGE TEMPERATURE: 46.904				
SINK TEMPERATURE: 10.337				

TABLE 16. REDUCED DATA FOR FC-75 AND 18 MM SPACING

THE RAW Emf DATA ARE FROM THE FILE: 15DEC0220
 THE POWER SETTING PER CHIP WAS: 0.115 W
 THE DISTANCE TO THE FRONT WALL WAS 18 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	.113	5.751	4.272	5.996
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.06				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.52				
AVERAGE TEMPERATURE: 15.847				
SINK TEMPERATURE: 10.086				
2	.113	5.760	4.259	5.978
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.06				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.50				
AVERAGE TEMPERATURE: 15.846				
SINK TEMPERATURE: 10.086				
3	.113	5.779	4.233	5.942
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.06				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.49				
AVERAGE TEMPERATURE: 15.865				
SINK TEMPERATURE: 10.086				
4	.114	5.700	4.333	6.082
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.05				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.53				
AVERAGE TEMPERATURE: 15.786				
SINK TEMPERATURE: 10.086				
5	.116	5.630	4.485	6.295
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.03				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.63				
AVERAGE TEMPERATURE: 15.716				
SINK TEMPERATURE: 10.086				
6	.116	5.708	4.396	6.170
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.05				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.60				
AVERAGE TEMPERATURE: 15.794				
SINK TEMPERATURE: 10.086				
7	.112	5.687	4.285	6.015
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.04				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.47				
AVERAGE TEMPERATURE: 15.773				
SINK TEMPERATURE: 10.086				
8	.116	5.812	4.349	6.104
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.07				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.64				
AVERAGE TEMPERATURE: 15.899				
SINK TEMPERATURE: 10.086				
9	.116	5.814	4.344	6.096
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.07				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.64				
AVERAGE TEMPERATURE: 15.902				
SINK TEMPERATURE: 10.086				

TABLE 17. REDUCED DATA FOR FC-75 AND 18 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 15DEC0445
 THE POWER SETTINGS PER CHIP WAS: 0.34 W
 THE DISTANCE TO THE FRONT WALL WAS 18 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	.331	9.370	7.690	10.793
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.79				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.80				
AVERAGE TEMPERATURE: 19.561				
SINK TEMPERATURE: 10.191				
2	.330	9.081	7.902	11.091
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.73				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.70				
AVERAGE TEMPERATURE: 19.272				
SINK TEMPERATURE: 10.191				
3	.329	9.073	7.886	11.059
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.73				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.66				
AVERAGE TEMPERATURE: 19.264				
SINK TEMPERATURE: 10.191				
4	.332	9.286	7.777	10.916
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.78				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.82				
AVERAGE TEMPERATURE: 19.479				
SINK TEMPERATURE: 10.191				
5	.339	9.020	8.184	11.486
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.72				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.08				
AVERAGE TEMPERATURE: 19.211				
SINK TEMPERATURE: 10.191				
6	.337	9.060	8.101	11.370
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.73				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.01				
AVERAGE TEMPERATURE: 19.251				
SINK TEMPERATURE: 10.191				
7	.327	9.324	7.638	10.720
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.78				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.63				
AVERAGE TEMPERATURE: 19.515				
SINK TEMPERATURE: 10.191				
8	.339	9.127	8.092	11.357
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.74				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.11				
AVERAGE TEMPERATURE: 19.318				
SINK TEMPERATURE: 10.191				
9	.340	9.082	8.143	11.429
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.73				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.12				
AVERAGE TEMPERATURE: 19.273				
SINK TEMPERATURE: 10.191				

TABLE 18. REDUCED DATA FOR FC-75 AND 18 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 15DEC1705
 THE POWER SETTING PER CHIP WAS: 0.8 W
 THE DISTANCE TO THE FRONT WALL WAS 18 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	.773	15.989	10.553	14.812
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.27				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 34.48				
AVERAGE TEMPERATURE: 25.856				
SINK TEMPERATURE: 9.867				
2	.770	15.179	11.072	15.541
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.07				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 34.05				
AVERAGE TEMPERATURE: 25.045				
SINK TEMPERATURE: 9.867				
3	.768	15.034	11.150	15.650
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.04				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 33.91				
AVERAGE TEMPERATURE: 24.901				
SINK TEMPERATURE: 9.867				
4	.775	15.927	10.622	14.909
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.25				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 34.55				
AVERAGE TEMPERATURE: 25.794				
SINK TEMPERATURE: 9.867				
5	.792	15.396	11.229	15.761
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.13				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 35.11				
AVERAGE TEMPERATURE: 25.263				
SINK TEMPERATURE: 9.867				
6	.788	15.296	11.241	15.778
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.10				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 34.88				
AVERAGE TEMPERATURE: 25.163				
SINK TEMPERATURE: 9.867				
7	.764	15.815	10.548	14.806
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.23				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 34.03				
AVERAGE TEMPERATURE: 25.682				
SINK TEMPERATURE: 9.867				
8	.791	15.367	11.240	15.776
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.12				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 35.06				
AVERAGE TEMPERATURE: 25.234				
SINK TEMPERATURE: 9.867				
9	.791	15.081	11.447	16.067
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.05				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 34.94				
AVERAGE TEMPERATURE: 24.948				
SINK TEMPERATURE: 9.867				

TABLE 19. REDUCED DATA FOR FC-75 AND 18 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 150502002
 THE POWER SETTING PER CHIP WAS: 1.7 W
 THE DISTANCE TO THE FRONT WALL WAS 18 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	NU1	NU2
1	1.651	26.608	13.647	19.154
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 6.13				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 83.70				
AVERAGE TEMPERATURE: 35.885				
SINK TEMPERATURE: 10.277				
2	1.646	25.690	14.087	19.772
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 5.87				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 82.64				
AVERAGE TEMPERATURE: 35.957				
SINK TEMPERATURE: 10.277				
3	1.642	25.441	14.186	19.910
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 5.79				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 82.20				
AVERAGE TEMPERATURE: 35.719				
SINK TEMPERATURE: 10.277				
4	1.656	26.445	13.772	19.329
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 6.09				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 83.62				
AVERAGE TEMPERATURE: 36.723				
SINK TEMPERATURE: 10.277				
5	1.692	25.936	14.349	20.139
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 5.94				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 85.20				
AVERAGE TEMPERATURE: 36.213				
SINK TEMPERATURE: 10.277				
6	1.682	25.646	14.422	20.243
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 5.85				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 84.42				
AVERAGE TEMPERATURE: 35.922				
SINK TEMPERATURE: 10.277				
7	1.631	26.311	13.834	19.136
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 6.05				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 82.44				
AVERAGE TEMPERATURE: 36.588				
SINK TEMPERATURE: 10.277				
8	1.690	26.355	14.102	19.794
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 6.06				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 85.45				
AVERAGE TEMPERATURE: 36.632				
SINK TEMPERATURE: 10.277				
9	1.689	25.566	14.525	20.387
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 5.83				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 84.68				
AVERAGE TEMPERATURE: 35.843				
SINK TEMPERATURE: 10.277				

TABLE 20. REDUCED DATA FOR FC-75 AND 18 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 15DEC2315
 THE POWER SETTING PER CHIP WAS: 2.25 W
 THE DISTANCE TO THE FRONT WALL WAS 18 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	2.175	31.844	15.068	21.148
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.71				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 116.22				
AVERAGE TEMPERATURE: 41.932				
SINK TEMPERATURE: 10.088				
2	2.167	31.268	15.277	21.443
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.54				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 115.14				
AVERAGE TEMPERATURE: 41.376				
SINK TEMPERATURE: 10.088				
3	2.162	31.322	15.413	21.634
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.42				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 114.43				
AVERAGE TEMPERATURE: 41.021				
SINK TEMPERATURE: 10.088				
4	2.182	31.665	15.200	21.335
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.66				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 116.38				
AVERAGE TEMPERATURE: 41.753				
SINK TEMPERATURE: 10.088				
5	2.230	31.674	15.533	21.802
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.66				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 118.97				
AVERAGE TEMPERATURE: 41.762				
SINK TEMPERATURE: 10.088				
6	2.217	31.173	15.688	22.019
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.50				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 117.65				
AVERAGE TEMPERATURE: 41.261				
SINK TEMPERATURE: 10.088				
7	2.150	31.496	15.060	21.138
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.60				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 114.50				
AVERAGE TEMPERATURE: 41.584				
SINK TEMPERATURE: 10.088				
8	2.227	32.178	15.276	21.441
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.82				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 119.47				
AVERAGE TEMPERATURE: 42.266				
SINK TEMPERATURE: 10.088				
9	2.227	31.178	15.755	22.113
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.50				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 118.19				
AVERAGE TEMPERATURE: 41.266				
SINK TEMPERATURE: 10.088				

TABLE 21. REDUCED DATA FOR FC-75 AND 18 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 16DEC0050
 THE POWER SETTING PER CHIP WAS: 2.9 W
 THE DISTANCE TO THE FRONT WALL WAS 18 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	2.789	36.201	17.044	23.922
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 9.18				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 156.44				
AVERAGE TEMPERATURE: 46.396				
SINK TEMPERATURE: 10.196				
2	2.779	36.930	16.661	23.385
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 9.43				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 157.14				
AVERAGE TEMPERATURE: 47.126				
SINK TEMPERATURE: 10.196				
3	2.773	36.008	17.038	23.913
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 9.11				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 155.26				
AVERAGE TEMPERATURE: 46.204				
SINK TEMPERATURE: 10.196				
4	2.797	35.940	17.218	24.167
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 9.09				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 156.50				
AVERAGE TEMPERATURE: 46.136				
SINK TEMPERATURE: 10.196				
5	2.859	37.221	17.006	23.870
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 9.53				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 162.13				
AVERAGE TEMPERATURE: 47.417				
SINK TEMPERATURE: 10.196				
6	2.841	36.198	17.368	24.378
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 9.18				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 159.41				
AVERAGE TEMPERATURE: 46.394				
SINK TEMPERATURE: 10.196				
7	2.756	35.738	17.059	23.943
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 9.02				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 153.88				
AVERAGE TEMPERATURE: 45.934				
SINK TEMPERATURE: 10.196				
8	2.853	37.512	16.846	23.645
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 9.64				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 162.32				
AVERAGE TEMPERATURE: 47.707				
SINK TEMPERATURE: 10.196				
9	2.854	36.201	17.445	24.485
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 9.18				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 160.13				
AVERAGE TEMPERATURE: 46.397				
SINK TEMPERATURE: 10.196				

TABLE 22. REDUCED DATA FOR FC-75 AND 11 MM SPACING

THE RAW E-f DATA ARE FROM THE FILE: 18DEC1930
 THE POWER SETTING PER CHIP WAS: 0.115 W
 THE DISTANCE TO THE FRONT WALL WAS 11 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	.114	7.494	3.295	4.625
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.40				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.62				
AVERAGE TEMPERATURE: 17.537				
SINK TEMPERATURE: 10.042				
2	.113	7.481	3.289	4.617
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.40				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.60				
AVERAGE TEMPERATURE: 17.523				
SINK TEMPERATURE: 10.042				
3	.113	7.483	3.284	4.609
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.40				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.59				
AVERAGE TEMPERATURE: 17.525				
SINK TEMPERATURE: 10.042				
4	.114	7.366	3.361	4.717
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.38				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.62				
AVERAGE TEMPERATURE: 17.408				
SINK TEMPERATURE: 10.042				
5	.116	7.330	3.451	4.844
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.37				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.72				
AVERAGE TEMPERATURE: 17.372				
SINK TEMPERATURE: 10.042				
6	.116	7.375	3.415	4.794
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.38				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.70				
AVERAGE TEMPERATURE: 17.418				
SINK TEMPERATURE: 10.042				
7	.113	7.467	3.275	4.595
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.40				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.57				
AVERAGE TEMPERATURE: 17.509				
SINK TEMPERATURE: 10.042				
8	.116	7.453	3.396	4.766
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.39				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.73				
AVERAGE TEMPERATURE: 17.496				
SINK TEMPERATURE: 10.042				
9	.116	7.454	3.393	4.762
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.39				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.73				
AVERAGE TEMPERATURE: 17.496				
SINK TEMPERATURE: 10.042				

TABLE 23. REDUCED DATA FOR FC-75 AND 11 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 16DEC1900
 THE POWER SETTING PER CHIP WAS: 0.34 W
 THE DISTANCE TO THE FRONT WALL WAS 11 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	.332	11.061	6.535	9.172
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.15				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.05				
AVERAGE TEMPERATURE: 21.092				
SINK TEMPERATURE: 10.031				
2	.331	10.906	6.606	9.272
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.12				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.98				
AVERAGE TEMPERATURE: 20.937				
SINK TEMPERATURE: 10.031				
3	.330	10.947	6.566	9.216
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.13				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.96				
AVERAGE TEMPERATURE: 20.977				
SINK TEMPERATURE: 10.031				
4	.333	11.084	6.547	9.190
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.16				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.11				
AVERAGE TEMPERATURE: 21.114				
SINK TEMPERATURE: 10.031				
5	.341	10.858	6.836	9.595
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.11				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.40				
AVERAGE TEMPERATURE: 20.889				
SINK TEMPERATURE: 10.031				
6	.339	10.695	6.780	9.516
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.11				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.33				
AVERAGE TEMPERATURE: 20.925				
SINK TEMPERATURE: 10.031				
7	.329	10.927	6.559	9.206
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.12				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.91				
AVERAGE TEMPERATURE: 20.957				
SINK TEMPERATURE: 10.031				
8	.341	10.557	6.779	9.515
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.13				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.42				
AVERAGE TEMPERATURE: 20.987				
SINK TEMPERATURE: 10.031				
9	.341	10.935	6.786	9.524
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.12				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.41				
AVERAGE TEMPERATURE: 20.966				
SINK TEMPERATURE: 10.031				

TABLE 24. REDUCED DATA FOR FC-75 AND 11 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 16DEC2235
 THE POWER SETTING PER CHIP WAS: 0.6 W
 THE DISTANCE TO THE FRONT WALL WAS 11 MM, LIQUID WAS FC-75

CHIP	ONET(W)	Tavg-Ts	Nu1	Nu2
1	.776	18.389	9.237	12.965
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.87				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 35.78				
AVERAGE TEMPERATURE: 28.457				
SINK TEMPERATURE: 10.078				
2	.774	17.638	9.603	13.478
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.69				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 35.39				
AVERAGE TEMPERATURE: 27.716				
SINK TEMPERATURE: 10.078				
3	.773	17.504	9.659	13.557
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.65				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 35.28				
AVERAGE TEMPERATURE: 27.582				
SINK TEMPERATURE: 10.078				
4	.780	18.274	9.342	13.113
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.84				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 35.92				
AVERAGE TEMPERATURE: 28.352				
SINK TEMPERATURE: 10.078				
5	.798	17.677	9.868	13.850
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.70				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 36.46				
AVERAGE TEMPERATURE: 27.755				
SINK TEMPERATURE: 10.078				
6	.793	17.592	9.864	13.844
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.67				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 36.24				
AVERAGE TEMPERATURE: 27.670				
SINK TEMPERATURE: 10.078				
7	.770	18.098	9.307	13.063
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.80				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 35.37				
AVERAGE TEMPERATURE: 28.176				
SINK TEMPERATURE: 10.078				
8	.758	17.661	9.876	13.862
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.69				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 36.45				
AVERAGE TEMPERATURE: 27.739				
SINK TEMPERATURE: 10.078				
9	.797	17.437	9.991	14.023
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.64				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 36.32				
AVERAGE TEMPERATURE: 27.515				
SINK TEMPERATURE: 10.078				

TABLE 25. REDUCED DATA FOR FC-75 AND 11 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 18DEC1615
 THE POWER SETTING PER CHIP WAS: 1.3 W
 THE DISTANCE TO THE FRONT WALL WAS 11 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	1.255	25.829	10.681	14.991
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 5.67				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 62.56				
AVERAGE TEMPERATURE: 35.782				
SINK TEMPERATURE: 9.954				
2	1.252	25.853	10.641	14.935
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 5.67				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 62.50				
AVERAGE TEMPERATURE: 35.805				
SINK TEMPERATURE: 9.954				
3	1.249	25.239	10.868	15.255
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 5.70				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 61.93				
AVERAGE TEMPERATURE: 35.193				
SINK TEMPERATURE: 9.954				
4	1.260	25.866	10.706	15.026
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 5.88				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 62.93				
AVERAGE TEMPERATURE: 35.820				
SINK TEMPERATURE: 9.954				
5	1.288	25.513	11.092	15.569
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 5.76				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 64.07				
AVERAGE TEMPERATURE: 35.467				
SINK TEMPERATURE: 9.954				
6	1.280	27.507	10.241	14.374
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.36				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 65.11				
AVERAGE TEMPERATURE: 37.460				
SINK TEMPERATURE: 9.954				
7	1.241	26.096	10.455	14.675
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 5.94				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 62.15				
AVERAGE TEMPERATURE: 36.049				
SINK TEMPERATURE: 9.954				
8	1.286	26.212	10.789	15.143
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 5.98				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 64.49				
AVERAGE TEMPERATURE: 36.165				
SINK TEMPERATURE: 9.954				
9	1.286	25.309	11.162	15.666
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 5.72				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 63.82				
AVERAGE TEMPERATURE: 35.263				
SINK TEMPERATURE: 9.954				

TABLE 26. REDUCED DATA FOR FC-75 AND 11 MM SPACING

THE RAW Emf DATA ARE FROM THE FILE: 17DEC00100
 THE POWER SETTING PER CHIP WAS: 1.7 W
 THE DISTANCE TO THE FRONT WALL WAS 11 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	1.647	28.683	12.642	17.744
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.71				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 84.86				
AVERAGE TEMPERATURE: 36.659				
SINK TEMPERATURE: 9.977				
2	1.642	29.264	12.357	17.344
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.89				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 85.14				
AVERAGE TEMPERATURE: 39.241				
SINK TEMPERATURE: 9.977				
3	1.639	28.716	12.566	17.637
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.72				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 84.48				
AVERAGE TEMPERATURE: 36.692				
SINK TEMPERATURE: 9.977				
4	1.654	28.527	12.764	17.915
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.67				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 85.08				
AVERAGE TEMPERATURE: 38.504				
SINK TEMPERATURE: 9.977				
5	1.690	29.015	12.028	18.005
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.81				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 87.41				
AVERAGE TEMPERATURE: 38.992				
SINK TEMPERATURE: 9.977				
6	1.680	28.670	12.905	18.113
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.71				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 86.58				
AVERAGE TEMPERATURE: 38.647				
SINK TEMPERATURE: 9.977				
7	1.630	28.453	12.612	17.701
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.64				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 83.78				
AVERAGE TEMPERATURE: 38.430				
SINK TEMPERATURE: 9.977				
8	1.688	30.082	12.367	17.358
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.14				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 88.32				
AVERAGE TEMPERATURE: 40.059				
SINK TEMPERATURE: 9.977				
9	1.687	28.612	12.896	18.101
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.75				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 87.07				
AVERAGE TEMPERATURE: 36.768				
SINK TEMPERATURE: 9.977				

TABLE 27. REDUCED DATA FOR FC-75 AND 11 MM SPACING

THE FAW EFF DATA ARE FROM THE FILE: 17DEC1830
 THE POWER SETTING PER CHIP WAS: 2.25 W
 THE DISTANCE TO THE FRONT WALL WAS 11 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	2.181	33.920	14.208	19.942
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 8.39				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 119.26				
AVERAGE TEMPERATURE: 44.033				
SINK TEMPERATURE: 10.113				
2	2.174	35.537	13.531	18.932
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 8.94				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 120.55				
AVERAGE TEMPERATURE: 45.650				
SINK TEMPERATURE: 10.113				
3	2.169	34.671	13.628	19.408
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 8.64				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 119.53				
AVERAGE TEMPERATURE: 44.784				
SINK TEMPERATURE: 10.113				
4	2.169	35.734	14.332	20.116
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 8.33				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 119.42				
AVERAGE TEMPERATURE: 43.847				
SINK TEMPERATURE: 10.113				
5	2.237	35.539	13.922	19.540
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 8.94				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 124.42				
AVERAGE TEMPERATURE: 45.651				
SINK TEMPERATURE: 10.113				
6	2.225	35.260	13.948	19.577
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 8.85				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 123.38				
AVERAGE TEMPERATURE: 45.380				
SINK TEMPERATURE: 10.113				
7	2.158	33.570	14.199	19.929
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 8.28				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 117.54				
AVERAGE TEMPERATURE: 43.683				
SINK TEMPERATURE: 10.113				
8	2.235	36.440	13.574	19.051
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 9.25				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 125.51				
AVERAGE TEMPERATURE: 46.553				
SINK TEMPERATURE: 10.113				
9	2.235	34.871	14.170	19.888
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 8.71				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 123.44				
AVERAGE TEMPERATURE: 44.984				
SINK TEMPERATURE: 10.113				

TABLE 28. REDUCED DATA FOR FC-75 AND 11 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 17DEC2350
 THE POWER SETTING PER CHIP WAS: 2.9 W
 THE DISTANCE TO THE FRONT WALL WAS 11 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	2.782	39.181	15.737	22.088
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 10.18				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 160.16				
AVERAGE TEMPERATURE: 49.110				
SINK TEMPERATURE: 9.929				
2	2.773	41.647	14.778	20.742
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 11.08				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 163.75				
AVERAGE TEMPERATURE: 51.577				
SINK TEMPERATURE: 9.929				
3	2.766	40.625	15.105	21.201
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 10.70				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 161.65				
AVERAGE TEMPERATURE: 50.554				
SINK TEMPERATURE: 9.929				
4	2.790	38.896	15.896	22.311
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 10.07				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 160.15				
AVERAGE TEMPERATURE: 48.825				
SINK TEMPERATURE: 9.929				
5	2.853	40.867	15.486	21.736
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 10.79				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 167.12				
AVERAGE TEMPERATURE: 50.797				
SINK TEMPERATURE: 9.929				
6	2.836	40.801	15.421	21.645
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 10.77				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 166.04				
AVERAGE TEMPERATURE: 50.730				
SINK TEMPERATURE: 9.929				
7	2.752	36.637	15.778	22.145
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 9.98				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 157.50				
AVERAGE TEMPERATURE: 48.567				
SINK TEMPERATURE: 9.929				
8	2.849	41.457	15.252	21.408
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 11.01				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 167.93				
AVERAGE TEMPERATURE: 51.387				
SINK TEMPERATURE: 9.929				
9	2.849	40.575	15.577	21.864
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 10.68				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 166.42				
AVERAGE TEMPERATURE: 50.504				
SINK TEMPERATURE: 9.929				

TABLE 29. REDUCED DATA FOR FC-75 AND 7 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 25DEC0115
 THE POWER SETTING PER CHIP WAS: 0.115 W
 THE DISTANCE TO THE FRONT WALL WAS 7 MM, LIQUID WAS FC-75

CHIP	GNET(W)	Tavg-Ts	Nu1	Nu2
1	.113	7.545	3.257	4.572
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.41				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.60				
AVERAGE TEMPERATURE: 17.564				
SINK TEMPERATURE: 10.019				
2	.113	7.656	3.202	4.495
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.43				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.59				
AVERAGE TEMPERATURE: 17.675				
SINK TEMPERATURE: 10.019				
3	.113	7.279	3.361	4.717
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.36				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.56				
AVERAGE TEMPERATURE: 17.298				
SINK TEMPERATURE: 10.019				
4	.114	7.315	3.373	4.735
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.36				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.60				
AVERAGE TEMPERATURE: 17.334				
SINK TEMPERATURE: 10.019				
5	.116	7.527	3.347	4.667
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.41				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.71				
AVERAGE TEMPERATURE: 17.546				
SINK TEMPERATURE: 10.019				
6	.115	7.144	3.504	4.919
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.33				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.66				
AVERAGE TEMPERATURE: 17.163				
SINK TEMPERATURE: 10.019				
7	.112	6.895	3.519	4.939
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.28				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.50				
AVERAGE TEMPERATURE: 16.914				
SINK TEMPERATURE: 10.019				
8	.116	7.497	3.349	4.701
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.40				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.69				
AVERAGE TEMPERATURE: 17.516				
SINK TEMPERATURE: 10.019				
9	.115	7.299	3.437	4.824
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.36				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 4.66				
AVERAGE TEMPERATURE: 17.318				
SINK TEMPERATURE: 10.019				

TABLE 30. REDUCED DATA FOR FC-75 AND 7 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 25DEC7340
 THE POWER SETTING PER CHIP WAS: 0.34 W
 THE DISTANCE TO THE FRONT WALL WAS 7 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	.330	11.877	6.059	8.505
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 2.33				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.10				
AVERAGE TEMPERATURE: 21.848				
SINK TEMPERATURE: 9.971				
2	.329	11.943	6.005	8.429
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 2.34				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.06				
AVERAGE TEMPERATURE: 21.914				
SINK TEMPERATURE: 9.971				
3	.328	11.302	6.330	8.685
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 2.20				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.93				
AVERAGE TEMPERATURE: 21.273				
SINK TEMPERATURE: 9.971				
4	.331	11.525	6.263	8.791
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 2.25				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.09				
AVERAGE TEMPERATURE: 21.496				
SINK TEMPERATURE: 9.971				
5	.339	11.807	6.247	8.768
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 2.31				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.44				
AVERAGE TEMPERATURE: 21.776				
SINK TEMPERATURE: 9.971				
6	.337	11.335	6.466	9.076
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 2.21				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.27				
AVERAGE TEMPERATURE: 21.306				
SINK TEMPERATURE: 9.971				
7	.326	11.237	6.318	8.868
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 2.19				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.81				
AVERAGE TEMPERATURE: 21.208				
SINK TEMPERATURE: 9.971				
8	.333	11.705	6.292	8.831
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 2.29				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.40				
AVERAGE TEMPERATURE: 21.676				
SINK TEMPERATURE: 9.971				
9	.338	11.395	6.464	9.073
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 2.22				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.35				
AVERAGE TEMPERATURE: 21.366				
SINK TEMPERATURE: 9.971				

TABLE 31. REDUCED DATA FOR FC-75 AND 7 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 26DEC02300
 THE POWER SETTING PER CHIP WAS: 0.8 W
 THE DISTANCE TO THE FRONT WALL WAS 7 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	.766	19.503	8.601	12.072
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.15				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 35.68				
AVERAGE TEMPERATURE: 29.483				
SINK TEMPERATURE: 9.980				
2	.764	19.817	8.440	11.846
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.23				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 35.69				
AVERAGE TEMPERATURE: 29.797				
SINK TEMPERATURE: 9.980				
3	.762	19.432	8.583	12.047
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.13				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 35.45				
AVERAGE TEMPERATURE: 29.412				
SINK TEMPERATURE: 9.980				
4	.768	18.750	8.966	12.584
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.96				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 35.47				
AVERAGE TEMPERATURE: 28.731				
SINK TEMPERATURE: 9.980				
5	.785	19.711	8.720	12.240
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.20				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 36.64				
AVERAGE TEMPERATURE: 29.691				
SINK TEMPERATURE: 9.980				
6	.780	19.011	8.983	12.608
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.02				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 36.13				
AVERAGE TEMPERATURE: 28.991				
SINK TEMPERATURE: 9.980				
7	.756	18.316	9.034	12.680
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.85				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 34.75				
AVERAGE TEMPERATURE: 28.296				
SINK TEMPERATURE: 9.980				
8	.764	19.308	8.867	12.473
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.10				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 36.42				
AVERAGE TEMPERATURE: 29.288				
SINK TEMPERATURE: 9.980				
9	.784	18.722	9.162	12.859
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.95				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 36.18				
AVERAGE TEMPERATURE: 28.702				
SINK TEMPERATURE: 9.980				

TABLE 32. REDUCED DATA FOR FC-75 AND 7 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 26DEC1625
 THE POWER SETTING PER CHIP WAS: 1.3 W
 THE DISTANCE TO THE FRONT WALL WAS 7 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	NU1	NU2
1	1.243	26.970	10.142	14.235
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.23				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 63.17				
AVERAGE TEMPERATURE: 37.156				
SINK TEMPERATURE: 10.187				
2	1.239	27.642	9.867	13.849
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.43				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 63.43				
AVERAGE TEMPERATURE: 37.829				
SINK TEMPERATURE: 10.187				
3	1.237	26.655	10.207	14.326
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.14				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 62.63				
AVERAGE TEMPERATURE: 36.842				
SINK TEMPERATURE: 10.187				
4	1.248	25.693	10.681	14.991
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 5.86				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 62.55				
AVERAGE TEMPERATURE: 35.880				
SINK TEMPERATURE: 10.187				
5	1.276	27.544	10.195	14.310
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.40				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 65.24				
AVERAGE TEMPERATURE: 37.731				
SINK TEMPERATURE: 10.187				
6	1.268	26.657	10.465	14.668
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.14				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 64.22				
AVERAGE TEMPERATURE: 36.844				
SINK TEMPERATURE: 10.187				
7	1.229	24.717	10.924	15.333
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 5.58				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 60.92				
AVERAGE TEMPERATURE: 34.903				
SINK TEMPERATURE: 10.187				
8	1.274	27.000	10.378	14.566
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 6.24				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 64.73				
AVERAGE TEMPERATURE: 37.187				
SINK TEMPERATURE: 10.187				
9	1.274	25.833	10.840	15.214
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 5.90				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 63.92				
AVERAGE TEMPERATURE: 36.020				
SINK TEMPERATURE: 10.167				

TABLE 33. REDUCED DATA FOR FC-75 AND 7 MM SPACING

THE RAW EXF DATA ARE FROM THE FILE: 270EC2400
 THE POWER SETTING PER CHIP WAS: 1.7 W
 THE DISTANCE TO THE FRONT WALL WAS 7 MM, LIQUID WAS FC-75

CHIP	ONET(W)	Tavg-Ts	Nu1	Nu2
1	1.638	32.918	10.987	15.421
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 8.02				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 88.15				
AVERAGE TEMPERATURE: 42.777				
SINK TEMPERATURE: 9.859				
2	1.633	33.946	10.628	14.917
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 8.36				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 86.85				
AVERAGE TEMPERATURE: 43.805				
SINK TEMPERATURE: 9.859				
3	1.630	32.853	10.949	15.368
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 8.00				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 87.62				
AVERAGE TEMPERATURE: 42.712				
SINK TEMPERATURE: 9.859				
4	1.645	31.233	11.610	16.296
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.48				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 86.89				
AVERAGE TEMPERATURE: 41.032				
SINK TEMPERATURE: 9.859				
5	1.662	33.726	11.011	15.454
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 8.29				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 91.25				
AVERAGE TEMPERATURE: 43.586				
SINK TEMPERATURE: 9.659				
6	1.672	31.766	11.613	16.299
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.65				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 88.87				
AVERAGE TEMPERATURE: 41.626				
SINK TEMPERATURE: 9.859				
7	1.622	29.756	12.009	16.856
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.02				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 84.35				
AVERAGE TEMPERATURE: 39.615				
SINK TEMPERATURE: 9.859				
8	1.680	33.198	11.172	15.680
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 8.11				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 90.65				
AVERAGE TEMPERATURE: 43.058				
SINK TEMPERATURE: 9.859				
9	1.680	32.325	11.467	16.095
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 7.83				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 89.81				
AVERAGE TEMPERATURE: 42.164				
SINK TEMPERATURE: 9.859				

TABLE 34. REDUCED DATA FOR FC-75 AND 7 MM SPACING

THE RAW E-MF DATA ARE FROM THE FILE: 27DEC2330
 THE POWER SETTING PER CHIP WAS: 2.25 W
 THE DISTANCE TO THE FRONT WALL WAS 7 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	2.158	38.828	12.319	17.290
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 10.07				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 124.03				
AVERAGE TEMPERATURE: 48.847				
SINK TEMPERATURE: 10.019				
2	2.151	41.212	11.562	16.256
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 10.94				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 126.68				
AVERAGE TEMPERATURE: 51.231				
SINK TEMPERATURE: 10.019				
3	2.146	39.767	11.966	16.795
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 10.41				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 124.53				
AVERAGE TEMPERATURE: 49.786				
SINK TEMPERATURE: 10.019				
4	2.165	37.422	12.807	17.976
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 9.57				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 122.57				
AVERAGE TEMPERATURE: 47.441				
SINK TEMPERATURE: 10.019				
5	2.212	41.430	11.852	16.635
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 11.02				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 130.60				
AVERAGE TEMPERATURE: 51.449				
SINK TEMPERATURE: 10.019				
6	2.198	39.311	12.394	17.397
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 10.24				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 126.94				
AVERAGE TEMPERATURE: 49.330				
SINK TEMPERATURE: 10.019				
7	2.132	36.728	12.844	18.028
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 9.33				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 119.82				
AVERAGE TEMPERATURE: 46.747				
SINK TEMPERATURE: 10.019				
8	2.207	39.949	12.251	17.196
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 10.47				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 128.31				
AVERAGE TEMPERATURE: 49.968				
SINK TEMPERATURE: 10.019				
9	2.206	39.768	12.302	17.267
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 10.41				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 128.04				
AVERAGE TEMPERATURE: 49.787				
SINK TEMPERATURE: 10.019				

TABLE 35. REDUCED DATA FOR FC-75 AND 7 MM SPACING

THE RAW Emf DATA ARE FROM THE FILE: 280ECC315
 THE POWER SETTING PER CHIP WAS: 2.6 W
 THE DISTANCE TO THE FRONT WALL WAS 7 MM, LIQUID WAS FC-75

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	2.769	46.198	13.345	18.730
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 12.87				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 171.74				
AVERAGE TEMPERATURE: 56.244				
SINK TEMPERATURE: 10.046				
2	2.760	49.792	12.367	17.358
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 14.35				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 177.45				
AVERAGE TEMPERATURE: 59.838				
SINK TEMPERATURE: 10.046				
3	2.754	47.550	12.907	18.115
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 13.42				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 173.17				
AVERAGE TEMPERATURE: 57.595				
SINK TEMPERATURE: 10.046				
4	2.780	44.626	13.855	19.447
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 12.25				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 169.68				
AVERAGE TEMPERATURE: 54.672				
SINK TEMPERATURE: 10.046				
5	2.841	49.097	12.909	18.118
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 14.06				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 181.45				
AVERAGE TEMPERATURE: 59.143				
SINK TEMPERATURE: 10.046				
6	2.824	47.801	13.168	18.482
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 13.52				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 178.02				
AVERAGE TEMPERATURE: 57.847				
SINK TEMPERATURE: 10.046				
7	2.740	43.728	13.931	19.553
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 11.90				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 165.74				
AVERAGE TEMPERATURE: 53.774				
SINK TEMPERATURE: 10.046				
8	2.837	47.208	13.387	18.790
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 13.28				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 177.74				
AVERAGE TEMPERATURE: 57.254				
SINK TEMPERATURE: 10.046				
9	2.838	46.856	13.476	18.917
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 13.15				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 177.24				
AVERAGE TEMPERATURE: 55.942				
SINK TEMPERATURE: 10.046				

TABLE 36. REDUCED DATA FOR FC-43 AND 42 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 12JAN1630
 THE POWER SETTING PER CHIP WAS: 0.34 W
 THE DISTANCE TO THE FRONT WALL WAS 42 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	.328	10.670	6.423	9.016
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .43				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.74				
AVERAGE TEMPERATURE: 20.575				
SINK TEMPERATURE: 9.906				
2	.327	11.056	6.187	8.683
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .45				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.76				
AVERAGE TEMPERATURE: 20.962				
SINK TEMPERATURE: 9.906				
3	.326	11.416	5.972	8.382
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .46				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.78				
AVERAGE TEMPERATURE: 21.322				
SINK TEMPERATURE: 9.906				
4	.329	10.629	6.475	9.088
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .43				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.75				
AVERAGE TEMPERATURE: 20.535				
SINK TEMPERATURE: 9.906				
5	.336	10.982	6.398	8.980
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .44				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.83				
AVERAGE TEMPERATURE: 20.886				
SINK TEMPERATURE: 9.906				
6	.335	11.404	6.135	8.611
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .46				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.85				
AVERAGE TEMPERATURE: 21.310				
SINK TEMPERATURE: 9.906				
7	.324	10.438	6.497	9.120
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .42				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.70				
AVERAGE TEMPERATURE: 20.343				
SINK TEMPERATURE: 9.906				
8	.336	11.041	6.368	8.937
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .45				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.84				
AVERAGE TEMPERATURE: 20.946				
SINK TEMPERATURE: 9.906				
9	.335	11.395	6.153	8.636
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .46				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.85				
AVERAGE TEMPERATURE: 21.300				
SINK TEMPERATURE: 9.926				

TABLE 37. REDUCED DATA FOR FC-43 AND 42 MM SPACING

THE RAW Emf DATA ARE FROM THE FILE: 12JAN2045
 THE POWER SETTING PER CHIP WAS: 0.8 W
 THE DISTANCE TO THE FRONT WALL WAS 42 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	.770	17.833	9.126	12.612
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .83				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 7.54				
AVERAGE TEMPERATURE: 27.823				
SINK TEMPERATURE: 10.190				
2	.766	17.886	8.981	12.605
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .64				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 7.57				
AVERAGE TEMPERATURE: 28.078				
SINK TEMPERATURE: 10.190				
3	.766	18.134	8.831	12.395
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .86				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 7.58				
AVERAGE TEMPERATURE: 28.324				
SINK TEMPERATURE: 10.190				
4	.773	17.555	9.211	12.929
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .82				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 7.57				
AVERAGE TEMPERATURE: 27.745				
SINK TEMPERATURE: 10.190				
5	.790	17.946	9.201	12.914
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .65				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 7.79				
AVERAGE TEMPERATURE: 28.136				
SINK TEMPERATURE: 10.190				
6	.785	18.448	8.911	12.507
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .66				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 7.83				
AVERAGE TEMPERATURE: 28.236				
SINK TEMPERATURE: 10.190				
7	.762	17.617	9.049	12.701
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .83				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 7.47				
AVERAGE TEMPERATURE: 27.807				
SINK TEMPERATURE: 10.190				
8	.789	18.063	9.141	12.830
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .65				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 7.81				
AVERAGE TEMPERATURE: 28.253				
SINK TEMPERATURE: 10.190				
9	.787	18.262	8.999	12.630
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .67				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 7.81				
AVERAGE TEMPERATURE: 28.472				
SINK TEMPERATURE: 10.190				

TABLE 38. REDUCED DATA FOR FC-43 AND 42 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 13JAN0045
 THE POWER SETTING PER CHIP WAS: 1.3 W
 THE DISTANCE TO THE FRONT WALL WAS 42 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	ONET(W)	Tavo-Ts	Nu1	Nu2
1	1.244	24.192	10.760	15.102
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: 1.28				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 13.77				
AVERAGE TEMPERATURE: 34.253				
SINK TEMPERATURE: 10.061				
2	1.242	23.891	10.876	15.265
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: 1.26				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 13.67				
AVERAGE TEMPERATURE: 33.951				
SINK TEMPERATURE: 10.061				
3	1.237	23.690	10.926	15.336
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: 1.24				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 13.56				
AVERAGE TEMPERATURE: 33.751				
SINK TEMPERATURE: 10.061				
4	1.249	24.051	10.867	15.253
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: 1.27				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 13.79				
AVERAGE TEMPERATURE: 34.112				
SINK TEMPERATURE: 10.061				
5	1.276	24.048	11.101	15.580
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: 1.27				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 14.08				
AVERAGE TEMPERATURE: 34.109				
SINK TEMPERATURE: 10.061				
6	1.271	24.360	10.920	15.326
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: 1.29				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 14.11				
AVERAGE TEMPERATURE: 34.421				
SINK TEMPERATURE: 10.061				
7	1.234	24.114	10.704	15.024
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: 1.27				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 13.63				
AVERAGE TEMPERATURE: 34.175				
SINK TEMPERATURE: 10.061				
8	1.278	24.099	11.099	15.578
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: 1.27				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 14.12				
AVERAGE TEMPERATURE: 34.160				
SINK TEMPERATURE: 10.061				
9	1.276	23.930	11.154	15.656
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: 1.26				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 14.05				
AVERAGE TEMPERATURE: 33.990				
SINK TEMPERATURE: 10.061				

TABLE 39. REDUCED DATA FOR FC-43 AND 42 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 13JAN1525
 THE POWER SETTING PER CHIP WAS: 1.7 W
 THE DISTANCE TO THE FRONT WALL WAS 42 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	1.647	29.363	11.744	16.483
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.71				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 20.07				
AVERAGE TEMPERATURE: 39.521				
SINK TEMPERATURE: 10.158				
2	1.644	28.591	12.036	16.694
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.64				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 19.76				
AVERAGE TEMPERATURE: 38.749				
SINK TEMPERATURE: 10.158				
3	1.637	28.463	12.040	16.899
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.63				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 19.64				
AVERAGE TEMPERATURE: 38.621				
SINK TEMPERATURE: 10.158				
4	1.653	29.221	11.838	16.616
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.70				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 20.09				
AVERAGE TEMPERATURE: 39.379				
SINK TEMPERATURE: 10.158				
5	1.689	29.288	12.070	16.941
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.70				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 20.55				
AVERAGE TEMPERATURE: 39.447				
SINK TEMPERATURE: 10.158				
6	1.681	29.023	12.121	17.013
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.68				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 20.36				
AVERAGE TEMPERATURE: 39.182				
SINK TEMPERATURE: 10.158				
7	1.629	29.298	11.638	16.335
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.70				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 19.82				
AVERAGE TEMPERATURE: 39.457				
SINK TEMPERATURE: 10.158				
8	1.688	29.002	12.182	17.098
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.68				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 20.44				
AVERAGE TEMPERATURE: 39.161				
SINK TEMPERATURE: 10.158				
9	1.682	28.653	12.290	17.249
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.65				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 20.24				
AVERAGE TEMPERATURE: 38.811				
SINK TEMPERATURE: 10.158				

TABLE 40. REDUCED DATA FOR FC-43 AND 42 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 13JAN2000
 THE POWER SETTING PER CHIP WAS: 2.25 W
 THE DISTANCE TO THE FRONT WALL WAS 42 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	2.171	35.295	12.879	18.077
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.27				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 29.22				
AVERAGE TEMPERATURE: 45.443				
SINK TEMPERATURE: 10.146				
2	2.166	34.130	13.291	18.654
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.15				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 28.61				
AVERAGE TEMPERATURE: 44.278				
SINK TEMPERATURE: 10.148				
3	2.158	33.840	13.353	18.742
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.12				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 28.36				
AVERAGE TEMPERATURE: 43.988				
SINK TEMPERATURE: 10.148				
4	2.179	35.222	12.952	18.180
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.26				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 29.29				
AVERAGE TEMPERATURE: 45.371				
SINK TEMPERATURE: 10.148				
5	2.227	34.581	13.483	18.525
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.20				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 29.62				
AVERAGE TEMPERATURE: 44.729				
SINK TEMPERATURE: 10.148				
6	2.216	34.661	13.395	18.786
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.21				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 29.51				
AVERAGE TEMPERATURE: 44.809				
SINK TEMPERATURE: 10.148				
7	2.149	35.275	12.756	17.904
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.27				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 28.91				
AVERAGE TEMPERATURE: 45.423				
SINK TEMPERATURE: 10.146				
8	2.226	34.673	13.442	18.867
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.21				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 29.66				
AVERAGE TEMPERATURE: 44.822				
SINK TEMPERATURE: 10.148				
9	2.220	34.389	13.516	18.970
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.18				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 29.44				
AVERAGE TEMPERATURE: 44.537				
SINK TEMPERATURE: 10.148				

TABLE 41. REDUCED DATA FOR FC-43 AND 42 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 13JAN2400
 THE POWER SETTING PER CHIP WAS: 2.5 W
 THE DISTANCE TO THE FRONT WALL WAS 42 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	T _{avo} -T _s	Nu1	Nu2
1	2.776	41.936	13.866	19.462
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.98				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 41.34				
AVERAGE TEMPERATURE: 51.921				
SINK TEMPERATURE: 9.985				
2	2.769	40.225	14.421	20.241
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.78				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 40.15				
AVERAGE TEMPERATURE: 50.210				
SINK TEMPERATURE: 9.985				
3	2.759	39.794	14.521	20.382
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.74				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 39.72				
AVERAGE TEMPERATURE: 49.779				
SINK TEMPERATURE: 9.985				
4	2.786	41.715	13.990	19.636
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.96				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 41.34				
AVERAGE TEMPERATURE: 51.700				
SINK TEMPERATURE: 9.985				
5	2.846	40.234	14.818	20.799
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.78				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 41.27				
AVERAGE TEMPERATURE: 50.219				
SINK TEMPERATURE: 9.985				
6	2.831	41.088	14.436	20.262
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.88				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 41.61				
AVERAGE TEMPERATURE: 51.073				
SINK TEMPERATURE: 9.985				
7	2.747	41.657	13.815	19.390
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.95				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 40.73				
AVERAGE TEMPERATURE: 51.642				
SINK TEMPERATURE: 9.985				
8	2.844	40.817	14.597	20.468
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.85				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 41.62				
AVERAGE TEMPERATURE: 50.802				
SINK TEMPERATURE: 9.985				
9	2.836	40.465	14.682	20.607
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.81				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 41.27				
AVERAGE TEMPERATURE: 50.450				
SINK TEMPERATURE: 9.985				

TABLE 42. REDUCED DATA FOR FC-43 AND 30 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 16JAN0200
 THE POWER SETTING PER CHIP WAS: 0.115 W
 THE DISTANCE TO THE FRONT WALL WAS 30 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	.113	6.807	3.461	4.857
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .25				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .85				
AVERAGE TEMPERATURE: 17.001				
SINK TEMPERATURE: 10.193				
2	.113	7.023	3.350	4.702
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .26				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .86				
AVERAGE TEMPERATURE: 17.217				
SINK TEMPERATURE: 10.193				
3	.112	7.232	3.242	4.551
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .27				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .86				
AVERAGE TEMPERATURE: 17.425				
SINK TEMPERATURE: 10.193				
4	.113	6.762	3.497	4.908
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .25				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .86				
AVERAGE TEMPERATURE: 16.955				
SINK TEMPERATURE: 10.193				
5	.116	6.970	3.463	4.961
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .26				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .90				
AVERAGE TEMPERATURE: 17.163				
SINK TEMPERATURE: 10.193				
6	.115	7.228	3.324	4.665
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .27				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .90				
AVERAGE TEMPERATURE: 17.421				
SINK TEMPERATURE: 10.193				
7	.112	6.919	3.372	4.733
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .26				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .87				
AVERAGE TEMPERATURE: 17.112				
SINK TEMPERATURE: 10.193				
8	.116	7.104	3.404	4.777
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .27				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .91				
AVERAGE TEMPERATURE: 17.297				
SINK TEMPERATURE: 10.193				
9	.115	7.299	3.303	4.635
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .27				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .91				
AVERAGE TEMPERATURE: 17.492				
SINK TEMPERATURE: 10.193				

TABLE 43. REDUCED DATA FOR FC-43 AND 30 MM SPACING

THE RAW EMT DATA ARE FROM THE FILE: 14JAN1800
 THE POWER SETTING PER CHIP WAS: 0.34 W
 THE DISTANCE TO THE FRONT WALL WAS 30 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	ONET(W)	Tavg-Ts	Nu1	Nu2
1	.329	11.446	5.996	8.416
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .47				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.79				
AVERAGE TEMPERATURE: 21.331				
SINK TEMPERATURE: 9.885				
2	.328	11.612	5.797	8.137
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .48				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.81				
AVERAGE TEMPERATURE: 21.698				
SINK TEMPERATURE: 9.885				
3	.326	12.181	5.601	7.861
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .50				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.62				
AVERAGE TEMPERATURE: 22.066				
SINK TEMPERATURE: 9.885				
4	.330	11.421	6.037	8.474
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .46				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.80				
AVERAGE TEMPERATURE: 21.306				
SINK TEMPERATURE: 9.885				
5	.337	11.798	5.973	8.363
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .48				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.89				
AVERAGE TEMPERATURE: 21.684				
SINK TEMPERATURE: 9.885				
6	.336	12.231	5.735	8.050
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .51				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.90				
AVERAGE TEMPERATURE: 22.117				
SINK TEMPERATURE: 9.885				
7	.326	11.604	5.866	8.234
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .47				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.78				
AVERAGE TEMPERATURE: 21.489				
SINK TEMPERATURE: 9.885				
8	.337	11.864	5.946	8.346
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .49				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.90				
AVERAGE TEMPERATURE: 21.749				
SINK TEMPERATURE: 9.885				
9	.336	12.175	5.773	8.103
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .50				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.91				
AVERAGE TEMPERATURE: 22.061				
SINK TEMPERATURE: 9.885				

TABLE 44. REDUCED DATA FOR FC-43 AND 30 MM SPACING

THE RAW EFF DATA ARE FROM THE FILE: 14JAN2300
 THE POWER SETTING PER CHIP WAS: 0.8 W
 THE DISTANCE TO THE FRONT WALL WAS 30 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	T _{avo} -T _s	Nu1	Nu2
1	.771	18.747	8.601	12.072
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: .89				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 7.65				
AVERAGE TEMPERATURE: 28.689				
SINK TEMPERATURE: 9.941				
2	.759	18.855	8.532	11.976
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: .90				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 7.65				
AVERAGE TEMPERATURE: 28.737				
SINK TEMPERATURE: 9.941				
3	.766	19.041	8.411	11.806
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: .91				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 7.64				
AVERAGE TEMPERATURE: 28.982				
SINK TEMPERATURE: 9.941				
4	.773	18.553	8.702	12.214
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: .88				
FLUX BASED RAYLEIGH NUMBER • E-5 IS: 7.65				
AVERAGE TEMPERATURE: 28.524				
SINK TEMPERATURE: 9.941				
5	.790	18.922	8.730	12.253
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: .90				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 7.87				
AVERAGE TEMPERATURE: 28.863				
SINK TEMPERATURE: 9.941				
6	.786	19.351	8.492	11.919
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: .93				
FLUX BASED RAYLEIGH NUMBER • E-5 IS: 7.85				
AVERAGE TEMPERATURE: 29.293				
SINK TEMPERATURE: 9.941				
7	.762	18.823	8.458	11.885
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: .89				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 7.57				
AVERAGE TEMPERATURE: 28.764				
SINK TEMPERATURE: 9.941				
8	.790	19.003	8.696	12.205
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: .91				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 7.88				
AVERAGE TEMPERATURE: 28.944				
SINK TEMPERATURE: 9.941				
9	.787	19.211	8.572	12.032
TEMP.BASED RAYLEIGH NUMBER • E-6 IS: .92				
FLUX BASED RAYLEIGH NUMBER • E-6 IS: 7.89				
AVERAGE TEMPERATURE: 29.152				
SINK TEMPERATURE: 9.941				

TABLE 45. REDUCED DATA FOR FC-43 AND 30 MM SPACING

THE RAW Emf DATA ARE FROM THE FILE: 15JAN0140
 THE POWER SETTING PER CHIP WAS: 1.3 W
 THE DISTANCE TO THE FRONT WALL WAS 30 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	1.240	25.912	10.013	14.053
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.40				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.06				
AVERAGE TEMPERATURE: 35.775				
SINK TEMPERATURE: 9.863				
2	1.236	25.479	10.153	14.251
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.37				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.91				
AVERAGE TEMPERATURE: 35.342				
SINK TEMPERATURE: 9.863				
3	1.231	25.593	10.057	14.130
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.38				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.88				
AVERAGE TEMPERATURE: 35.456				
SINK TEMPERATURE: 9.863				
4	1.242	25.757	10.093	14.166
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.39				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.05				
AVERAGE TEMPERATURE: 35.620				
SINK TEMPERATURE: 9.863				
5	1.269	25.748	10.315	14.478
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.39				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.35				
AVERAGE TEMPERATURE: 35.611				
SINK TEMPERATURE: 9.863				
6	1.263	25.847	10.226	14.353
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.40				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.30				
AVERAGE TEMPERATURE: 35.710				
SINK TEMPERATURE: 9.863				
7	1.224	26.064	9.826	13.792
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.42				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 13.92				
AVERAGE TEMPERATURE: 35.927				
SINK TEMPERATURE: 9.863				
8	1.268	25.847	10.268	14.412
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.40				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.36				
AVERAGE TEMPERATURE: 35.710				
SINK TEMPERATURE: 9.863				
9	1.265	25.777	10.267	14.410
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.39				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.30				
AVERAGE TEMPERATURE: 35.639				
SINK TEMPERATURE: 9.863				

TABLE 46. REDUCED DATA FOR FC-43 AND 30 MM SPACING

THE RAW Emf DATA ARE FROM THE FILE: 15JAN1E10
 THE POWER SETTING PER CHIP WAS: 1.7 W
 THE DISTANCE TO THE FRONT WALL WAS 30 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	1.643	31.237	11.013	15.458
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.87				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 20.64				
AVERAGE TEMPERATURE: 41.347				
SINK TEMPERATURE: 10.111				
2	1.640	30.352	11.313	15.879
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.79				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 20.30				
AVERAGE TEMPERATURE: 40.462				
SINK TEMPERATURE: 10.111				
3	1.634	30.346	11.274	15.824
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.79				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 20.22				
AVERAGE TEMPERATURE: 40.457				
SINK TEMPERATURE: 10.111				
4	1.650	31.030	11.134	15.627
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.86				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 20.66				
AVERAGE TEMPERATURE: 41.141				
SINK TEMPERATURE: 10.111				
5	1.687	30.786	11.469	16.097
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.83				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 21.03				
AVERAGE TEMPERATURE: 40.897				
SINK TEMPERATURE: 10.111				
6	1.679	30.558	11.498	16.139
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.81				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 20.84				
AVERAGE TEMPERATURE: 40.668				
SINK TEMPERATURE: 10.111				
7	1.628	31.065	10.968	15.395
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.86				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 20.39				
AVERAGE TEMPERATURE: 41.175				
SINK TEMPERATURE: 10.111				
8	1.687	30.788	11.467	16.095
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.83				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 21.02				
AVERAGE TEMPERATURE: 40.898				
SINK TEMPERATURE: 10.111				
9	1.662	30.617	11.501	16.142
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.82				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 20.91				
AVERAGE TEMPERATURE: 40.727				
SINK TEMPERATURE: 10.111				

TABLE 47. REDUCED DATA FOR FC-43 AND 30 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 15JAN1850
 THE POWER SETTING PER CHIP WAS: 2.25 W
 THE DISTANCE TO THE FRONT WALL WAS 30 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	2.166	37.634	12.048	16.910
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.50				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 30.10				
AVERAGE TEMPERATURE: 47.604				
SINK TEMPERATURE: 9.970				
2	2.150	36.317	12.458	17.485
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.36				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 29.40				
AVERAGE TEMPERATURE: 46.287				
SINK TEMPERATURE: 9.970				
3	2.153	36.345	12.404	17.410
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.36				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 29.31				
AVERAGE TEMPERATURE: 46.315				
SINK TEMPERATURE: 9.970				
4	2.174	37.491	12.144	17.045
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.48				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 30.15				
AVERAGE TEMPERATURE: 47.461				
SINK TEMPERATURE: 9.970				
5	2.221	35.748	12.655	17.763
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.40				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 30.43				
AVERAGE TEMPERATURE: 46.717				
SINK TEMPERATURE: 9.970				
6	2.209	36.634	12.627	17.723
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.39				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 30.21				
AVERAGE TEMPERATURE: 46.604				
SINK TEMPERATURE: 9.970				
7	2.142	37.333	12.016	16.865
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.47				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 29.63				
AVERAGE TEMPERATURE: 47.302				
SINK TEMPERATURE: 9.970				
8	2.218	36.983	12.561	17.631
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.43				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 30.51				
AVERAGE TEMPERATURE: 46.952				
SINK TEMPERATURE: 9.970				
9	2.211	36.723	12.611	17.700
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.40				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 30.29				
AVERAGE TEMPERATURE: 46.693				
SINK TEMPERATURE: 9.970				

TABLE 48. REDUCED DATA FOR FC-43 AND 30 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 'SJAN2300
 THE POWER SETTING PER CHIP WAS: 2.9 W
 THE DISTANCE TO THE FRONT WALL WAS 30 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	2.770	43.939	13.208	18.539
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.23				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 42.63				
AVERAGE TEMPERATURE: 53.973				
SINK TEMPERATURE: 10.034				
2	2.763	42.359	13.668	19.165
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.04				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 41.49				
AVERAGE TEMPERATURE: 52.393				
SINK TEMPERATURE: 10.034				
3	2.753	42.274	13.646	19.154
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.03				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 41.29				
AVERAGE TEMPERATURE: 52.307				
SINK TEMPERATURE: 10.034				
4	2.781	43.700	13.334	18.715
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.20				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 42.64				
AVERAGE TEMPERATURE: 53.733				
SINK TEMPERATURE: 10.034				
5	2.841	42.746	13.927	19.546
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.08				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 42.93				
AVERAGE TEMPERATURE: 52.780				
SINK TEMPERATURE: 10.034				
6	2.828	42.465	13.951	19.561
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.05				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 42.53				
AVERAGE TEMPERATURE: 52.499				
SINK TEMPERATURE: 10.034				
7	2.743	43.800	13.124	18.421
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.21				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 42.13				
AVERAGE TEMPERATURE: 53.833				
SINK TEMPERATURE: 10.034				
8	2.841	42.987	13.846	19.433
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.11				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 43.07				
AVERAGE TEMPERATURE: 53.021				
SINK TEMPERATURE: 10.034				
9	2.832	42.886	13.835	19.419
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.10				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 42.88				
AVERAGE TEMPERATURE: 52.922				
SINK TEMPERATURE: 10.034				

TABLE 49. REDUCED DATA FOR FC-43 AND 18 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 17JAN1350
 THE POWER SETTING PER CHIP WAS: 0.115 W
 THE DISTANCE TO THE FRONT WALL WAS 18 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	NU1	NU2
1	.113	7.632	3.086	4.331
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .29				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .88				
AVERAGE TEMPERATURE: 17.551				
SINK TEMPERATURE: 9.919				
2	.113	7.614	3.010	4.225
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .29				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .88				
AVERAGE TEMPERATURE: 17.733				
SINK TEMPERATURE: 9.919				
3	.112	7.927	2.956	4.149
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .30				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .88				
AVERAGE TEMPERATURE: 17.846				
SINK TEMPERATURE: 9.919				
4	.113	7.556	3.131	4.395
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .28				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .86				
AVERAGE TEMPERATURE: 17.477				
SINK TEMPERATURE: 9.919				
5	.116	7.757	3.116	4.374
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .29				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .91				
AVERAGE TEMPERATURE: 17.676				
SINK TEMPERATURE: 9.919				
6	.115	7.902	3.046	4.276
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .30				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .91				
AVERAGE TEMPERATURE: 17.822				
SINK TEMPERATURE: 9.919				
7	.112	7.151	3.253	4.580
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .27				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .86				
AVERAGE TEMPERATURE: 17.071				
SINK TEMPERATURE: 9.919				
8	.116	7.932	3.045	4.274
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .30				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .91				
AVERAGE TEMPERATURE: 17.851				
SINK TEMPERATURE: 9.919				
9	.115	7.997	3.010	4.225
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .30				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .91				
AVERAGE TEMPERATURE: 17.917				
SINK TEMPERATURE: 9.919				

TABLE 50. REDUCED DATA FOR FC-43 AND 18 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 17JAN1750
 THE POWER SETTING PER CHIP WAS: 0.34 W
 THE DISTANCE TO THE FRONT WALL WAS 18 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	.326	12.894	5.403	7.584
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .53				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.88				
AVERAGE TEMPERATURE: 22.700				
SINK TEMPERATURE: 10.006				
2	.327	13.005	5.261	7.385
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .55				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.59				
AVERAGE TEMPERATURE: 23.012				
SINK TEMPERATURE: 10.006				
3	.326	13.359	5.105	7.166
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .57				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.91				
AVERAGE TEMPERATURE: 23.368				
SINK TEMPERATURE: 10.006				
4	.330	12.616	5.463	7.667
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .53				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.89				
AVERAGE TEMPERATURE: 22.623				
SINK TEMPERATURE: 10.005				
5	.337	12.965	5.418	7.605
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .55				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.97				
AVERAGE TEMPERATURE: 22.992				
SINK TEMPERATURE: 10.006				
6	.335	13.401	5.225	7.334
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .57				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.99				
AVERAGE TEMPERATURE: 23.408				
SINK TEMPERATURE: 10.006				
7	.325	12.613	5.383	7.556
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .53				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.85				
AVERAGE TEMPERATURE: 22.619				
SINK TEMPERATURE: 10.006				
8	.336	13.033	5.396	7.574
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .55				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.98				
AVERAGE TEMPERATURE: 23.040				
SINK TEMPERATURE: 10.006				
9	.335	13.245	5.292	7.428
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .56				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.98				
AVERAGE TEMPERATURE: 23.251				
SINK TEMPERATURE: 10.006				

TABLE 51. REDUCED DATA FOR FC-43 AND 18 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 17JAN2008
 THE POWER SETTING PER CHIP WAS: 0.6 W
 THE DISTANCE TO THE FRONT WALL WAS 18 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	NU1	NU2
1	.784	21.354	7.488	10.510
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.06				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 7.96				
AVERAGE TEMPERATURE: 31.226				
SINK TEMPERATURE: 9.872				
2	.763	21.376	7.462	10.474
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.06				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 7.95				
AVERAGE TEMPERATURE: 31.248				
SINK TEMPERATURE: 9.872				
3	.760	21.551	7.376	10.353
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.06				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 7.94				
AVERAGE TEMPERATURE: 31.420				
SINK TEMPERATURE: 9.872				
4	.767	21.230	7.559	10.605
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.06				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 7.97				
AVERAGE TEMPERATURE: 31.102				
SINK TEMPERATURE: 9.872				
5	.783	21.420	7.645	10.730
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.07				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 8.16				
AVERAGE TEMPERATURE: 31.262				
SINK TEMPERATURE: 9.872				
6	.779	21.670	7.516	10.552
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.09				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 8.16				
AVERAGE TEMPERATURE: 31.542				
SINK TEMPERATURE: 9.872				
7	.755	21.211	7.444	10.448
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.05				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 7.64				
AVERAGE TEMPERATURE: 31.092				
SINK TEMPERATURE: 9.872				
8	.782	21.565	7.586	10.647
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.08				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 8.18				
AVERAGE TEMPERATURE: 31.437				
SINK TEMPERATURE: 9.872				
9	.778	21.727	7.506	10.535
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.09				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 8.17				
AVERAGE TEMPERATURE: 31.595				
SINK TEMPERATURE: 9.872				

TABLE 52. REDUCED DATA FOR FC-43 AND 18 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 18DEC0005
 THE POWER SETTING PER CHIP WAS: 1.34 W
 THE DISTANCE TO THE FRONT WALL WAS 18 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	NU1	NU2
1	1.235	28.569	9.062	12.719
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 1.63				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.77				
AVERAGE TEMPERATURE: 38.536				
SINK TEMPERATURE: 9.949				
2	1.234	28.360	9.108	12.784
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 1.61				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.67				
AVERAGE TEMPERATURE: 38.308				
SINK TEMPERATURE: 9.949				
3	1.230	28.522	9.023	12.665
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 1.62				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.65				
AVERAGE TEMPERATURE: 38.471				
SINK TEMPERATURE: 9.949				
4	1.242	28.510	9.117	12.796
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 1.62				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.60				
AVERAGE TEMPERATURE: 38.456				
SINK TEMPERATURE: 9.949				
5	1.269	28.524	9.309	13.066
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 1.62				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 15.12				
AVERAGE TEMPERATURE: 38.472				
SINK TEMPERATURE: 9.949				
6	1.263	28.620	9.236	12.964
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 1.63				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 15.08				
AVERAGE TEMPERATURE: 38.568				
SINK TEMPERATURE: 9.949				
7	1.225	28.662	8.949	12.560
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 1.64				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 14.64				
AVERAGE TEMPERATURE: 38.610				
SINK TEMPERATURE: 9.949				
8	1.270	28.618	9.265	13.032
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 1.63				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 15.16				
AVERAGE TEMPERATURE: 38.567				
SINK TEMPERATURE: 9.949				
9	1.266	28.494	9.296	13.051
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 1.62				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 15.09				
AVERAGE TEMPERATURE: 38.443				
SINK TEMPERATURE: 9.945				

TABLE 53. REDUCED DATA FOR FC-43 AND 18 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 18JAN1800
 THE POWER SETTINGS PER CHIP WAS: 1.7 W
 THE DISTANCE TO THE FRONT WALL WAS 18 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	1.646	34.004	10.131	14.219
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.13				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 21.53				
AVERAGE TEMPERATURE: 43.942				
SINK TEMPERATURE: 9.919				
2	1.642	33.375	10.303	14.461
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.06				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 21.29				
AVERAGE TEMPERATURE: 43.293				
SINK TEMPERATURE: 9.919				
3	1.636	33.379	10.260	14.401
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.06				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 21.17				
AVERAGE TEMPERATURE: 43.297				
SINK TEMPERATURE: 9.919				
4	1.650	33.926	10.197	14.310
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.12				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 21.58				
AVERAGE TEMPERATURE: 43.845				
SINK TEMPERATURE: 9.919				
5	1.688	33.709	10.454	14.715
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.10				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 21.95				
AVERAGE TEMPERATURE: 43.628				
SINK TEMPERATURE: 9.919				
6	1.679	33.678	10.376	14.563
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.11				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 21.91				
AVERAGE TEMPERATURE: 43.797				
SINK TEMPERATURE: 9.919				
7	1.628	33.691	10.117	14.200
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.09				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 21.18				
AVERAGE TEMPERATURE: 43.610				
SINK TEMPERATURE: 9.919				
8	1.687	33.729	10.473	14.700
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.10				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 21.96				
AVERAGE TEMPERATURE: 43.648				
SINK TEMPERATURE: 9.919				
9	1.683	33.645	10.473	14.699
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.09				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 21.86				
AVERAGE TEMPERATURE: 43.583				
SINK TEMPERATURE: 9.919				

TABLE 54. REDUCED DATA FOR FC-43 AND 18 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 18JAN2240
 THE POWER SETTING PER CHIP WAS: 2.25 W
 THE DISTANCE TO THE FRONT WALL WAS 18 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	T _{avg} -T _s	Nu1	Nu2
1	2.163	40.921	11.072	15.541
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.96				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 31.70				
AVERAGE TEMPERATURE: 50.906				
SINK TEMPERATURE: 9.985				
2	2.158	40.589	11.136	15.630
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.83				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 31.46				
AVERAGE TEMPERATURE: 50.574				
SINK TEMPERATURE: 9.985				
3	2.149	40.875	11.014	15.459
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.86				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 31.48				
AVERAGE TEMPERATURE: 50.860				
SINK TEMPERATURE: 9.985				
4	2.171	40.771	11.153	15.654
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.95				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 31.74				
AVERAGE TEMPERATURE: 50.756				
SINK TEMPERATURE: 9.985				
5	2.217	40.881	11.363	15.948
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.86				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 32.48				
AVERAGE TEMPERATURE: 50.856				
SINK TEMPERATURE: 9.925				
6	2.205	41.163	11.223	15.752
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.89				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 32.45				
AVERAGE TEMPERATURE: 51.148				
SINK TEMPERATURE: 9.985				
7	2.139	40.668	11.019	15.466
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.83				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 31.23				
AVERAGE TEMPERATURE: 50.653				
SINK TEMPERATURE: 9.985				
8	2.216	40.960	11.335	15.909
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.87				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 32.50				
AVERAGE TEMPERATURE: 50.946				
SINK TEMPERATURE: 9.985				
9	2.209	41.152	11.247	15.786
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.89				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 32.50				
AVERAGE TEMPERATURE: 51.137				
SINK TEMPERATURE: 9.985				

TABLE 55. REDUCED DATA FOR FC-43 AND 18 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 21JAN0315
 THE POWER SETTING PER CHIP WAS: 0.9 W
 THE DISTANCE TO THE FRONT WALL WAS 18 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	NU1	NU2
1	2.745	47.753	12.046	16.906
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.69				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 44.45				
AVERAGE TEMPERATURE: 57.929				
SINK TEMPERATURE: 9.765				
2	2.735	47.423	12.103	16.989
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.64				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 44.11				
AVERAGE TEMPERATURE: 57.189				
SINK TEMPERATURE: 9.765				
3	2.728	48.073	11.254	16.694
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.73				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 44.38				
AVERAGE TEMPERATURE: 57.839				
SINK TEMPERATURE: 9.765				
4	2.756	47.612	12.131	17.026
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.67				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 44.52				
AVERAGE TEMPERATURE: 57.378				
SINK TEMPERATURE: 9.765				
5	2.816	47.563	12.304	17.270
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.72				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 45.73				
AVERAGE TEMPERATURE: 57.726				
SINK TEMPERATURE: 9.766				
6	2.801	48.041	12.218	17.149
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.73				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 45.54				
AVERAGE TEMPERATURE: 57.827				
SINK TEMPERATURE: 9.766				
7	2.716	47.165	12.069	16.940
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.61				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 43.58				
AVERAGE TEMPERATURE: 56.931				
SINK TEMPERATURE: 9.766				
8	2.813	48.010	12.281	17.239
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.72				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 45.72				
AVERAGE TEMPERATURE: 57.775				
SINK TEMPERATURE: 9.766				
9	2.806	48.231	12.194	17.115
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.75				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 45.76				
AVERAGE TEMPERATURE: 57.955				
SINK TEMPERATURE: 9.766				

TABLE 56. REDUCED DATA FOR FC-43 AND 11 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 00JAN1900
 THE POWER SETTING PER CHIP WAS: 0.115 W
 THE DISTANCE TO THE FRONT WALL WAS 11 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	.113	8.380	2.823	3.983
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .32				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .90				
AVERAGE TEMPERATURE: 18.330				
SINK TEMPERATURE: 9.965				
2	.113	8.542	2.756	3.869
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .33				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .90				
AVERAGE TEMPERATURE: 18.510				
SINK TEMPERATURE: 9.968				
3	.112	8.355	2.809	3.942
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .32				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .90				
AVERAGE TEMPERATURE: 18.323				
SINK TEMPERATURE: 9.969				
4	.113	8.365	2.861	4.016
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .32				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .90				
AVERAGE TEMPERATURE: 18.353				
SINK TEMPERATURE: 9.963				
5	.116	8.445	2.663	4.018
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .32				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .92				
AVERAGE TEMPERATURE: 18.413				
SINK TEMPERATURE: 9.958				
6	.115	8.648	2.784	3.907
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .33				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .92				
AVERAGE TEMPERATURE: 18.615				
SINK TEMPERATURE: 9.968				
7	.112	8.200	2.846	3.998
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .31				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .89				
AVERAGE TEMPERATURE: 18.170				
SINK TEMPERATURE: 9.958				
8	.116	8.619	2.811	3.946
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .33				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .93				
AVERAGE TEMPERATURE: 18.567				
SINK TEMPERATURE: 9.966				
9	.116	8.439	2.865	4.022
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .32				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .92				
AVERAGE TEMPERATURE: 18.407				
SINK TEMPERATURE: 9.966				

TABLE 57. REDUCED DATA FOR FC-43 AND 11 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 22JAN005
 THE POWER SETTING PER CHIP WAS: 0.34 W
 THE DISTANCE TO THE FRONT WALL WAS 11 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2	
1	.324	13.552	5.004	7.024	
	TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .58				
	FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.68				
	AVERAGE TEMPERATURE: 23.400				
	SINK TEMPERATURE: 9.648				
2	.324	13.779	4.909	6.890	
	TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .59				
	FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.89				
	AVERAGE TEMPERATURE: 23.627				
	SINK TEMPERATURE: 9.848				
3	.322	14.227	4.735	6.645	
	TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .61				
	FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.90				
	AVERAGE TEMPERATURE: 24.074				
	SINK TEMPERATURE: 9.648				
4	.325	13.599	5.002	7.020	
	TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .58				
	FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.69				
	AVERAGE TEMPERATURE: 23.447				
	SINK TEMPERATURE: 9.648				
5	.332	13.899	4.996	7.013	
	TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .60				
	FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.57				
	AVERAGE TEMPERATURE: 23.747				
	SINK TEMPERATURE: 9.848				
6	.330	14.295	4.837	6.789	
	TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .62				
	FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.98				
	AVERAGE TEMPERATURE: 24.133				
	SINK TEMPERATURE: 9.848				
7	.320	13.331	5.021	7.048	
	TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .56				
	FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.83				
	AVERAGE TEMPERATURE: 23.179				
	SINK TEMPERATURE: 9.848				
8	.332	13.920	4.987	7.000	
	TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .60				
	FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.97				
	AVERAGE TEMPERATURE: 23.768				
	SINK TEMPERATURE: 9.848				
9	.331	14.246	4.957	6.817	
	TEMP.BASED RAYLEIGH NUMBER * E-6 IS: .61				
	FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.98				
	AVERAGE TEMPERATURE: 24.096				
	SINK TEMPERATURE: 9.848				

TABLE 58. REDUCED DATA FOR FC-43 AND 11 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 03JAN0200
 THE POWER SETTING PER CHIP WAS: 0.9 W
 THE DISTANCE TO THE FRONT WALL WAS 11 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	.764	21.796	7.326	10.265
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.10				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 8.05				
AVERAGE TEMPERATURE: 31.954				
SINK TEMPERATURE: 10.059				
2	.762	22.507	7.080	9.938
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.15				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 8.17				
AVERAGE TEMPERATURE: 32.565				
SINK TEMPERATURE: 10.058				
3	.759	22.989	6.900	9.554
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.19				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 8.20				
AVERAGE TEMPERATURE: 33.049				
SINK TEMPERATURE: 10.056				
4	.755	21.789	7.344	10.307
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.10				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 8.09				
AVERAGE TEMPERATURE: 31.848				
SINK TEMPERATURE: 10.056				
5	.791	22.300	7.326	10.266
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.14				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 8.34				
AVERAGE TEMPERATURE: 32.359				
SINK TEMPERATURE: 10.058				
6	.777	23.021	7.065	9.916
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.19				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 8.42				
AVERAGE TEMPERATURE: 33.079				
SINK TEMPERATURE: 10.058				
7	.754	21.664	7.277	10.214
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.09				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 7.95				
AVERAGE TEMPERATURE: 31.722				
SINK TEMPERATURE: 10.052				
8	.782	22.264	7.346	10.311
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.14				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 8.34				
AVERAGE TEMPERATURE: 32.323				
SINK TEMPERATURE: 10.058				
9	.730	22.547	7.235	10.155
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.16				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 8.37				
AVERAGE TEMPERATURE: 32.809				
SINK TEMPERATURE: 10.056				

TABLE 59. REDUCED DATA FOR FC-43 AND 11 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 20JAN1950
 THE POWER SETTING PER CHIP WAS: 1.3 W
 THE DISTANCE TO THE FRONT WALL WAS 11 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	1.260	31.053	8.493	11.920
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.64				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 15.83				
AVERAGE TEMPERATURE: 40.866				
SINK TEMPERATURE: 9.833				
2	1.256	31.815	8.267	11.602
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.91				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 15.75				
AVERAGE TEMPERATURE: 41.648				
SINK TEMPERATURE: 9.833				
3	1.262	32.353	8.100	11.369
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.92				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 15.63				
AVERAGE TEMPERATURE: 42.185				
SINK TEMPERATURE: 9.833				
4	1.264	30.362	9.569	12.027
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.82				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 15.63				
AVERAGE TEMPERATURE: 40.715				
SINK TEMPERATURE: 9.833				
5	1.291	31.527	8.490	11.917
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.91				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 16.22				
AVERAGE TEMPERATURE: 41.560				
SINK TEMPERATURE: 9.833				
6	1.284	32.279	8.331	11.653
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.95				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 16.27				
AVERAGE TEMPERATURE: 42.111				
SINK TEMPERATURE: 9.833				
7	1.246	31.014	9.410	11.804
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.84				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 15.44				
AVERAGE TEMPERATURE: 40.847				
SINK TEMPERATURE: 9.833				
8	1.291	31.952	8.458	11.871
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.92				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 16.26				
AVERAGE TEMPERATURE: 41.791				
SINK TEMPERATURE: 9.833				
9	1.288	32.348	8.332	11.695
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.96				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 16.33				
AVERAGE TEMPERATURE: 42.181				
SINK TEMPERATURE: 9.833				

TABLE 60. REDUCED DATA FOR FC-43 AND 11 MM SPACING

THE RAW Emf DATA ARE FROM THE FILE: 03JAN0345
 THE POWER SETTING PER CHIP WAS: 1.7 W
 THE DISTANCE TO THE FRONT WALL WAS 11 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	1.639	35.662	9.568	13.429
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.31				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 22.15				
AVERAGE TEMPERATURE: 45.645				
SINK TEMPERATURE: 9.964				
2	1.635	37.456	9.144	12.834
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.49				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 22.66				
AVERAGE TEMPERATURE: 47.420				
SINK TEMPERATURE: 9.964				
3	1.629	37.955	8.961	12.606
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.54				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 22.77				
AVERAGE TEMPERATURE: 47.950				
SINK TEMPERATURE: 9.964				
4	1.646	35.742	9.644	13.536
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.30				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 22.15				
AVERAGE TEMPERATURE: 45.706				
SINK TEMPERATURE: 9.964				
5	1.622	37.473	9.393	13.192
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.46				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 23.31				
AVERAGE TEMPERATURE: 47.437				
SINK TEMPERATURE: 9.954				
6	1.674	37.527	9.342	13.112
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.49				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 23.22				
AVERAGE TEMPERATURE: 47.490				
SINK TEMPERATURE: 9.964				
7	1.624	35.519	9.546	13.395
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.29				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 21.64				
AVERAGE TEMPERATURE: 45.582				
SINK TEMPERATURE: 9.964				
8	1.681	37.741	9.331	13.097
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.51				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 23.41				
AVERAGE TEMPERATURE: 47.704				
SINK TEMPERATURE: 9.964				
9	1.677	37.621	9.292	13.042
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.52				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 23.37				
AVERAGE TEMPERATURE: 47.764				
SINK TEMPERATURE: 9.964				

TABLE 61. REDUCED DATA FOR FC-43 AND 11 MM SPACING

THE RAW Emf DATA ARE FROM THE FILE: 24JAN1440
 THE POWER SETTING PER CHIP WAS: 2.25 W
 THE DISTANCE TO THE FRONT WALL WAS 11 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	2.157	40.055	10.495	14.731
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 3.10				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 32.50				
AVERAGE TEMPERATURE: 52.855				
SINK TEMPERATURE: 9.798				
2	2.151	45.045	10.007	14.045
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 3.34				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 33.44				
AVERAGE TEMPERATURE: 54.844				
SINK TEMPERATURE: 9.795				
3	2.143	45.425	9.864	13.873
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 3.39				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 33.50				
AVERAGE TEMPERATURE: 55.224				
SINK TEMPERATURE: 9.795				
4	2.165	43.017	10.545	14.601
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 3.09				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 32.60				
AVERAGE TEMPERATURE: 52.815				
SINK TEMPERATURE: 9.792				
5	2.211	44.905	10.319	14.483
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 3.22				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 34.30				
AVERAGE TEMPERATURE: 54.705				
SINK TEMPERATURE: 9.798				
6	2.200	45.337	10.165	14.273
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 3.38				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 34.35				
AVERAGE TEMPERATURE: 55.135				
SINK TEMPERATURE: 9.792				
7	2.136	42.750	10.459	14.679
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 3.05				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 32.04				
AVERAGE TEMPERATURE: 52.577				
SINK TEMPERATURE: 9.795				
8	2.211	45.681	10.144	14.237
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 3.42				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 34.71				
AVERAGE TEMPERATURE: 55.479				
SINK TEMPERATURE: 9.795				
9	2.205	45.351	10.189	14.302
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 3.35				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 34.44				
AVERAGE TEMPERATURE: 55.149				
SINK TEMPERATURE: 9.795				

TABLE 62. REDUCED DATA FOR FC-43 AND 11 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 24JAN0245
 THE POWER SETTING PER CHIP WAS: 2.9 W
 THE DISTANCE TO THE FRONT WALL WAS 11 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	2.757	49.450	11.687	16.404
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.97				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 46.35				
AVERAGE TEMPERATURE: 59.602				
SINK TEMPERATURE: 10.153				
2	2.751	52.109	11.067	15.534
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.35				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 48.16				
AVERAGE TEMPERATURE: 62.261				
SINK TEMPERATURE: 10.153				
3	2.741	52.056	11.038	15.493
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.34				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 47.95				
AVERAGE TEMPERATURE: 62.209				
SINK TEMPERATURE: 10.153				
4	2.769	49.432	11.740	16.478
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.96				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 46.54				
AVERAGE TEMPERATURE: 59.525				
SINK TEMPERATURE: 10.153				
5	2.827	51.951	11.401	16.003
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.33				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 49.42				
AVERAGE TEMPERATURE: 62.144				
SINK TEMPERATURE: 10.153				
6	2.813	52.093	11.320	15.880
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.35				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 49.24				
AVERAGE TEMPERATURE: 62.246				
SINK TEMPERATURE: 10.153				
7	2.729	48.935	11.700	16.422
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.89				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 45.48				
AVERAGE TEMPERATURE: 59.036				
SINK TEMPERATURE: 10.153				
8	2.625	53.017	11.173	15.662
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.49				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 50.16				
AVERAGE TEMPERATURE: 63.170				
SINK TEMPERATURE: 10.153				
9	2.817	51.900	11.350	15.973
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.22				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 49.17				
AVERAGE TEMPERATURE: 62.053				
SINK TEMPERATURE: 10.153				

TABLE 63. REDUCED DATA FOR FC-43 AND 7 MM SPACING

THE RAW EMT DATA ARE FROM THE FILE: 3FEB1535
 THE POWER SETTING PER CHIP WAS: 0.115 W
 THE DISTANCE TO THE FRONT WALL WAS 7 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET W	Tavg-Ts	NU1	NU2
1	.112	10.119	2.313	3.247
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: .40				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .93				
AVERAGE TEMPERATURE: 20.046				
SINK TEMPERATURE: 9.927				
2	.112	10.466	2.334	3.135
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: .42				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .93				
AVERAGE TEMPERATURE: 20.393				
SINK TEMPERATURE: 9.927				
3	.111	10.055	2.313	3.247
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: .40				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .92				
AVERAGE TEMPERATURE: 19.982				
SINK TEMPERATURE: 9.927				
4	.112	10.176	2.306	3.237
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: .40				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .93				
AVERAGE TEMPERATURE: 20.103				
SINK TEMPERATURE: 9.927				
5	.115	10.463	2.390	3.314
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: .42				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .96				
AVERAGE TEMPERATURE: 20.390				
SINK TEMPERATURE: 9.927				
6	.114	10.133	2.351	3.300
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: .40				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .94				
AVERAGE TEMPERATURE: 20.060				
SINK TEMPERATURE: 9.927				
7	.110	10.165	2.262	3.175
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: .40				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .91				
AVERAGE TEMPERATURE: 20.111				
SINK TEMPERATURE: 9.927				
8	.114	10.377	2.295	3.222
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: .41				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .95				
AVERAGE TEMPERATURE: 20.303				
SINK TEMPERATURE: 9.927				
9	.113	10.120	2.340	3.284
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: .40				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: .94				
AVERAGE TEMPERATURE: 20.055				
SINK TEMPERATURE: 9.927				

TABLE 64. REDUCED DATA FOR FC-43 AND 7 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: ZFEE2045
 THE POWER SETTING PER CHIP WAS: 0.34 W
 THE DISTANCE TO THE FRONT WALL WAS 7 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	.322	14.745	4.572	6.417
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: .65				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.97				
AVERAGE TEMPERATURE: 24.636				
SINK TEMPERATURE: 10.091				
2	.322	15.192	4.429	6.217
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: .69				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.99				
AVERAGE TEMPERATURE: 25.263				
SINK TEMPERATURE: 10.091				
3	.321	14.529	4.567	6.439
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: .64				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.94				
AVERAGE TEMPERATURE: 24.700				
SINK TEMPERATURE: 10.091				
4	.324	14.454	4.691	6.570
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: .63				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.96				
AVERAGE TEMPERATURE: 24.545				
SINK TEMPERATURE: 10.091				
5	.330	15.055	4.565	6.435
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: .67				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 3.06				
AVERAGE TEMPERATURE: 25.150				
SINK TEMPERATURE: 10.091				
6	.329	15.016	4.575	6.422
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: .66				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 3.04				
AVERAGE TEMPERATURE: 25.107				
SINK TEMPERATURE: 10.091				
7	.318	14.254	4.669	6.652
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: .62				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 2.90				
AVERAGE TEMPERATURE: 24.345				
SINK TEMPERATURE: 10.091				
8	.330	14.900	4.627	6.495
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: .66				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 3.05				
AVERAGE TEMPERATURE: 24.991				
SINK TEMPERATURE: 10.091				
9	.328	14.717	4.665	6.548
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: .65				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 3.02				
AVERAGE TEMPERATURE: 24.809				
SINK TEMPERATURE: 10.091				

TABLE 65. REDUCED DATA FOR FC-43 AND 7 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 4FEE0100
 THE POWER SETTING PER CHIP WAS: 0.8 W
 THE DISTANCE TO THE FRONT WALL WAS 7 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	.761	24.610	6.470	9.082
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.31				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 9.51				
AVERAGE TEMPERATURE: 34.736				
SINK TEMPERATURE: 10.124				
2	.760	25.708	6.164	8.679
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.40				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 8.66				
AVERAGE TEMPERATURE: 35.622				
SINK TEMPERATURE: 10.124				
3	.757	24.426	6.488	9.107
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.30				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 8.44				
AVERAGE TEMPERATURE: 34.545				
SINK TEMPERATURE: 10.124				
4	.765	23.936	6.669	9.351
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.27				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 6.45				
AVERAGE TEMPERATURE: 34.109				
SINK TEMPERATURE: 10.124				
5	.780	25.051	6.518	9.149
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.35				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 8.79				
AVERAGE TEMPERATURE: 35.174				
SINK TEMPERATURE: 10.124				
6	.776	24.679	6.561	9.237
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.32				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 6.69				
AVERAGE TEMPERATURE: 34.803				
SINK TEMPERATURE: 10.124				
7	.753	23.626	6.664	9.354
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.24				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 8.26				
AVERAGE TEMPERATURE: 33.749				
SINK TEMPERATURE: 10.124				
8	.780	24.716	6.603	9.267
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.32				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 8.74				
AVERAGE TEMPERATURE: 34.641				
SINK TEMPERATURE: 10.124				
9	.778	24.726	6.552	9.226
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 1.32				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 6.71				
AVERAGE TEMPERATURE: 34.649				
SINK TEMPERATURE: 10.124				

TABLE 66. REDUCED DATA FOR FC-43 AND 7 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 4FEB81T00
 THE POWER SETTING PER CHIP WAS: 1.3 W
 THE DISTANCE TO THE FRONT WALL WAS 7 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET-W	Tavg-Is	Nu1	Nu2
1	1.228	32.259	7.975	11.193
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 1.98				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 15.61				
AVERAGE TEMPERATURE: 42.178				
SINK TEMPERATURE: 9.919				
2	1.225	34.088	7.525	10.562
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 2.13				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 16.04				
AVERAGE TEMPERATURE: 44.005				
SINK TEMPERATURE: 9.919				
3	1.222	32.097	7.980	11.173
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 1.94				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 15.49				
AVERAGE TEMPERATURE: 42.018				
SINK TEMPERATURE: 9.919				
4	1.233	31.165	8.280	11.522
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 1.68				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 15.27				
AVERAGE TEMPERATURE: 41.025				
SINK TEMPERATURE: 9.919				
5	1.250	33.068	7.978	11.182
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 2.03				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 16.22				
AVERAGE TEMPERATURE: 42.957				
SINK TEMPERATURE: 9.919				
6	1.253	32.334	8.115	11.291
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 1.96				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 15.94				
AVERAGE TEMPERATURE: 42.254				
SINK TEMPERATURE: 9.919				
7	1.215	31.429	8.095	11.363
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 1.88				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 15.22				
AVERAGE TEMPERATURE: 41.348				
SINK TEMPERATURE: 9.919				
8	1.260	32.571	8.097	11.364
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 1.99				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 16.08				
AVERAGE TEMPERATURE: 42.490				
SINK TEMPERATURE: 9.919				
9	1.255	32.607	8.007	11.239
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 2.01				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 16.08				
AVERAGE TEMPERATURE: 42.727				
SINK TEMPERATURE: 9.919				

TABLE 67. REDUCED DATA FOR FC-43 AND 7 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: 4FEED200
 THE POWER SETTINGS PER CHIP WAS: 1.7 W
 THE DISTANCE TO THE FRONT WALL WAS 7 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	1.634	38.334	8.938	12.532
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.60				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 23.25				
AVERAGE TEMPERATURE: 45.675				
SINK TEMPERATURE: 10.342				
2	1.629	41.058	8.312	11.667
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.91				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 24.20				
AVERAGE TEMPERATURE: 51.400				
SINK TEMPERATURE: 10.342				
3	1.622	38.200	8.894	12.483
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.99				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 23.03				
AVERAGE TEMPERATURE: 48.542				
SINK TEMPERATURE: 10.342				
4	1.635	37.127	9.243	12.973
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.47				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 22.67				
AVERAGE TEMPERATURE: 47.466				
SINK TEMPERATURE: 10.342				
5	1.674	39.665	8.643	12.412
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.75				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 24.33				
AVERAGE TEMPERATURE: 50.007				
SINK TEMPERATURE: 10.342				
6	1.666	35.697	9.020	12.661
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.64				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 23.85				
AVERAGE TEMPERATURE: 49.039				
SINK TEMPERATURE: 10.342				
7	1.616	36.896	9.171	12.872
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.45				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 22.46				
AVERAGE TEMPERATURE: 47.238				
SINK TEMPERATURE: 10.342				
8	1.674	39.045	8.973	12.602
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.68				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 24.08				
AVERAGE TEMPERATURE: 49.387				
SINK TEMPERATURE: 10.342				
9	1.669	38.113	8.936	12.543
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 2.69				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 24.04				
AVERAGE TEMPERATURE: 49.455				
SINK TEMPERATURE: 10.342				

TABLE 68. REDUCED DATA FOR FC-43 AND 7 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: SFEB0100
 THE POWER SETTING PER CHIP WAS: 2.25 W
 THE DISTANCE TO THE FRONT WALL WAS 7 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	2.153	46.253	9.757	13.694
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.56				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 34.72				
AVERAGE TEMPERATURE: 56.641				
SINK TEMPERATURE: 10.385				
2	2.147	50.348	8.938	10.545
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 4.12				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 36.85				
AVERAGE TEMPERATURE: 60.736				
SINK TEMPERATURE: 10.386				
3	2.139	46.572	9.619	13.510
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.60				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 34.66				
AVERAGE TEMPERATURE: 56.960				
SINK TEMPERATURE: 10.386				
4	2.161	44.475	10.180	14.288
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.33				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 33.90				
AVERAGE TEMPERATURE: 54.664				
SINK TEMPERATURE: 10.396				
5	2.207	46.315	9.577	13.440
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.64				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 35.74				
AVERAGE TEMPERATURE: 58.703				
SINK TEMPERATURE: 10.386				
6	2.196	47.146	9.763	13.704
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.62				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 35.90				
AVERAGE TEMPERATURE: 57.534				
SINK TEMPERATURE: 10.386				
7	2.132	44.068	10.136	14.226
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.26				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 33.23				
AVERAGE TEMPERATURE: 54.456				
SINK TEMPERATURE: 10.396				
8	2.208	47.710	9.701	13.615
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.75				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 36.41				
AVERAGE TEMPERATURE: 56.093				
SINK TEMPERATURE: 10.386				
9	2.202	47.342	9.750	13.665
TEMP.BASED RAYLEIGH NUMBER * E-6 IS: 3.70				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 36.11				
AVERAGE TEMPERATURE: 57.732				
SINK TEMPERATURE: 10.396				

TABLE 69. REDUCED DATA FOR FC-43 AND 7 MM SPACING

THE RAW EMF DATA ARE FROM THE FILE: SFEE1340
 THE POWER SETTING PER CHIP WAS: 2.9 W
 THE DISTANCE TO THE FRONT WALL WAS 7 MM
 ELECTRONIC LIQUID WAS FC-43

CHIP	QNET(W)	Tavg-Ts	Nu1	Nu2
1	2.747	52.452	10.963	15.415
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 4.42				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 46.58				
AVERAGE TEMPERATURE: 52.749				
SINK TEMPERATURE: 10.297				
2	2.739	57.925	9.908	13.907
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 5.22				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 52.70				
AVERAGE TEMPERATURE: 58.282				
SINK TEMPERATURE: 10.297				
3	2.730	53.920	10.617	14.501
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 4.65				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 49.35				
AVERAGE TEMPERATURE: 54.217				
SINK TEMPERATURE: 10.297				
4	2.758	50.517	11.421	16.031
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 4.15				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 47.41				
AVERAGE TEMPERATURE: 50.914				
SINK TEMPERATURE: 10.297				
5	2.817	55.859	10.575	14.844
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 4.96				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 52.46				
AVERAGE TEMPERATURE: 56.156				
SINK TEMPERATURE: 10.297				
6	2.903	54.487	10.759	15.142
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 4.74				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 51.12				
AVERAGE TEMPERATURE: 54.764				
SINK TEMPERATURE: 10.297				
7	2.721	49.905	11.428	16.040
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 4.05				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 46.26				
AVERAGE TEMPERATURE: 50.202				
SINK TEMPERATURE: 10.297				
8	2.817	54.409	10.857	15.236
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 4.73				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 51.31				
AVERAGE TEMPERATURE: 54.705				
SINK TEMPERATURE: 10.297				
9	2.809	54.266	10.855	15.236
TEMP. BASED RAYLEIGH NUMBER * E-6 IS: 4.70				
FLUX BASED RAYLEIGH NUMBER * E-6 IS: 51.05				
AVERAGE TEMPERATURE: 54.563				
SINK TEMPERATURE: 10.297				

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